



UiO : Centre for Materials Science and Nanotechnology

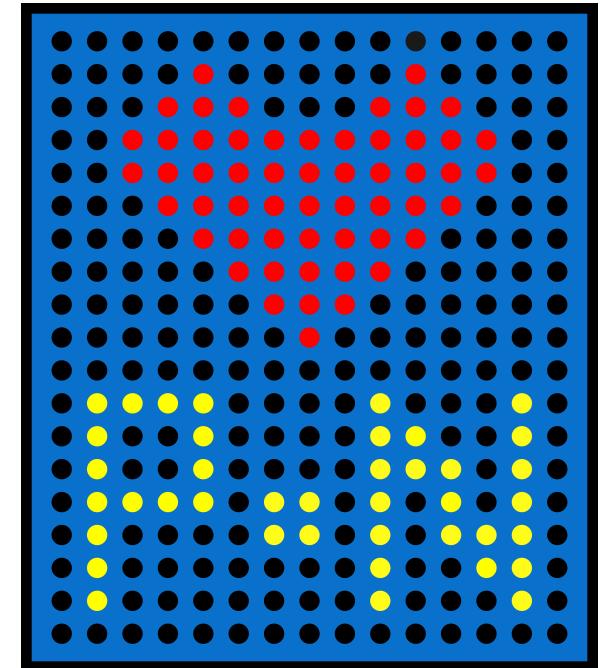
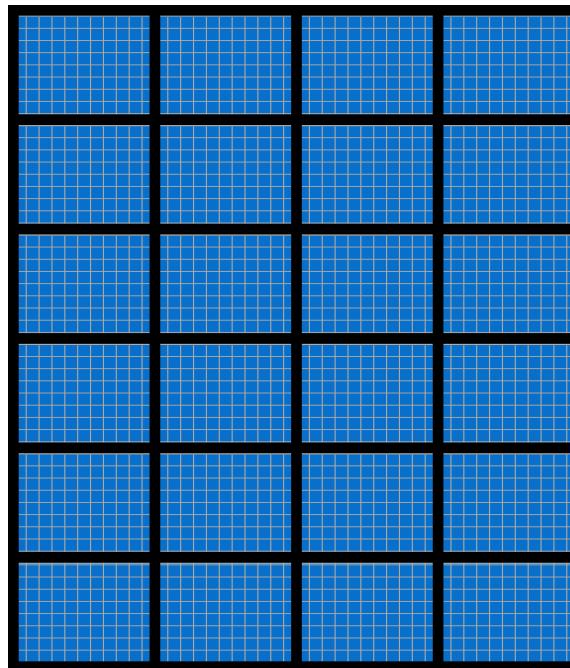
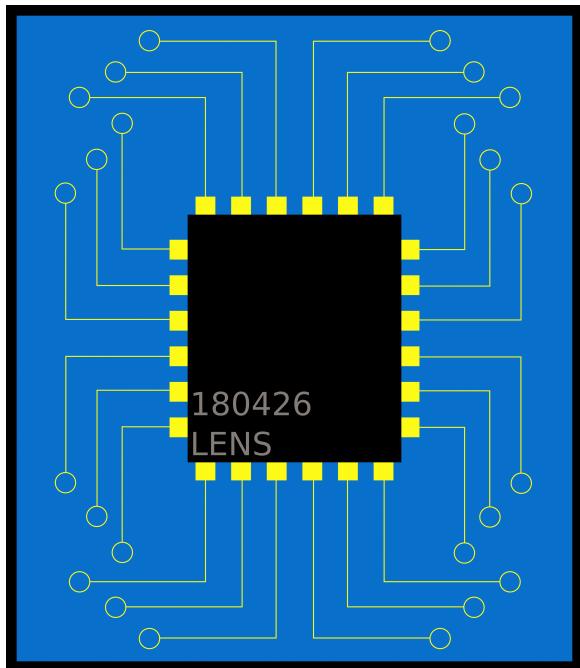
University of Oslo

Fundamentals of *p-n* junctions

Christian Zimmermann

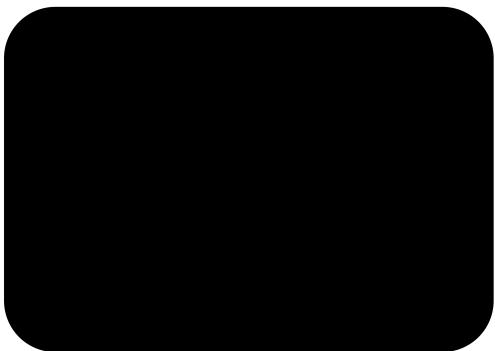


p-n junctions are fundamental

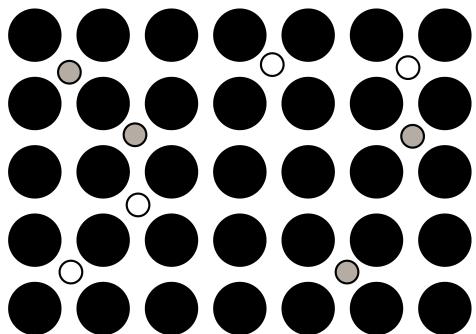


Let's start at the beginning...

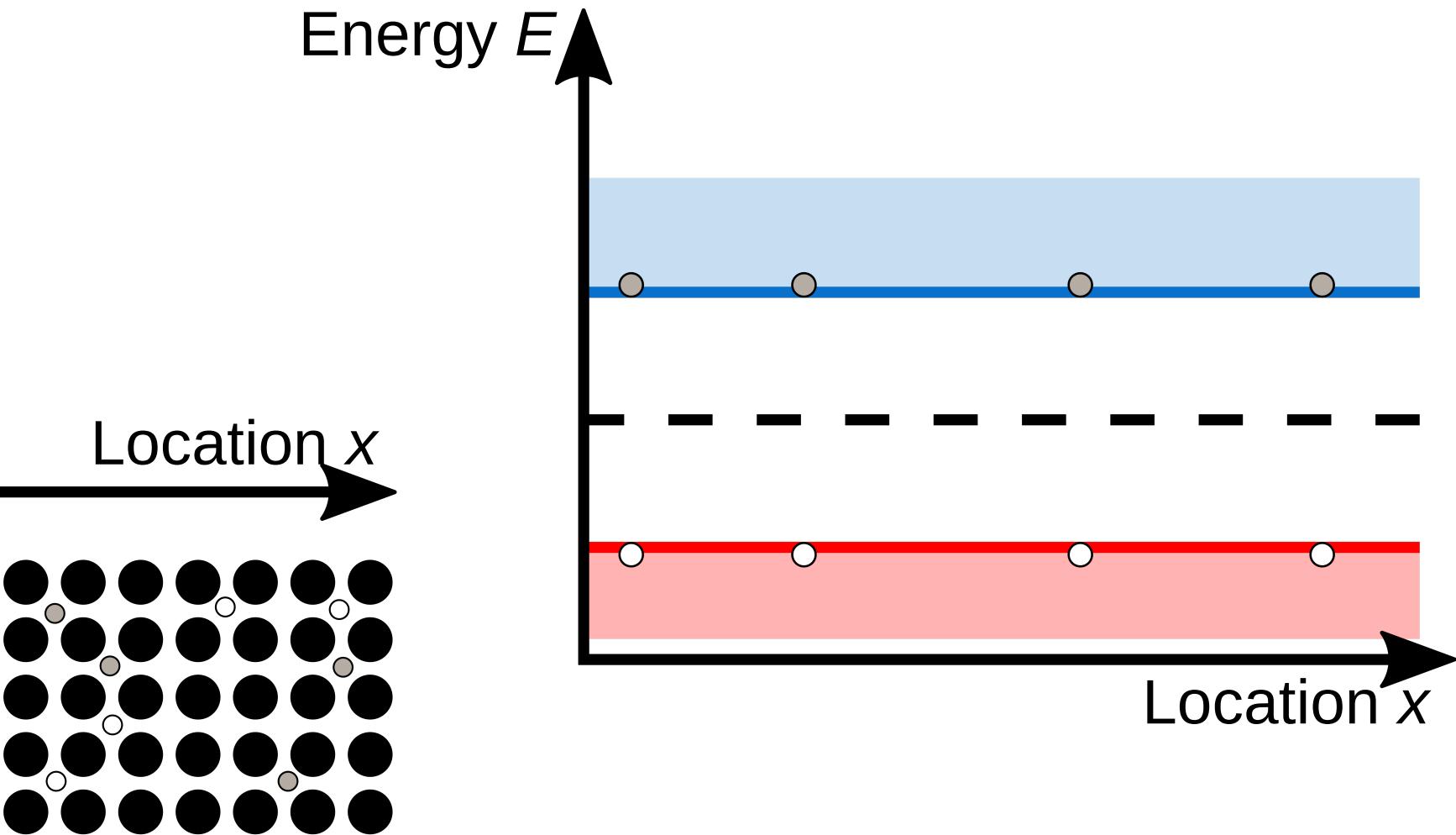
...with semiconductors.



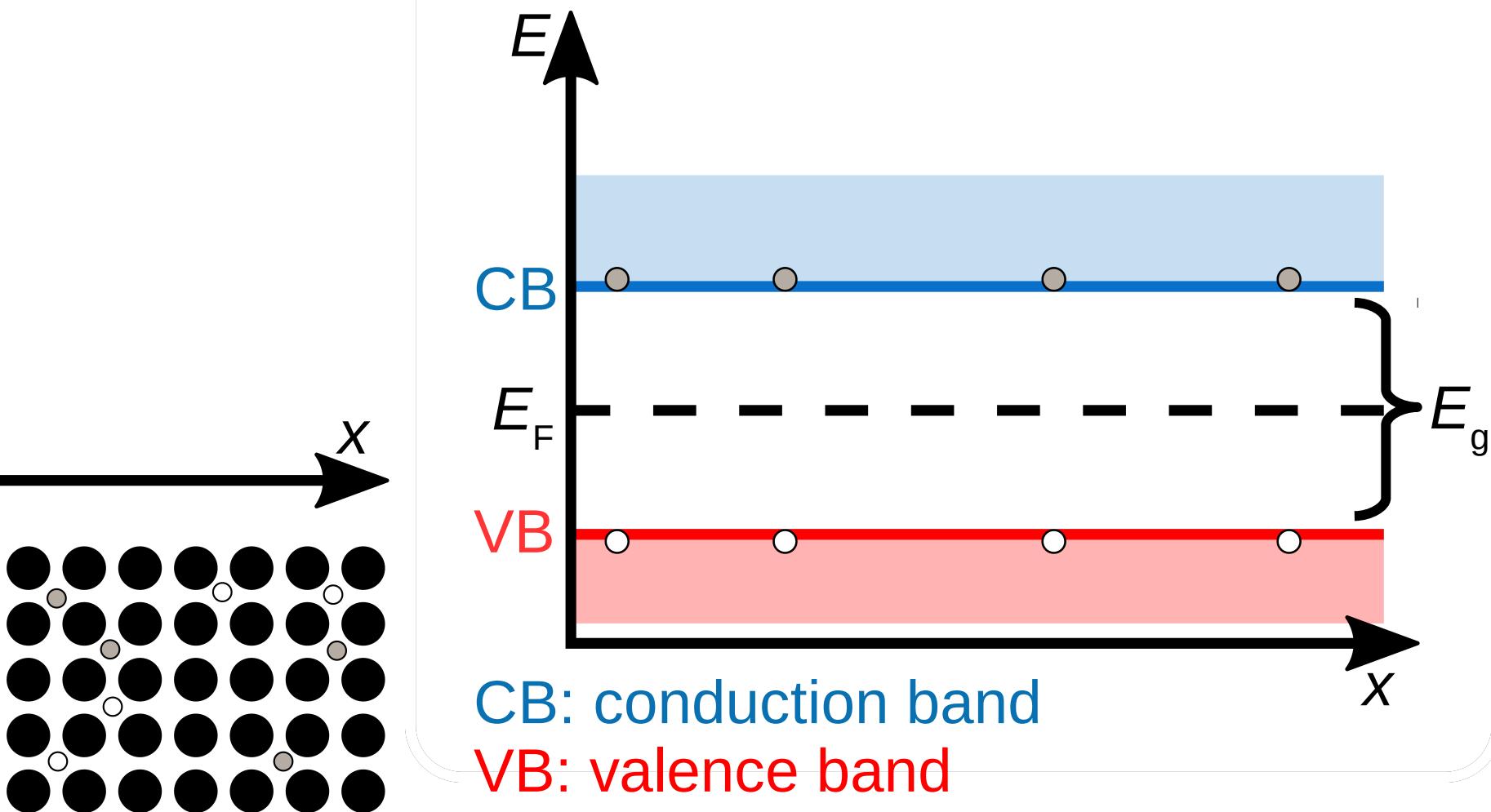
...with semiconductors.



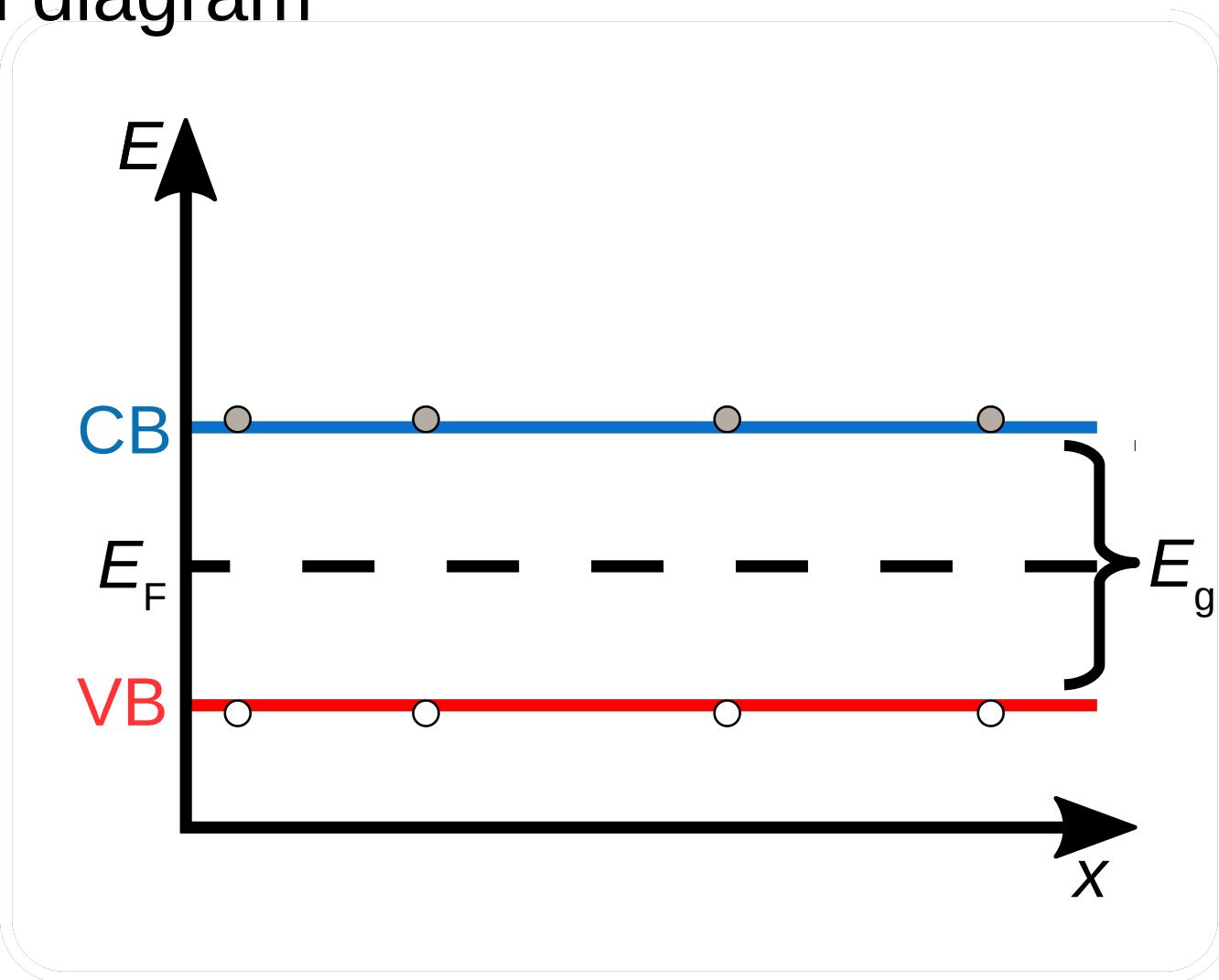
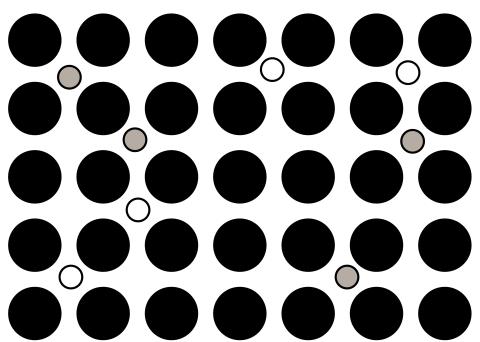
... with semiconductors.



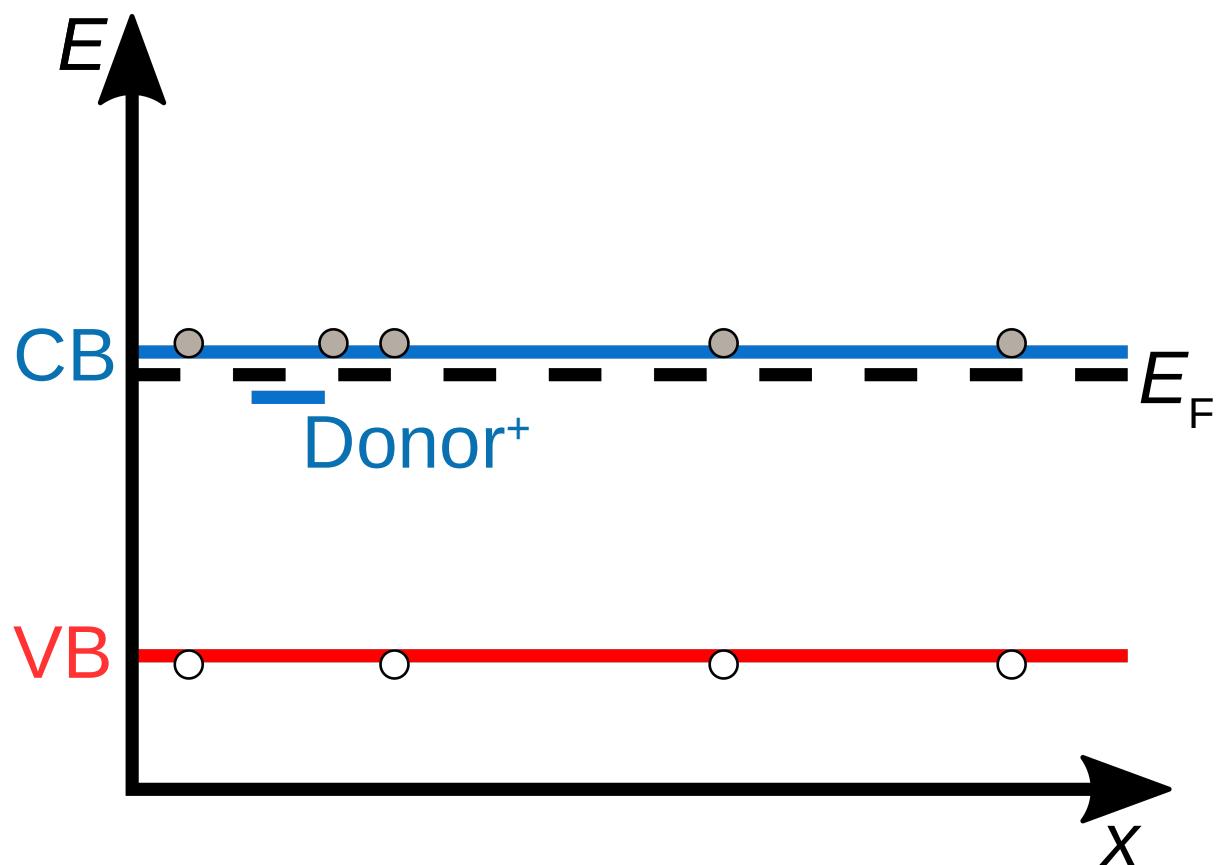
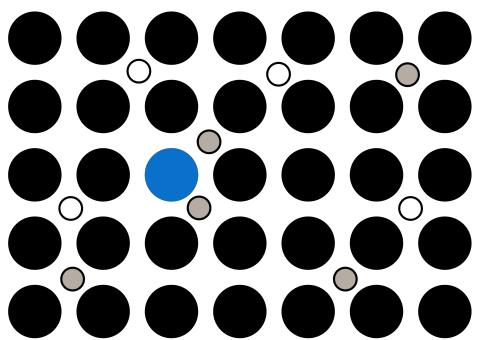
The band diagram



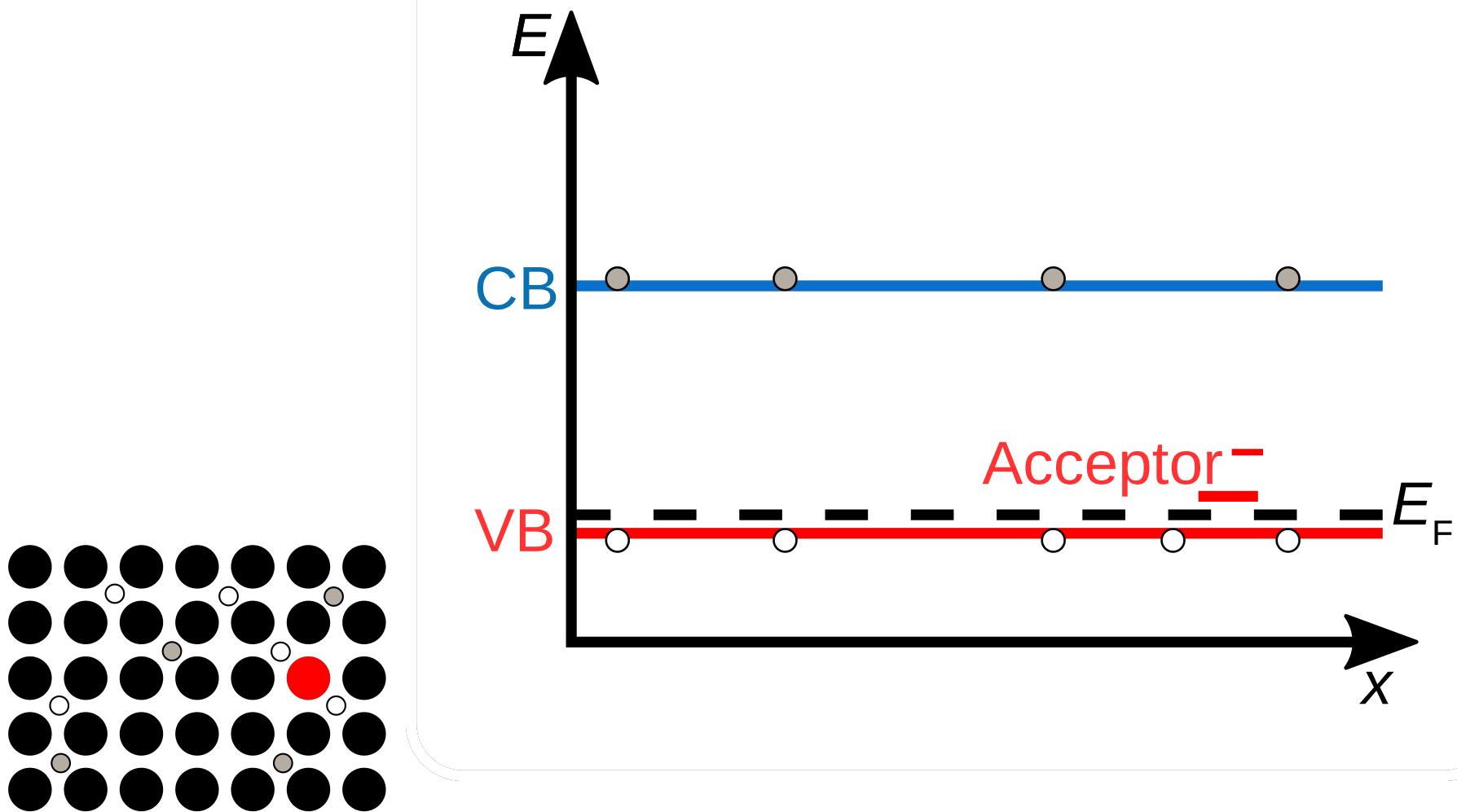
The band diagram



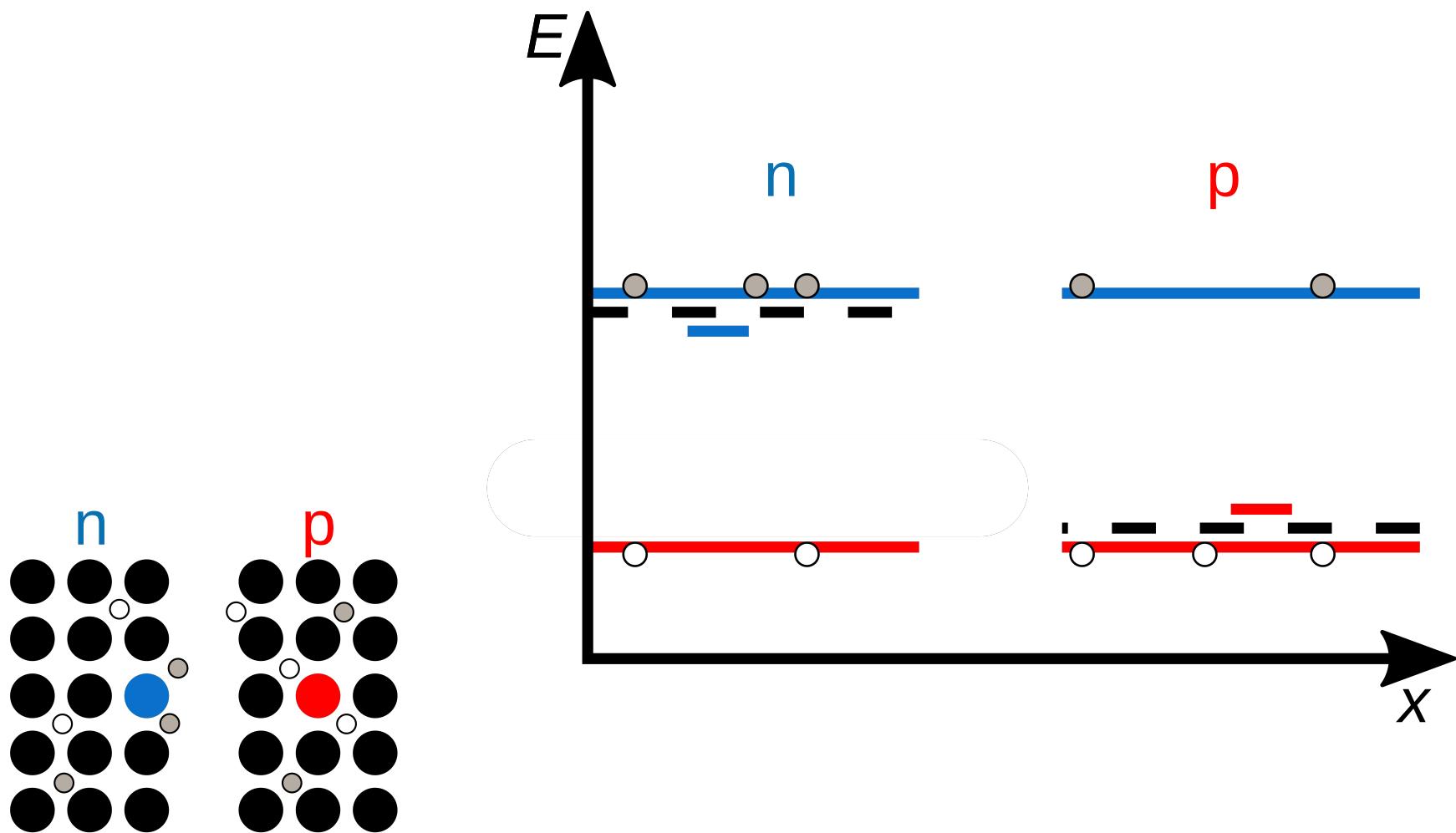
The band diagram: *n*-Doping



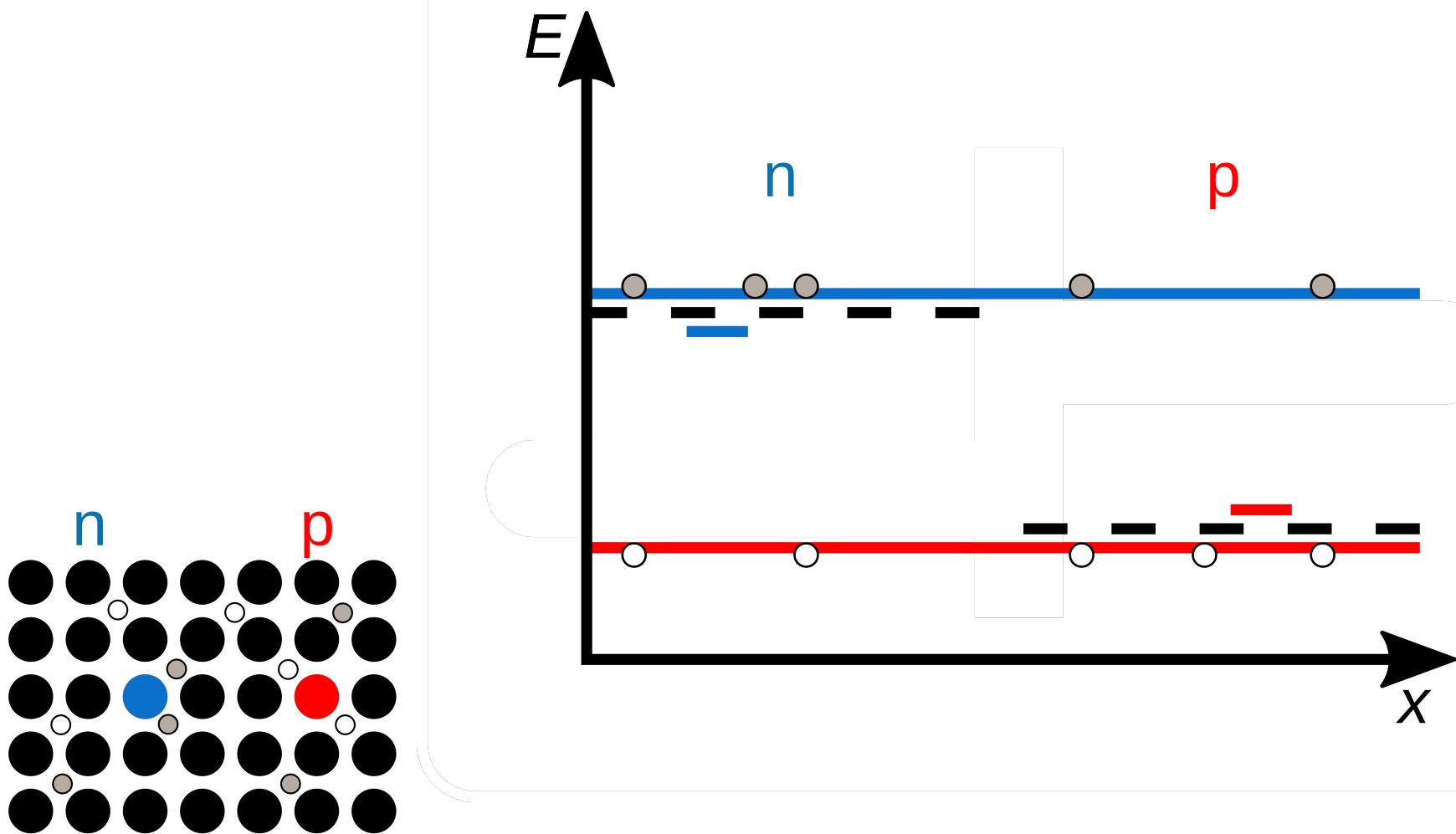
The Band diagram: *p*-Doping



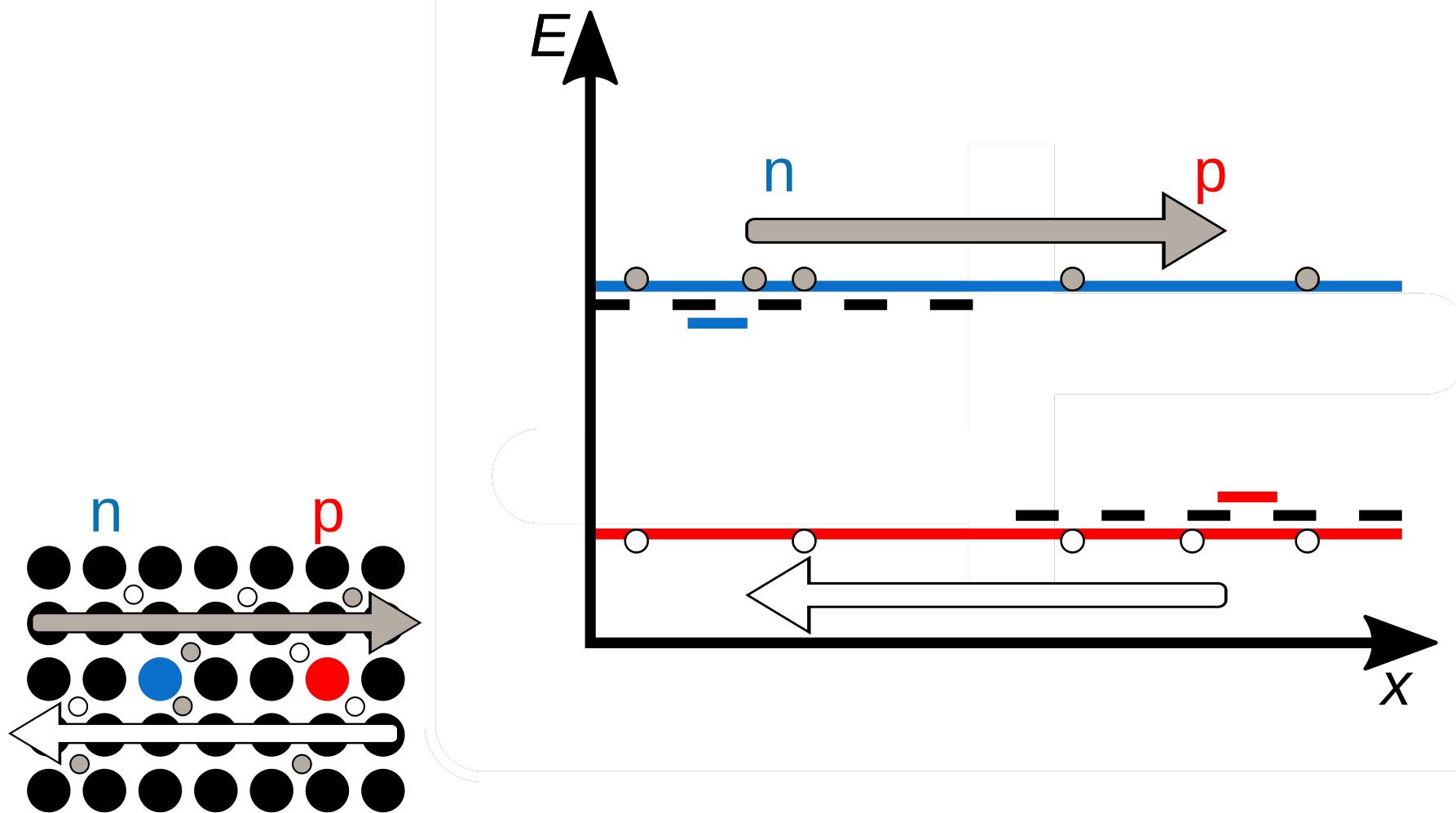
The band diagram of $p-n$ junctions



The band diagram of $p-n$ junctions

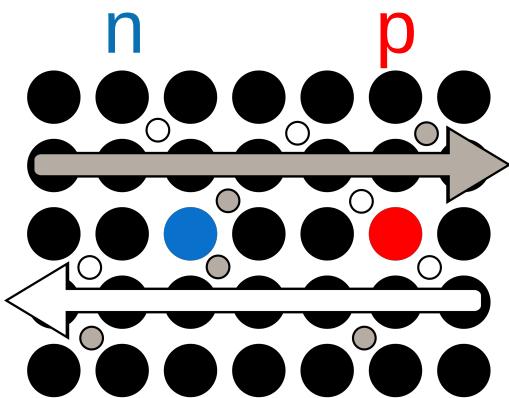
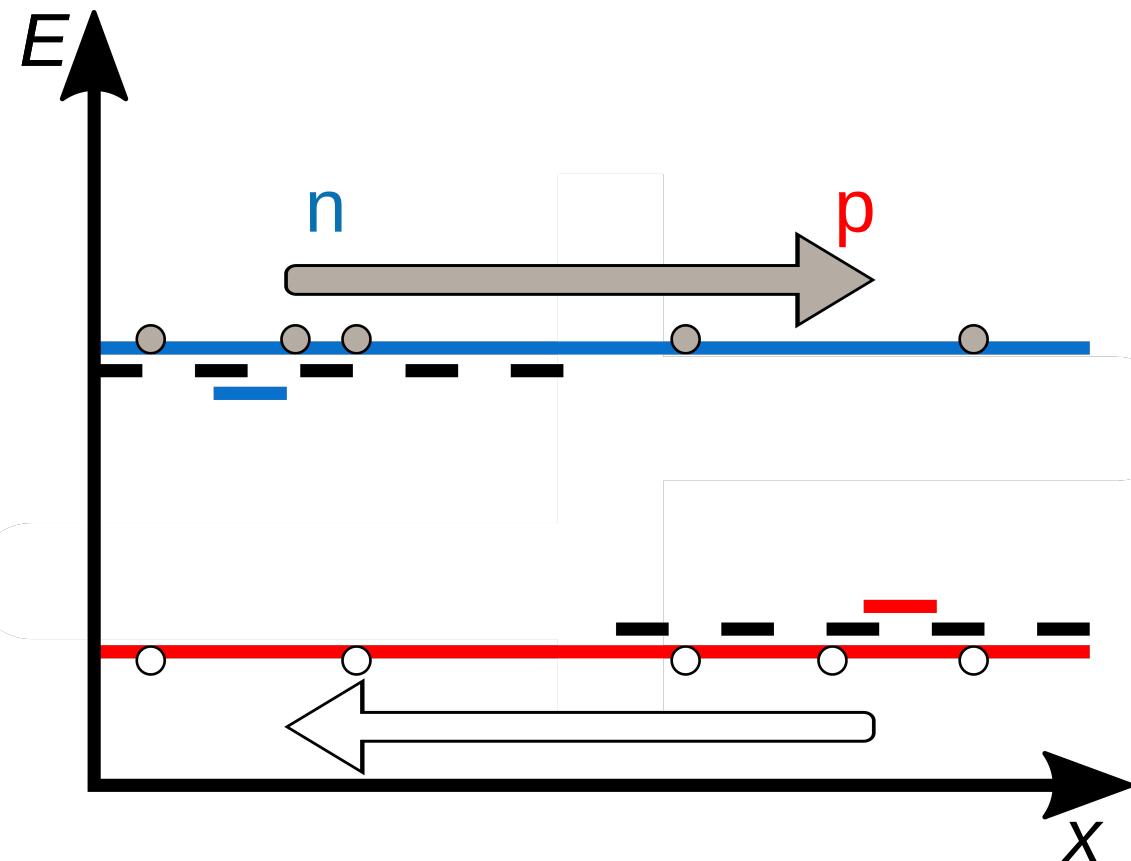


The band diagram of $p-n$ junctions



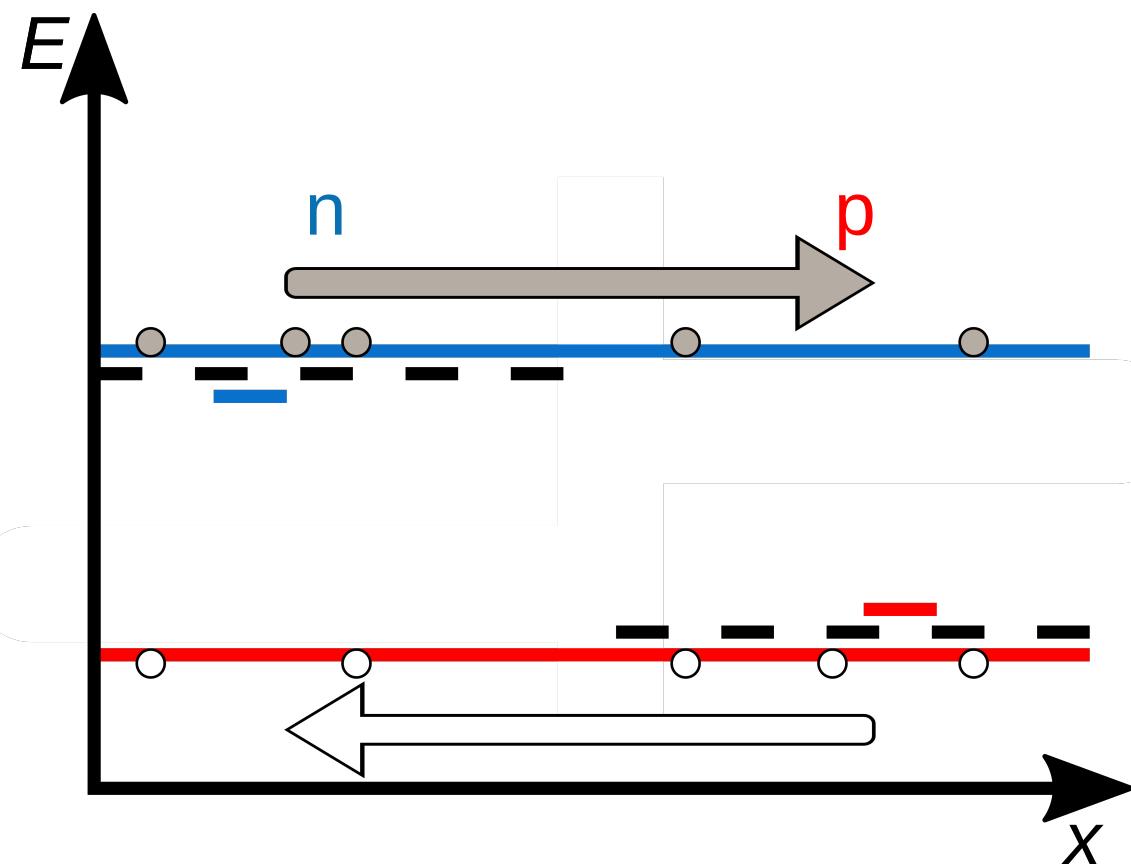
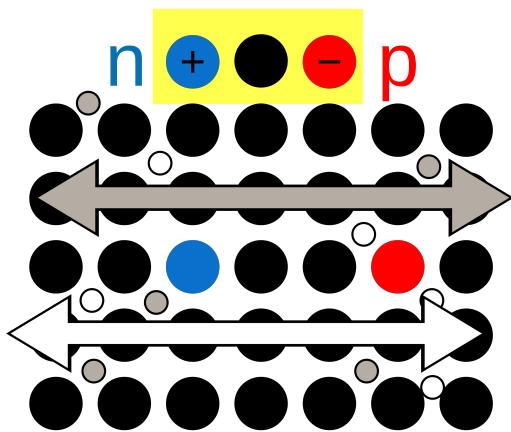
The band diagram of *p-n* junctions

Steady-State with
Diffusion
=
Drift



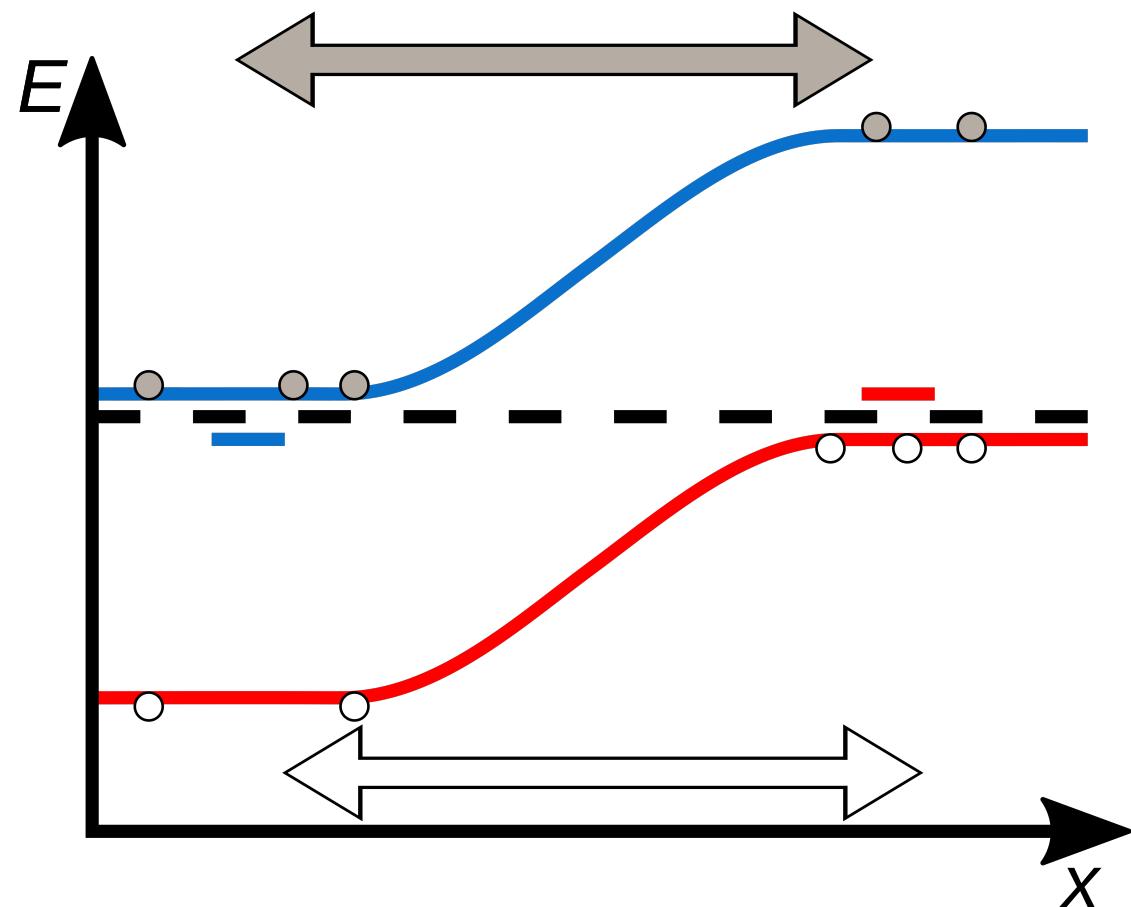
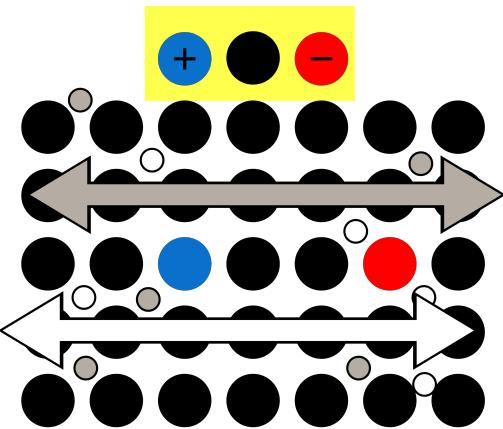
The band diagram of *p-n* junctions

Steady-State with
Diffusion
=
Drift



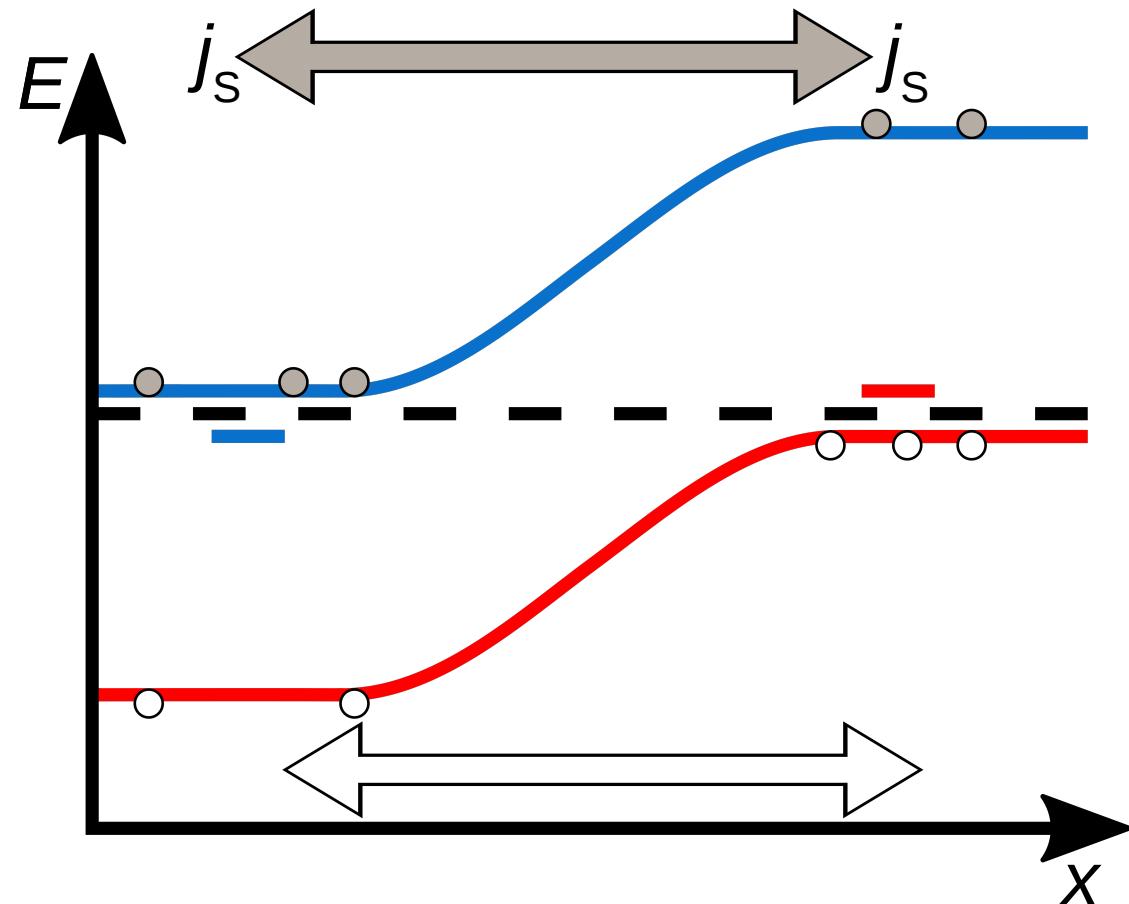
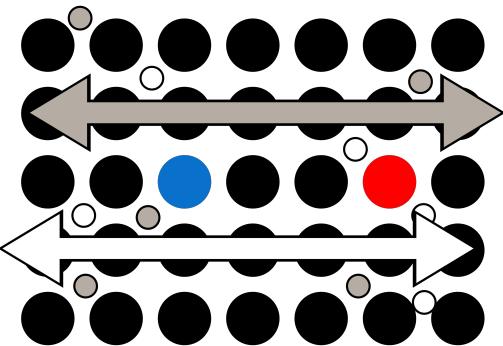
The band diagram of $p-n$ junctions

Steady-State with
Diffusion
=
Drift

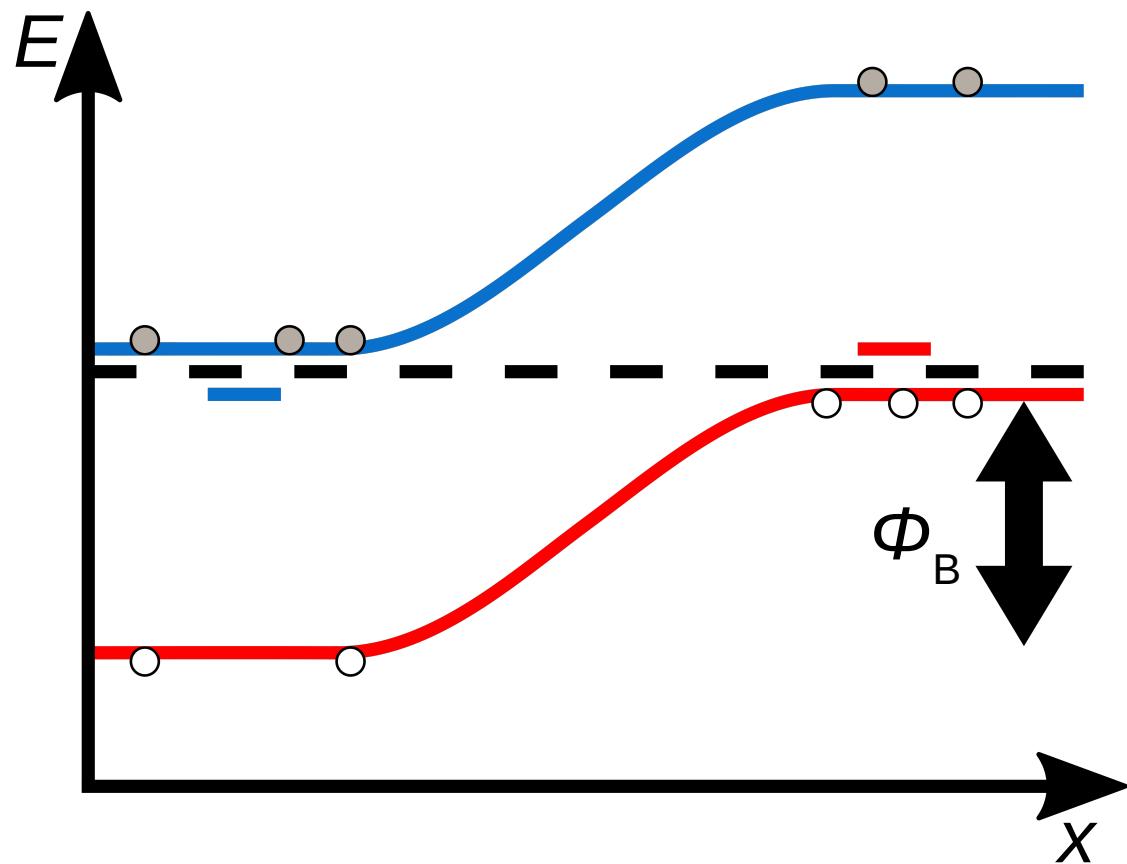
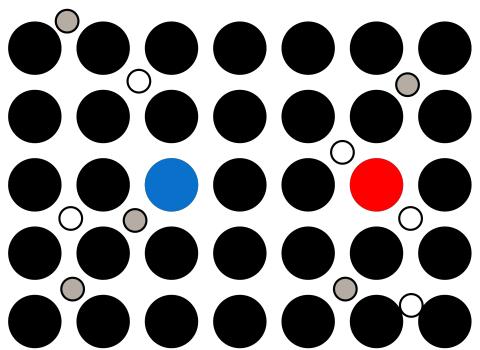


The band diagram of $p-n$ junctions

Steady-State with
Saturation
Current
=
 j_s

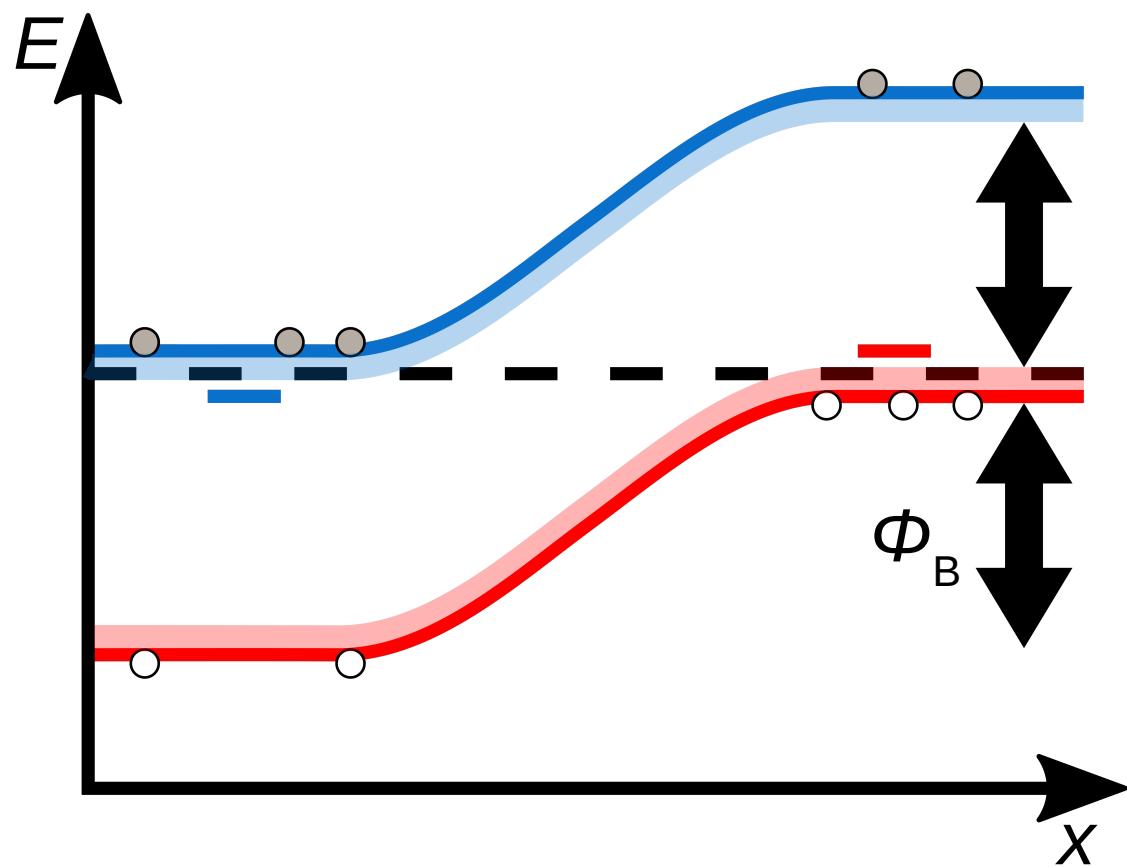
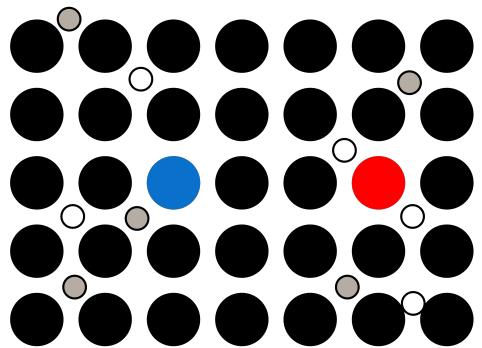


p-n junctions: Barrier height



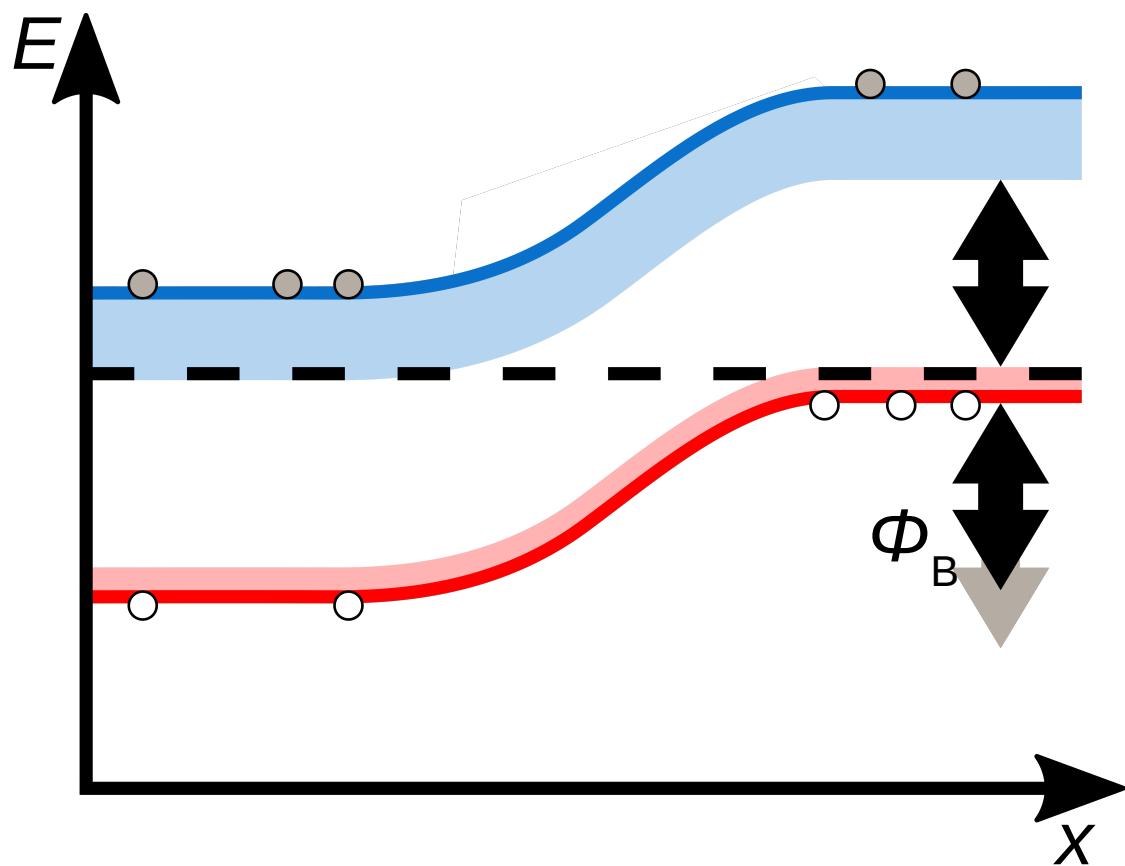
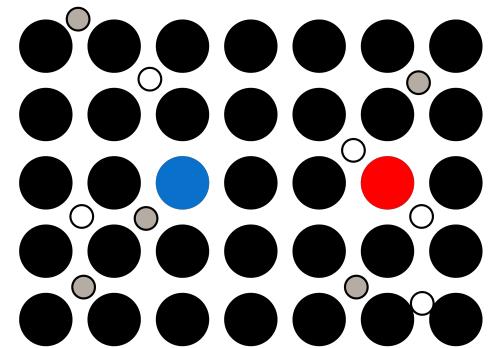
Φ_B : barrier height/ built-in voltage

p-n junctions: Barrier height



Φ_B : barrier height/ built-in voltage

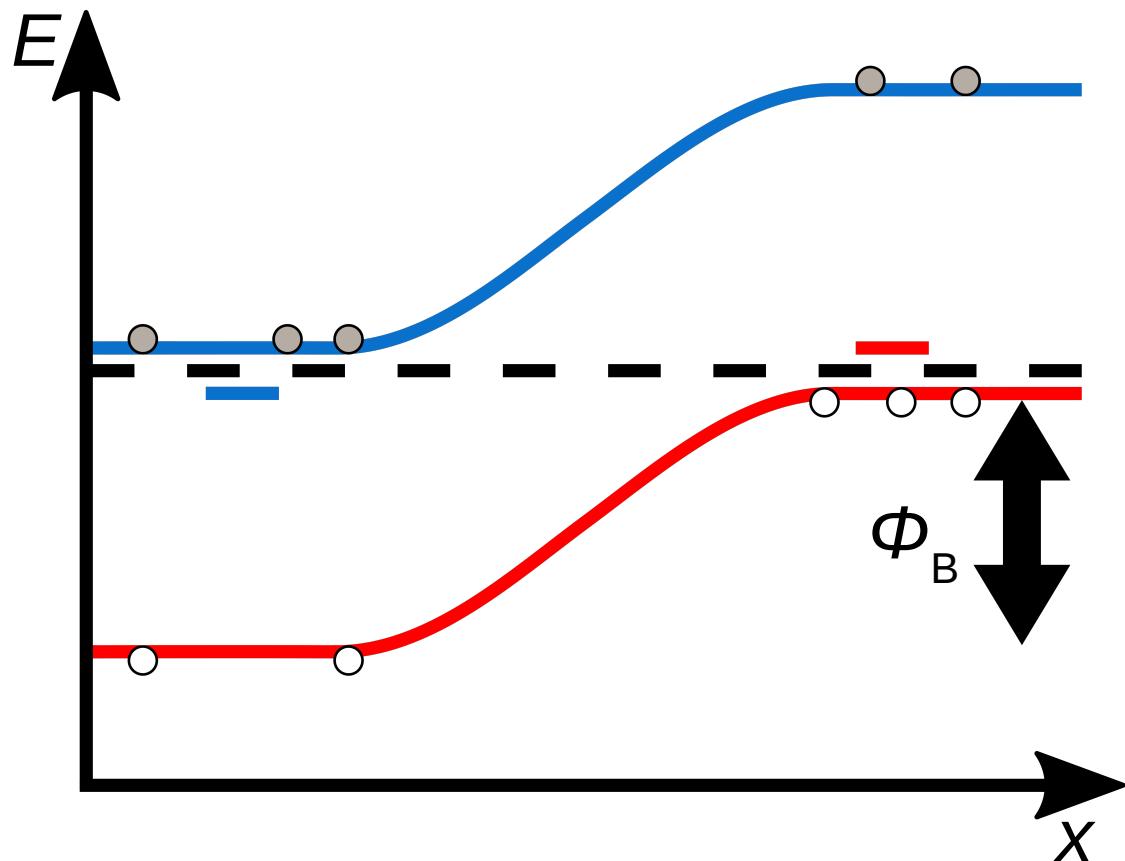
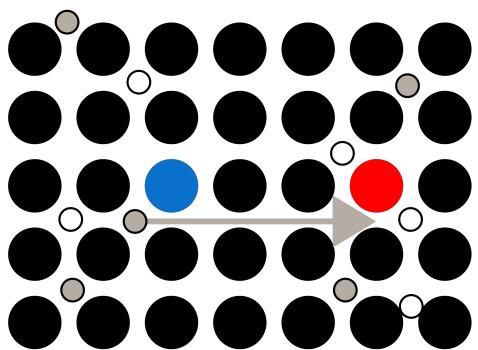
p-n junctions: Barrier height



Φ_B : barrier height/ built-in voltage

p-n junctions: Saturation current

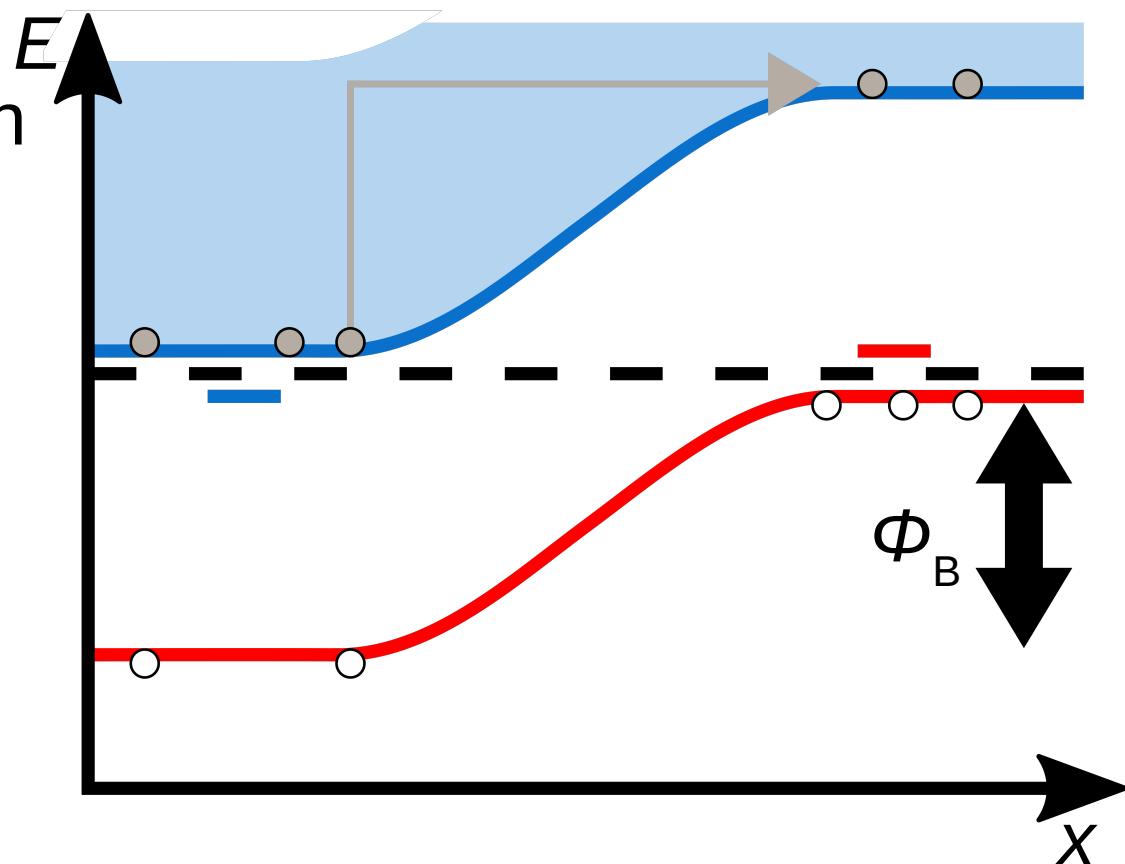
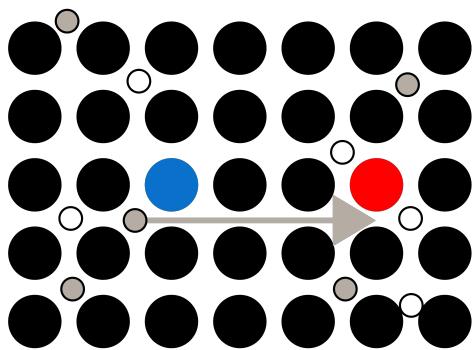
$$j_S =$$



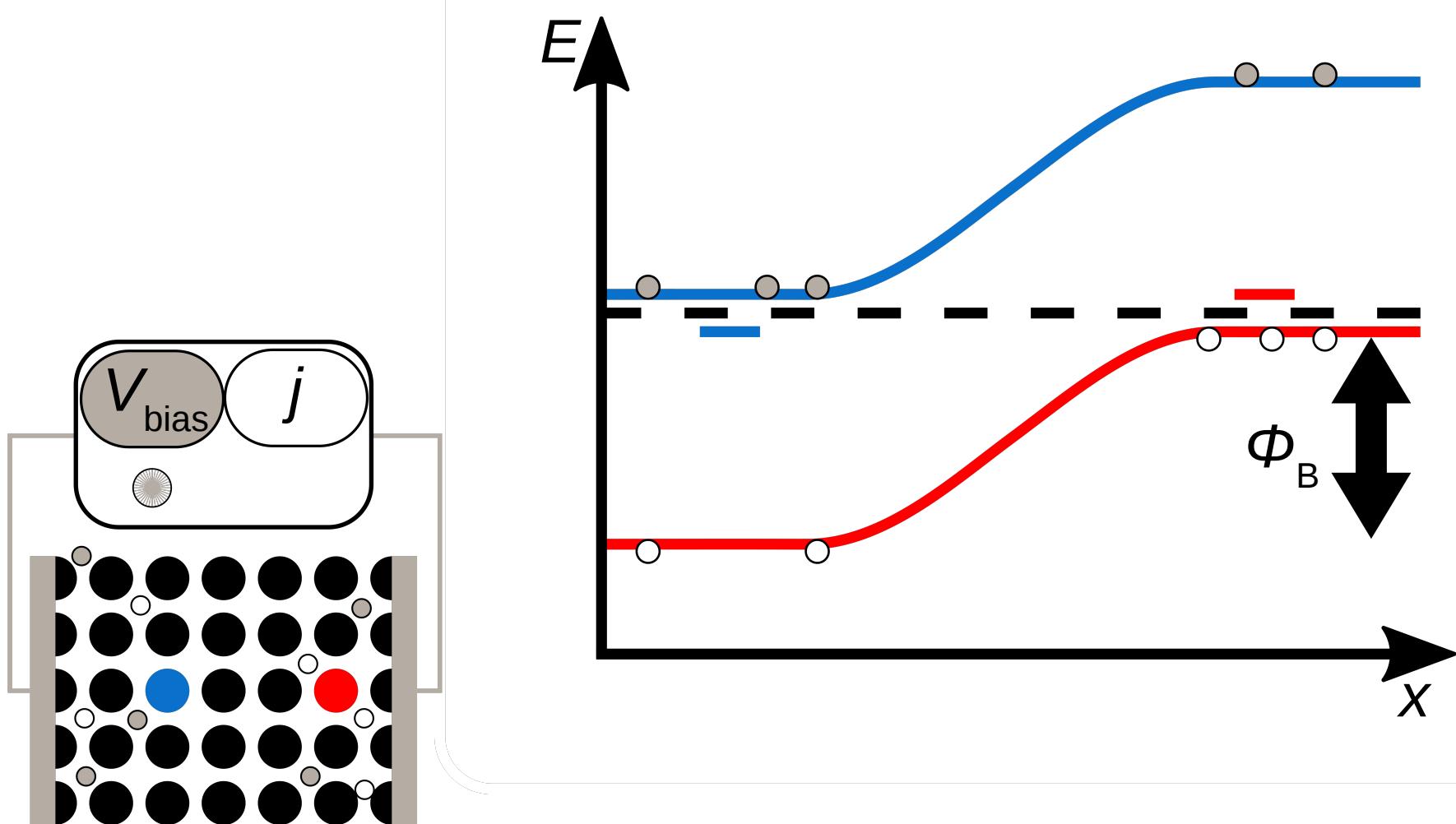
p-n junctions: Saturation current

Thermionic emission

$$j_S = A T^2 e^{\frac{-\phi_B}{kT}}$$



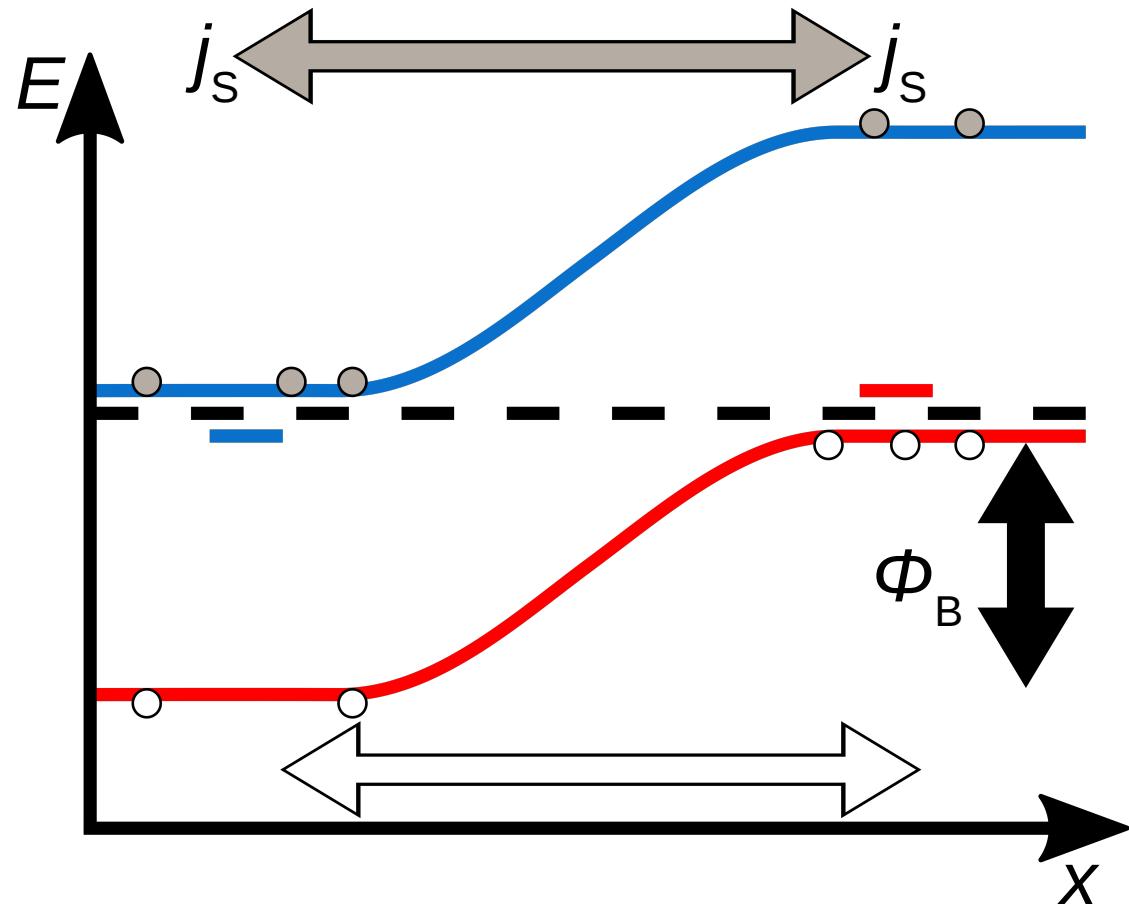
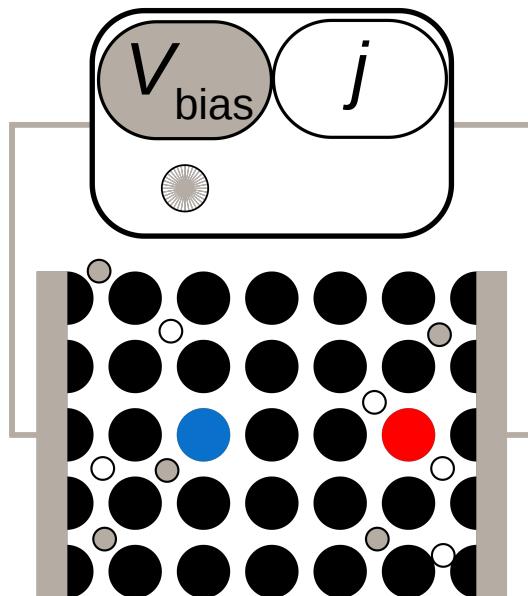
p-n junctions under applied voltage



p - n junctions under applied voltage

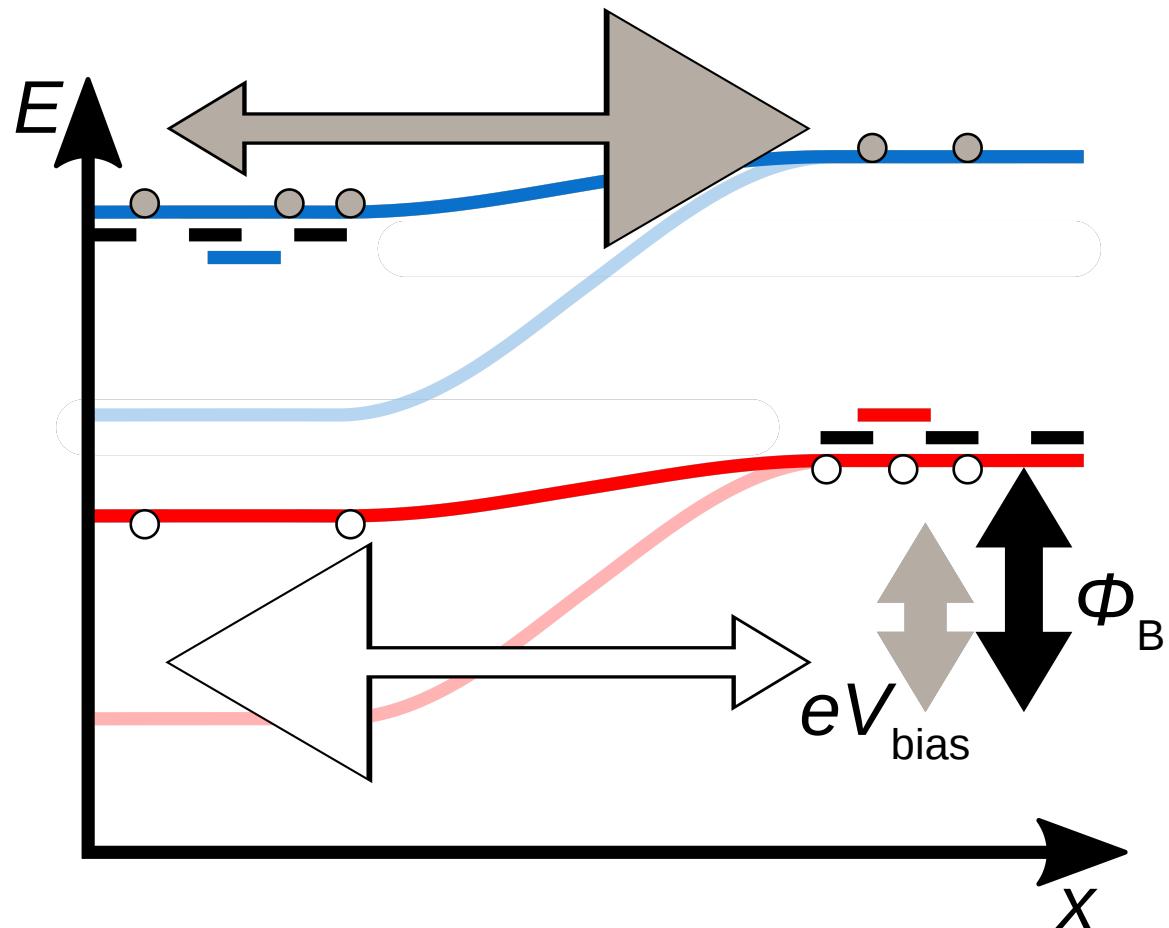
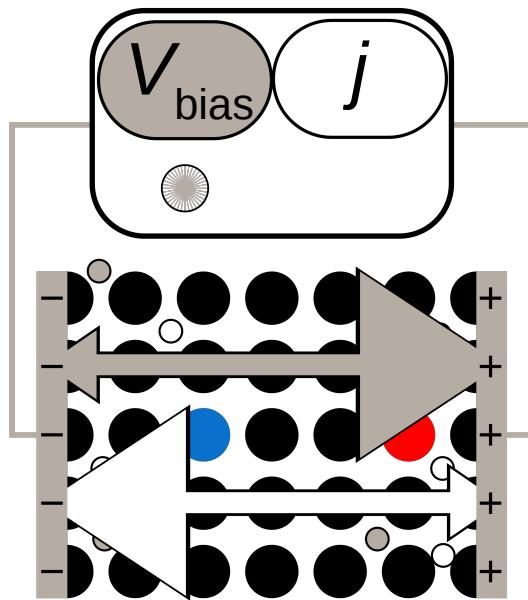
$V_{\text{bias}} = 0 \text{ V}$:

$$j = j_s - j_s$$



p - n junctions under forward bias

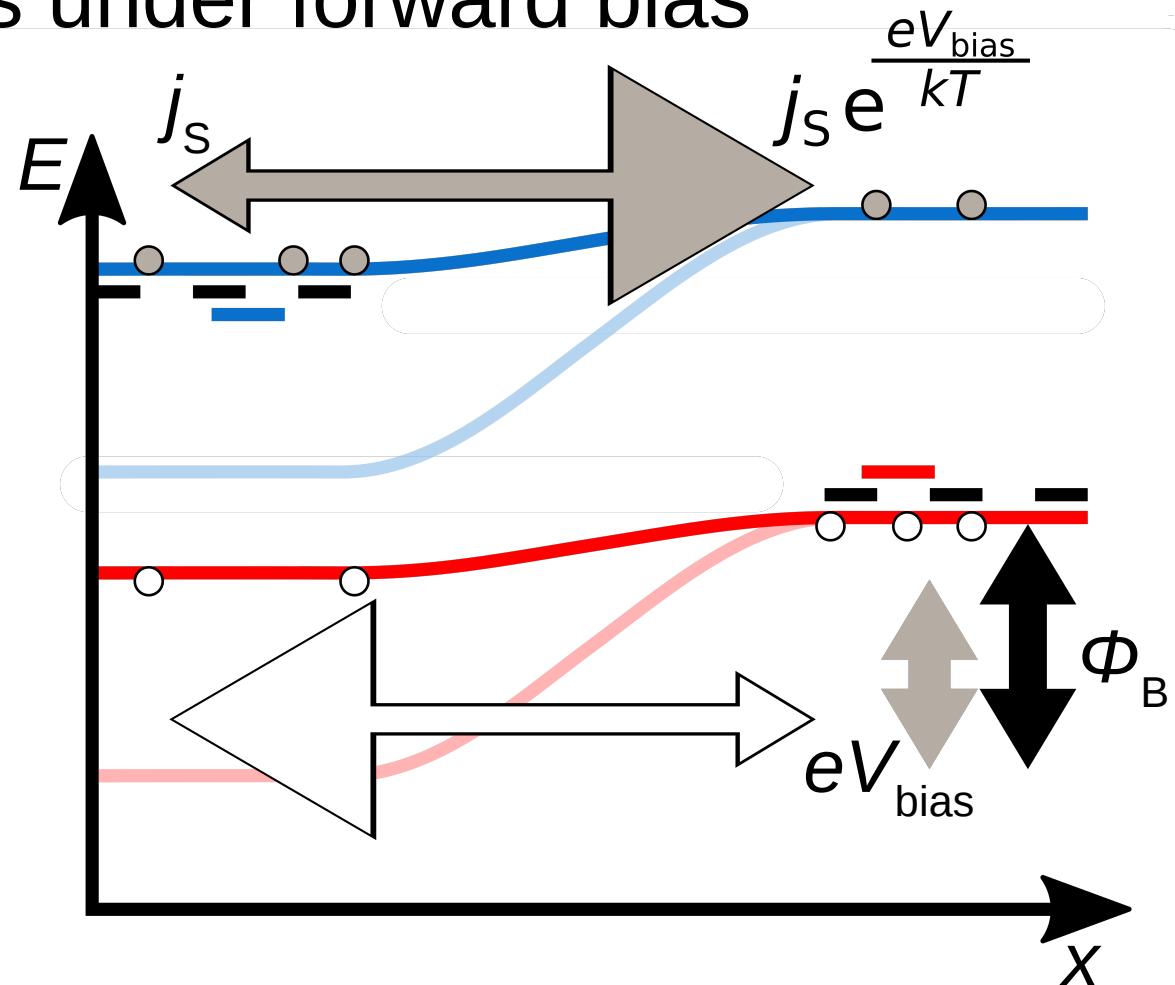
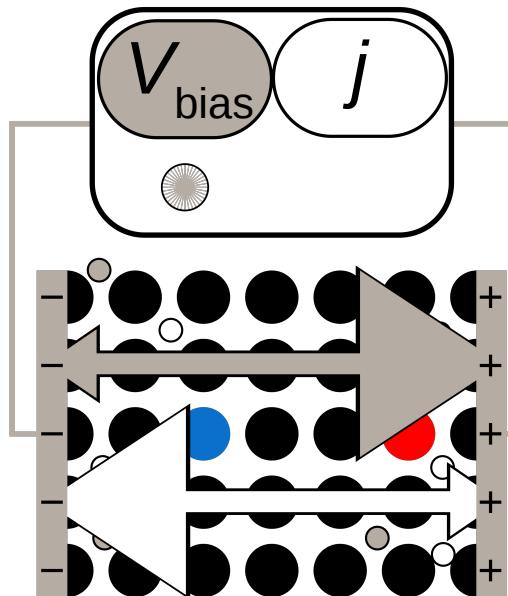
$V_{\text{bias}} > 0 \text{ V}$



p-n junctions under forward bias

$V_{\text{bias}} > 0 \text{ V}:$

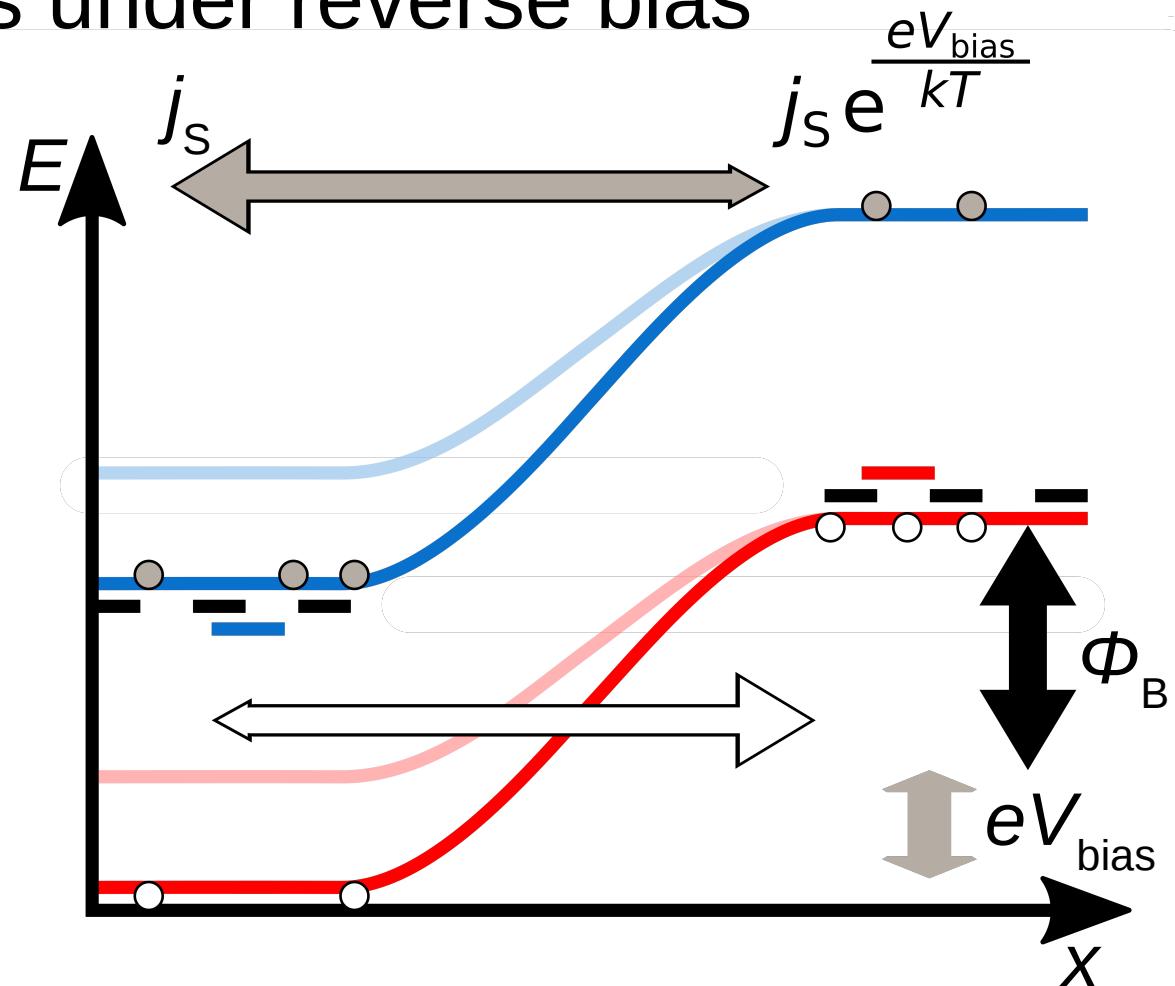
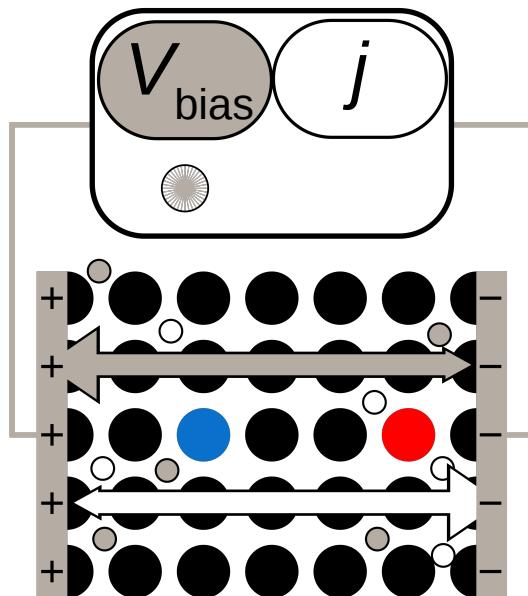
$$j = j_s e^{\frac{eV_{\text{bias}}}{kT}} - j_s$$



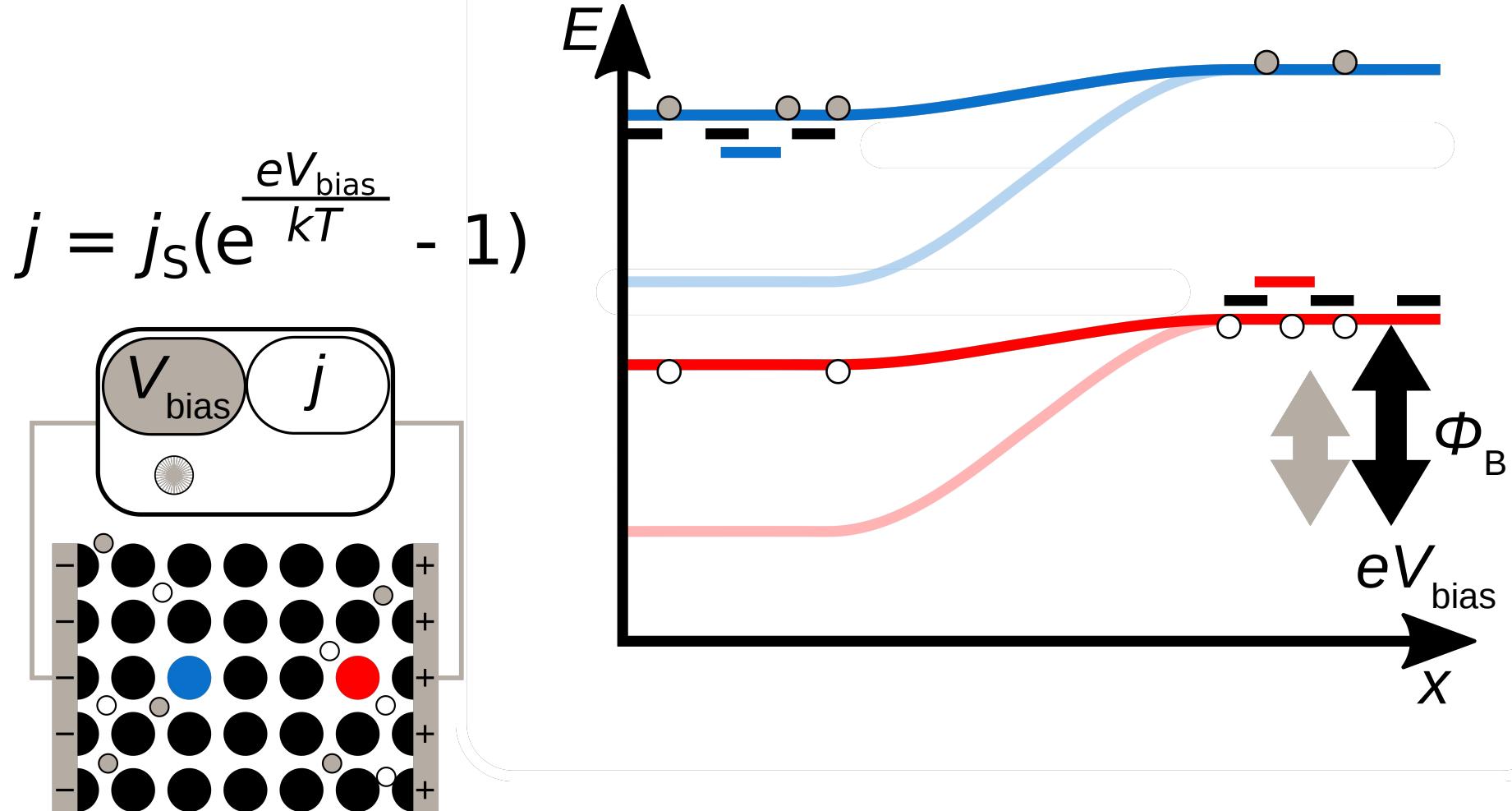
p-n junctions under reverse bias

$V_{\text{bias}} < 0 \text{ V}$:

$$j = j_s e^{\frac{eV_{\text{bias}}}{kT}} - j_s$$

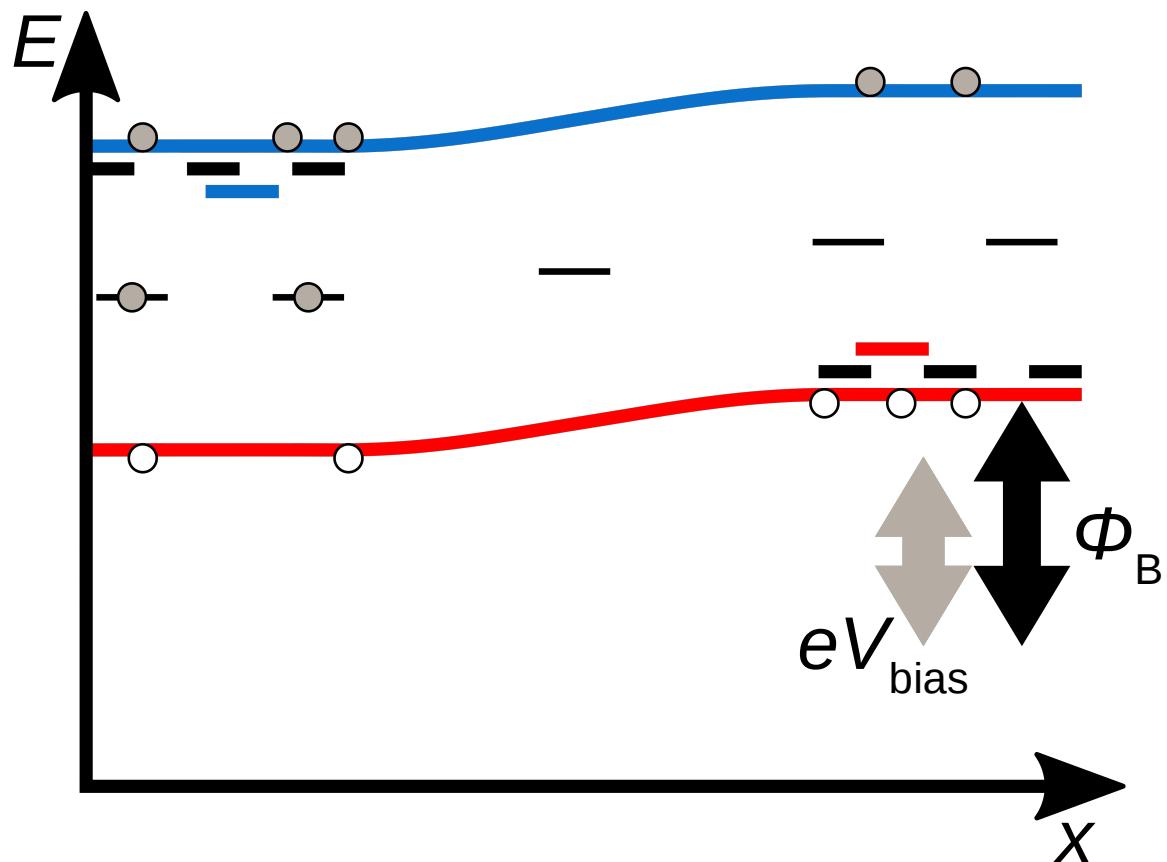
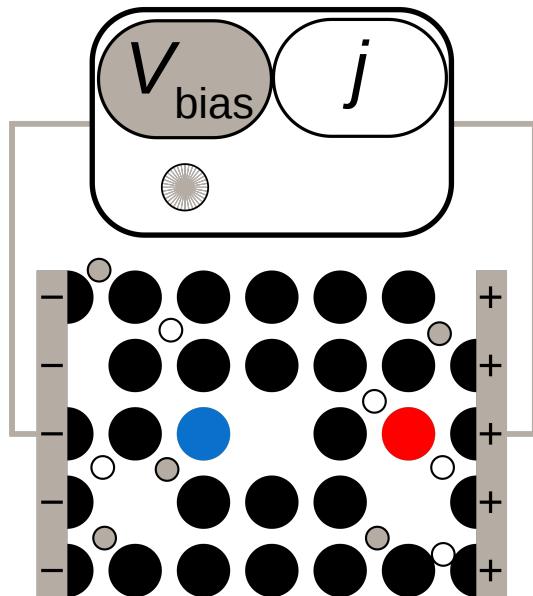


p-n junctions under forward bias



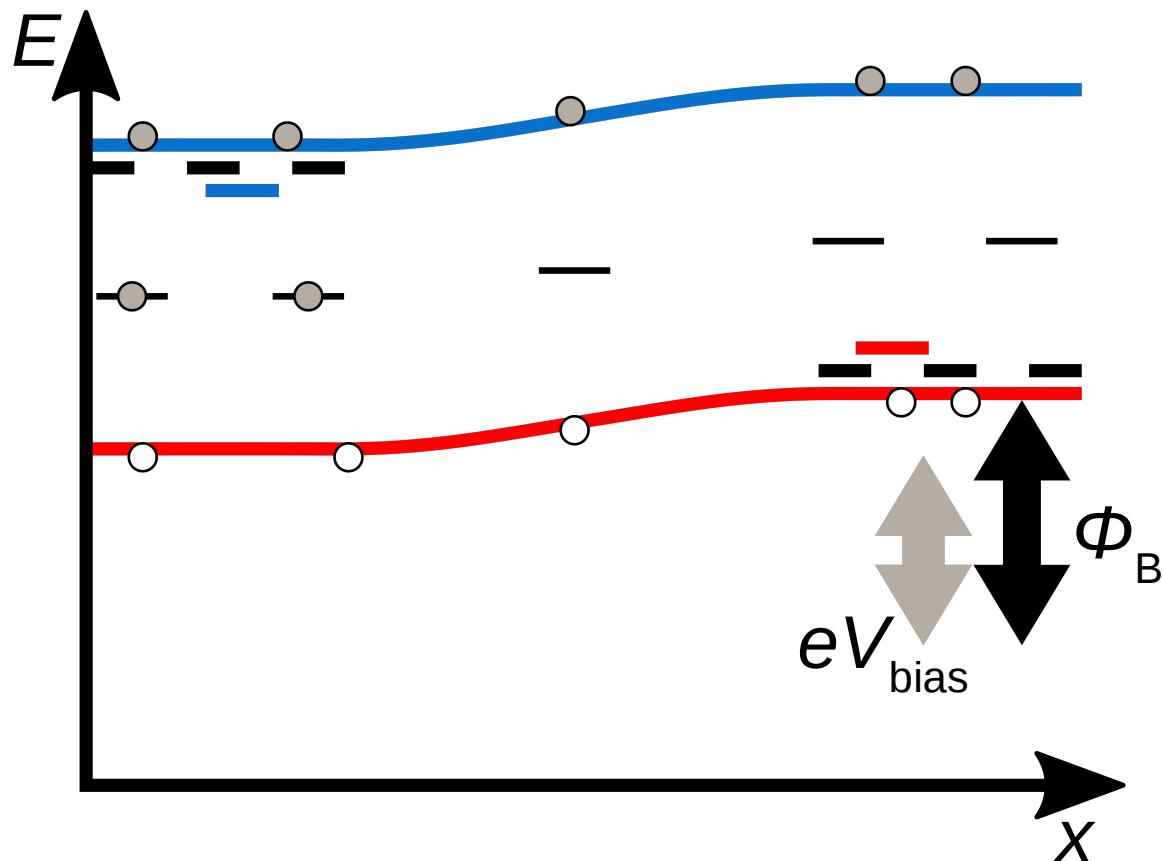
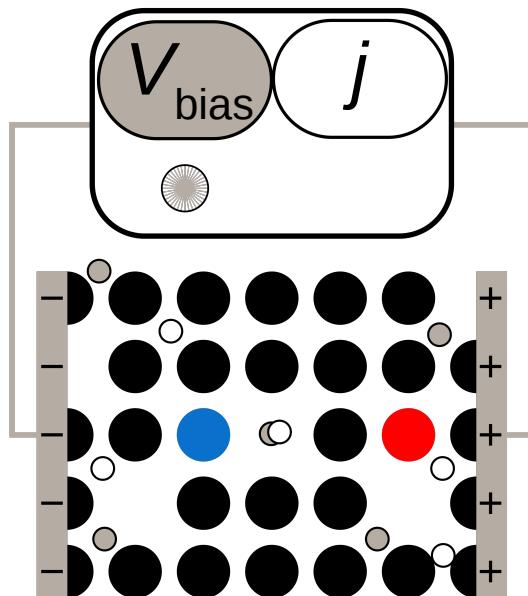
p-n junctions: Influence of defects

$$j = j_S \left(e^{\frac{eV_{\text{bias}}}{kT}} - 1 \right)$$

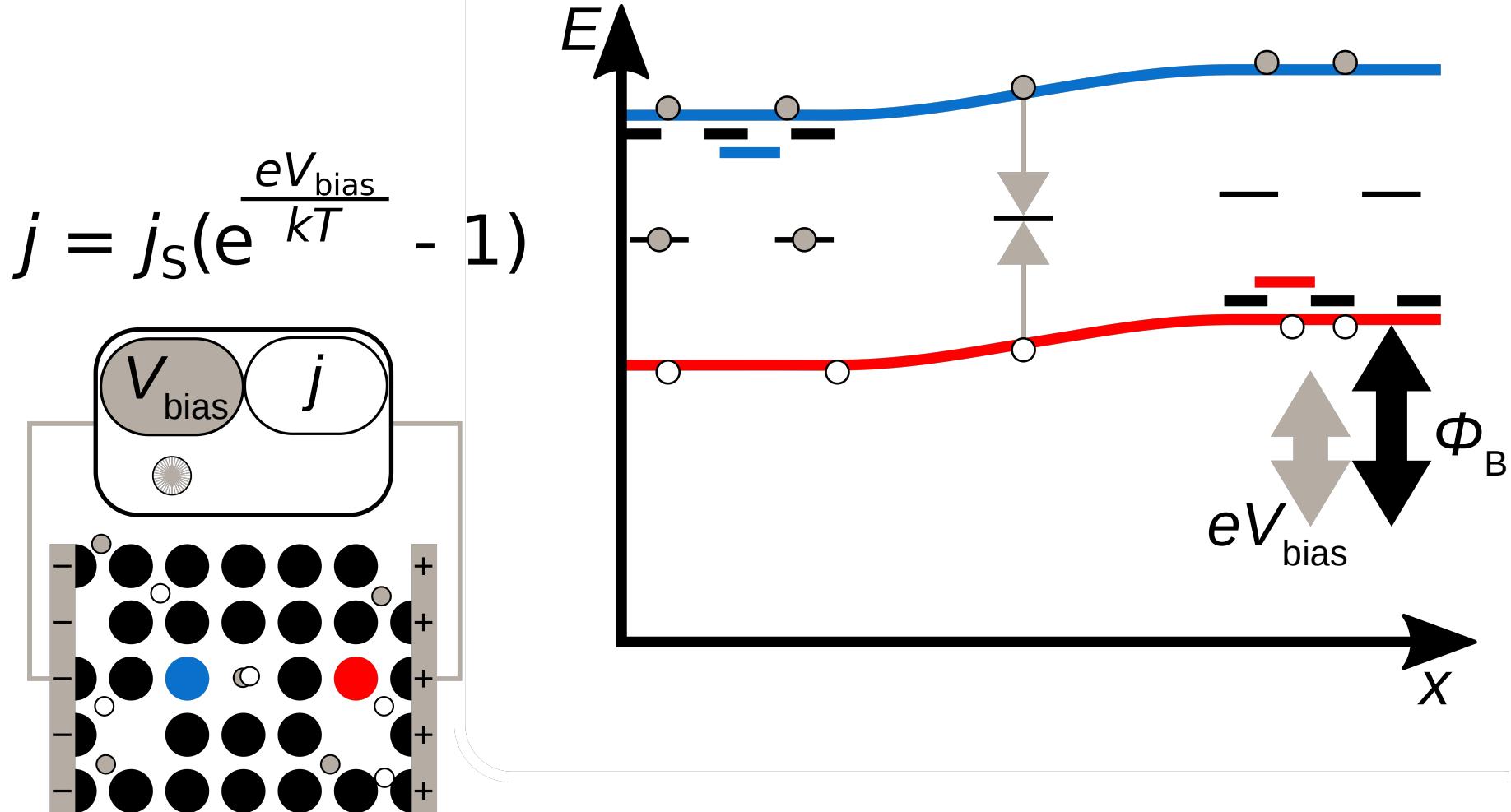


p-n junctions: Influence of defects

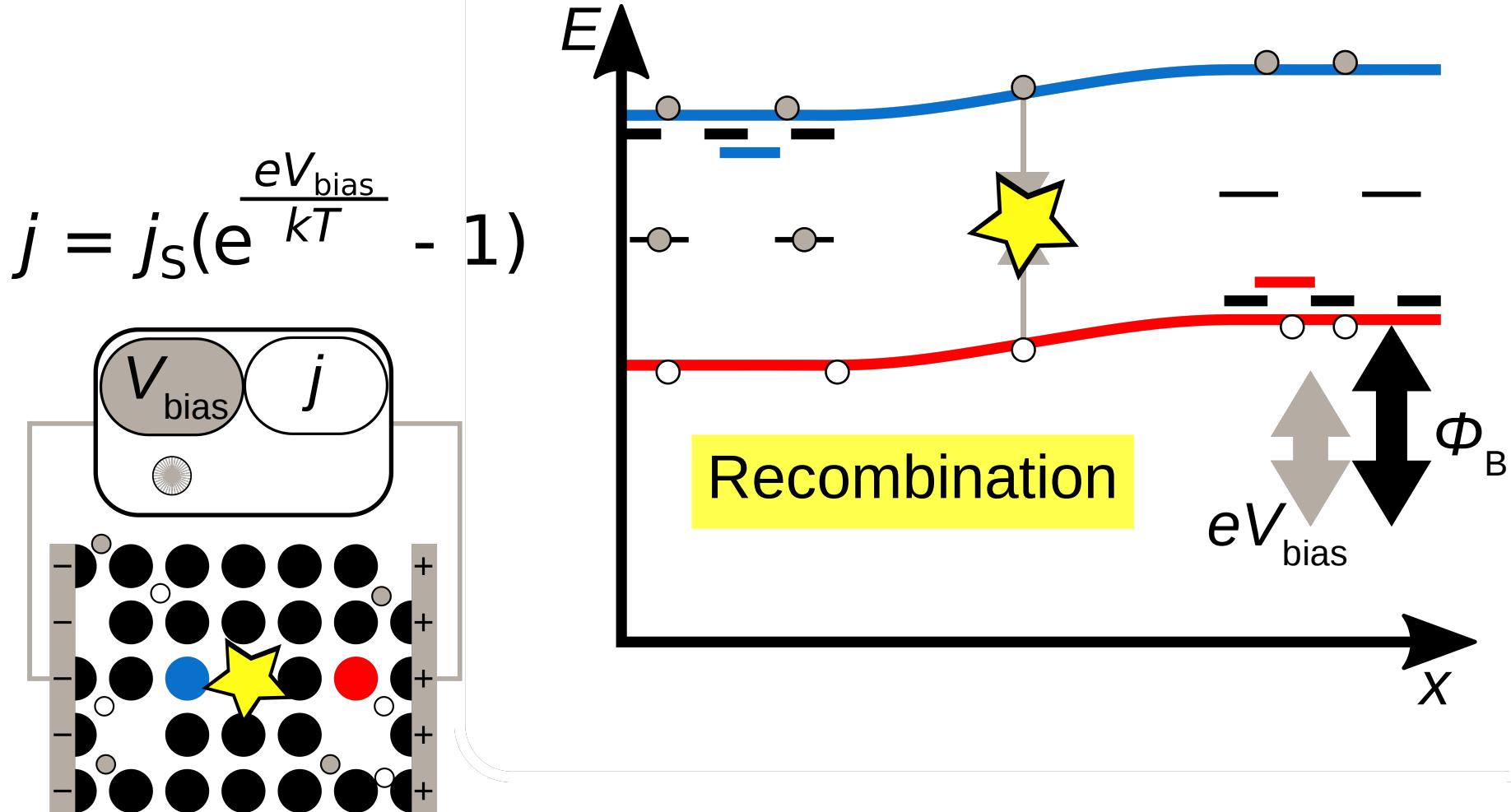
$$j = j_S \left(e^{\frac{eV_{\text{bias}}}{kT}} - 1 \right)$$



p-n junctions: Influence of defects



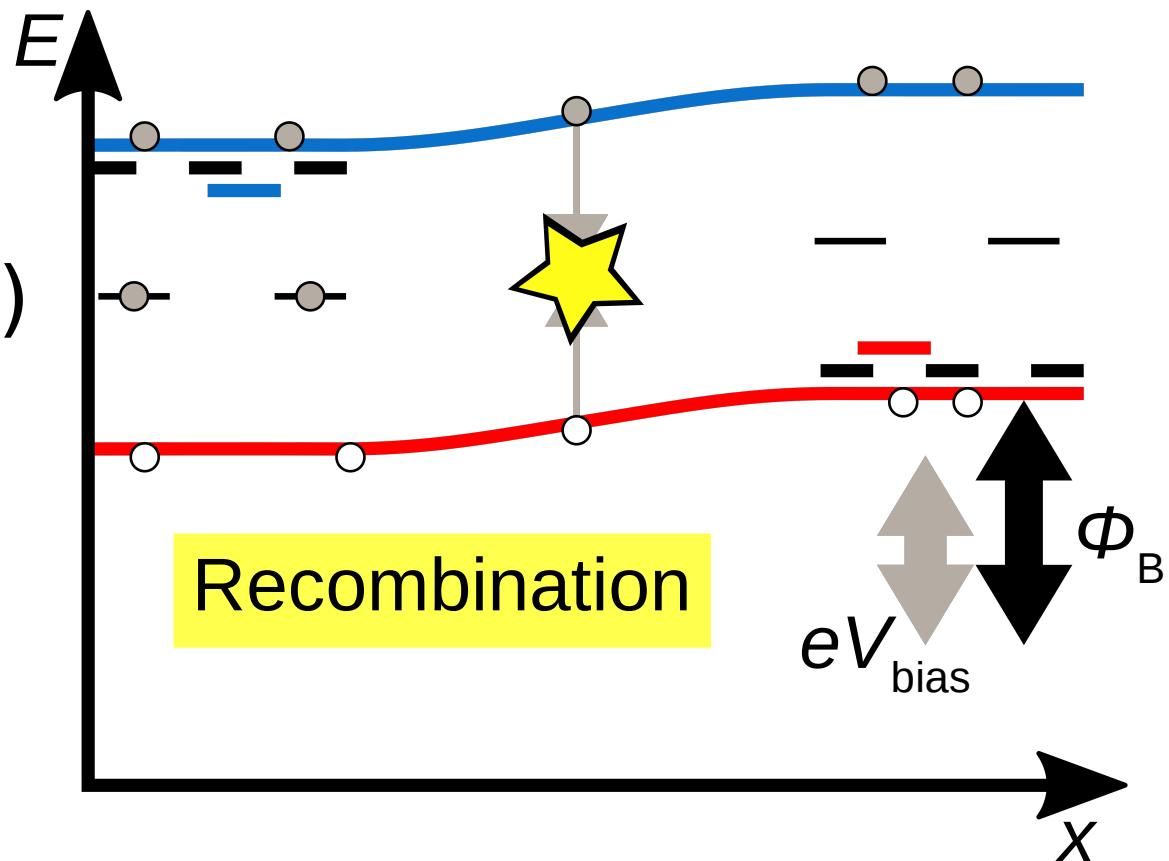
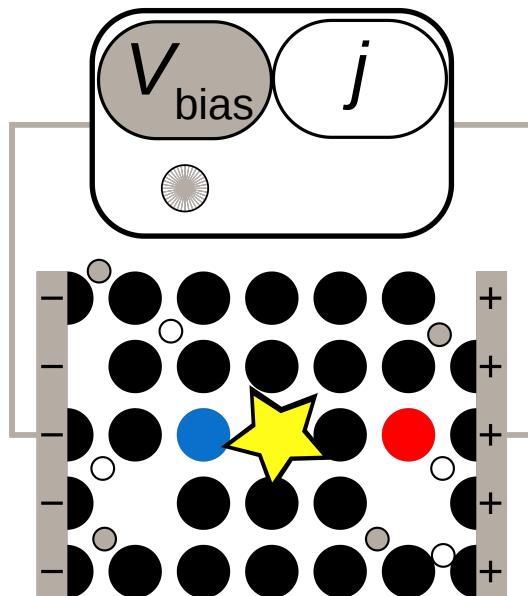
p-n junctions: Influence of defects



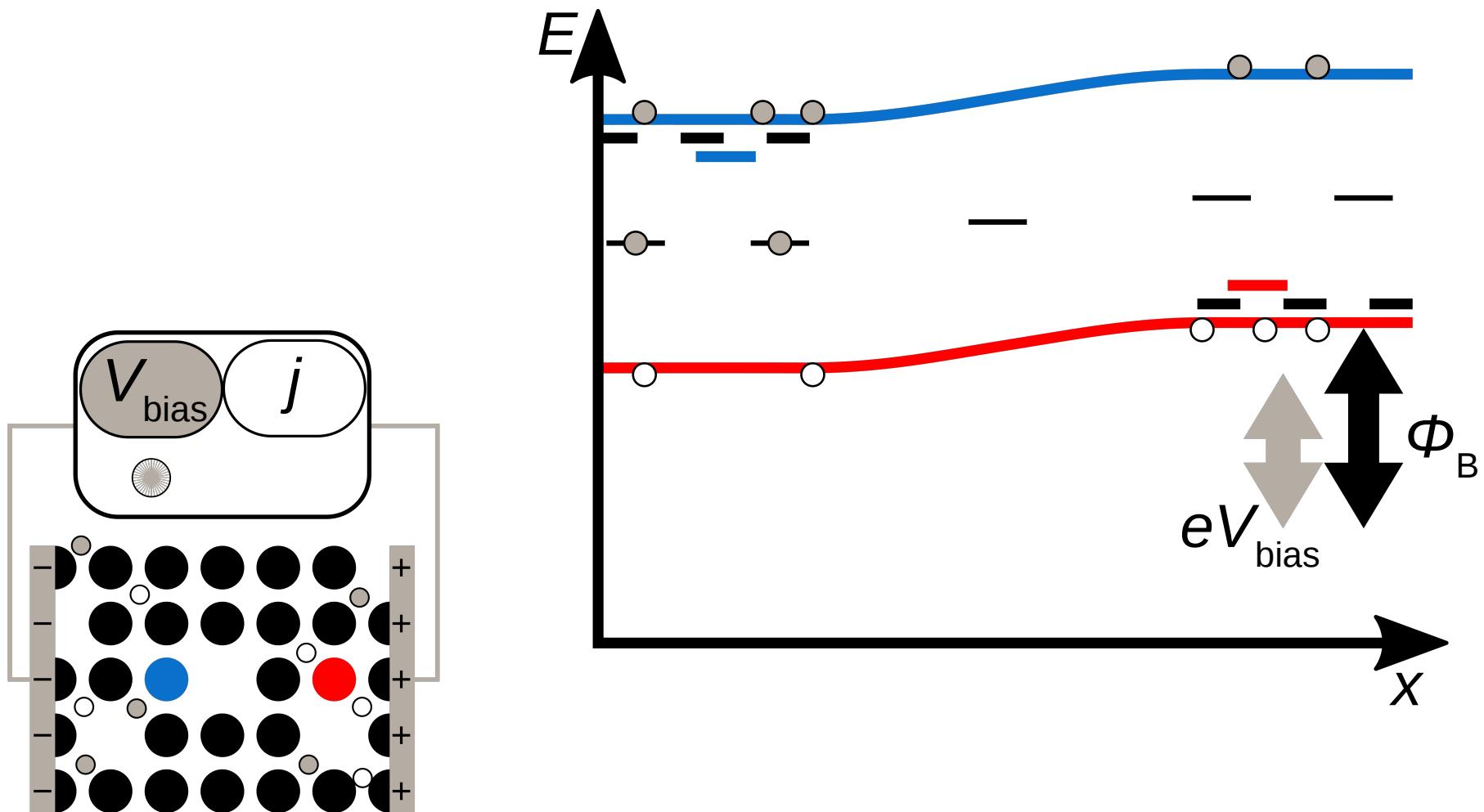
p-n junctions: Influence of defects

$$1 \leq n_{ideal} \leq 2$$

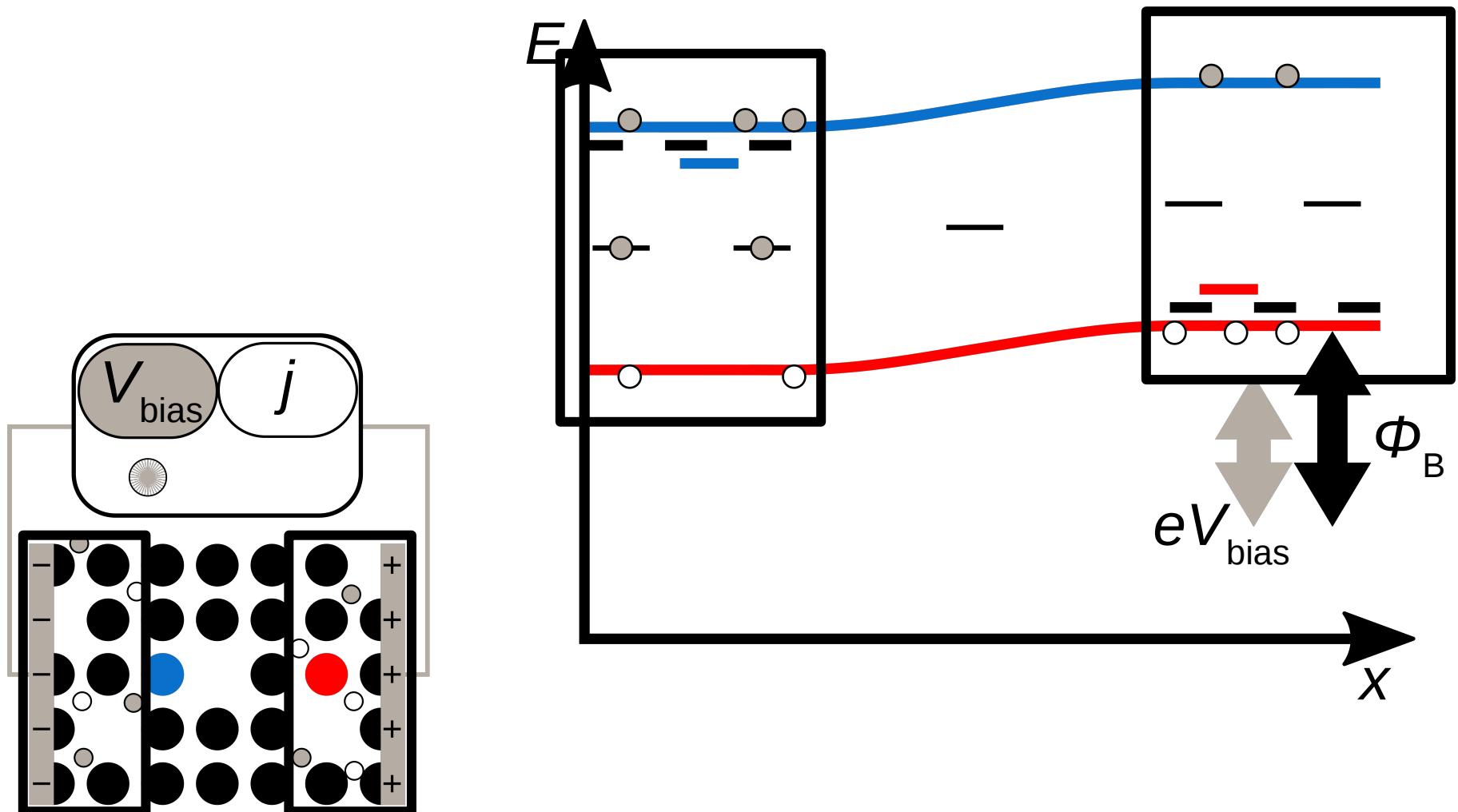
$$j = j_S(e^{\frac{eV_{bias}}{n_{ideal}kT}} - 1)$$



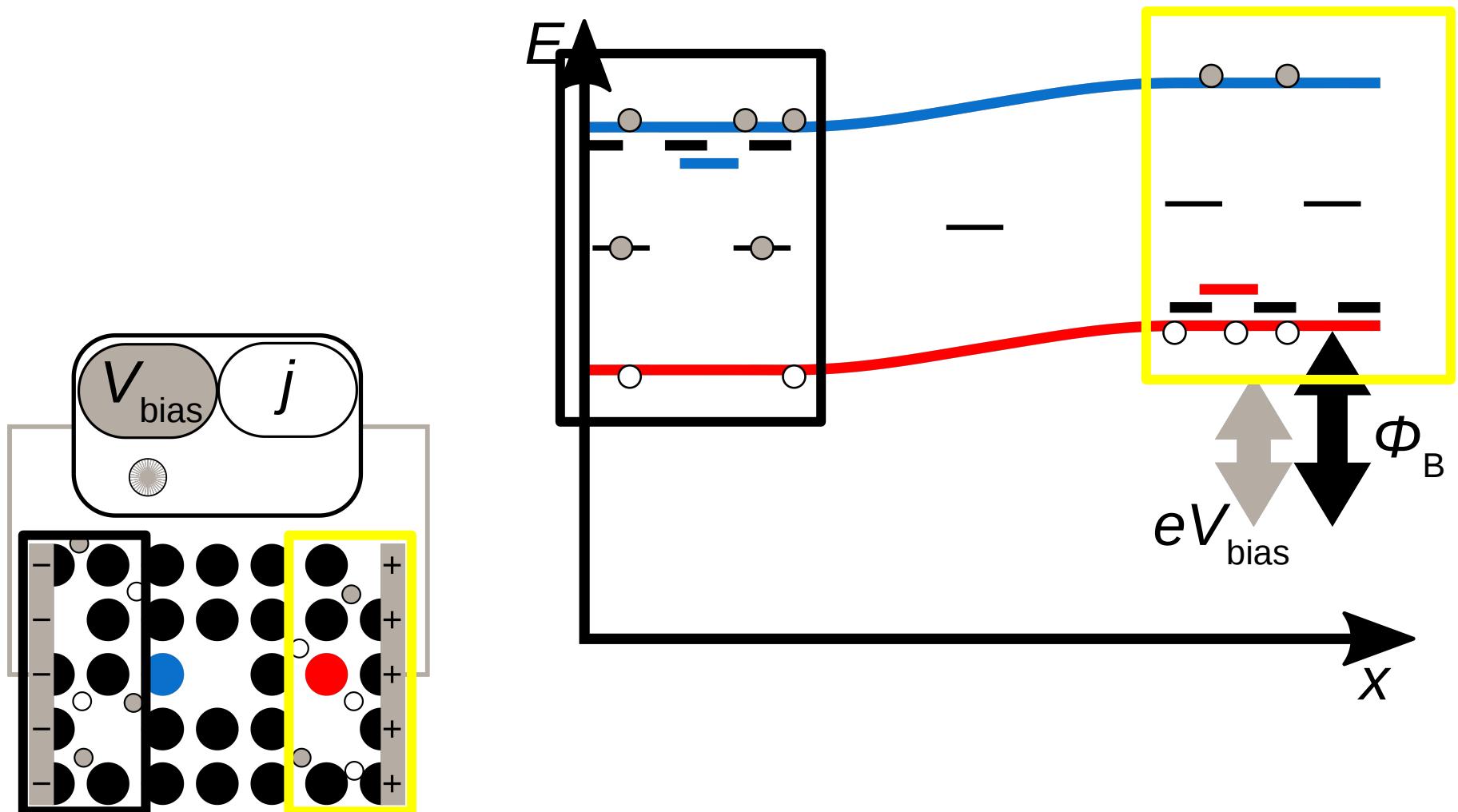
p-n junctions: Series resistance



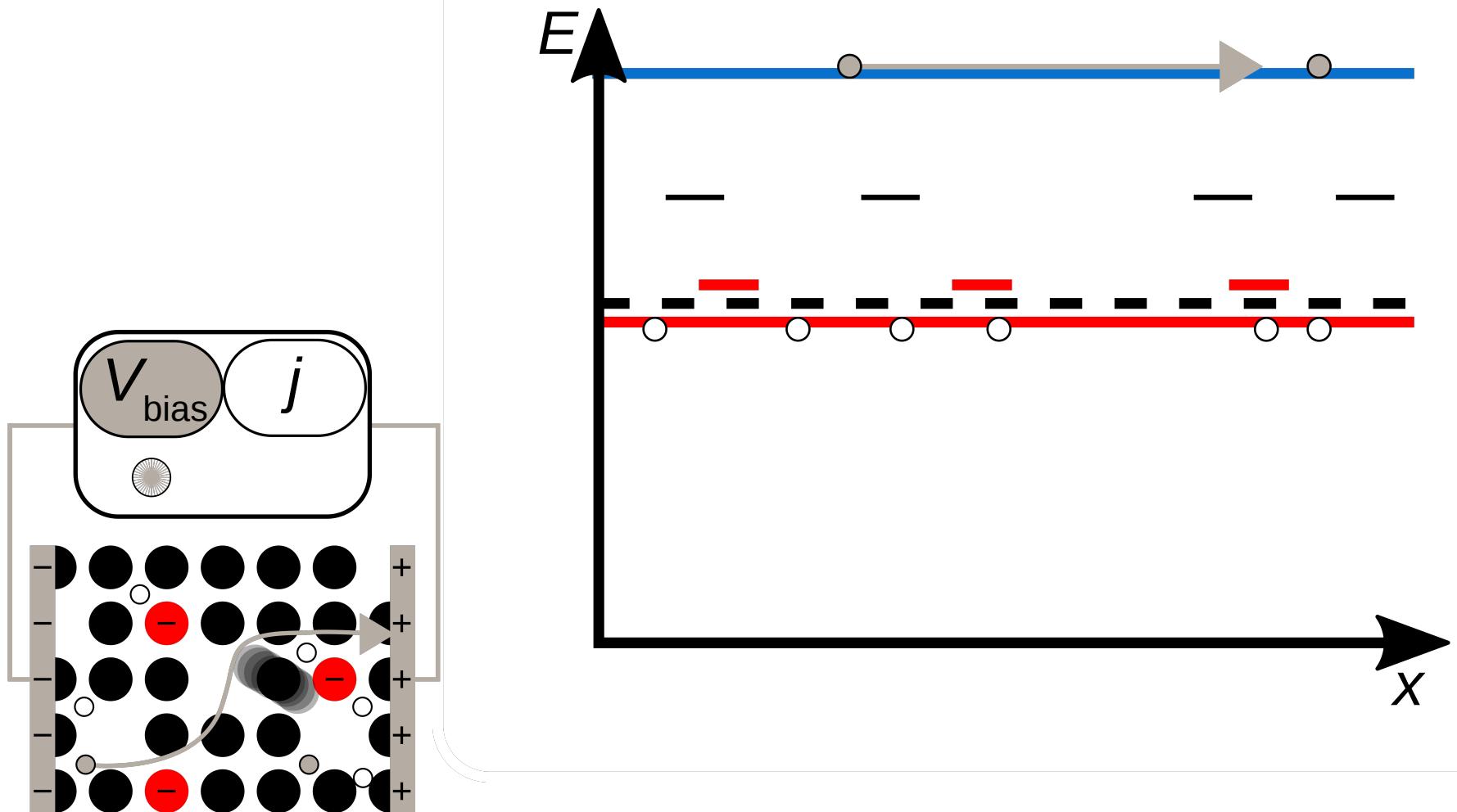
p-n junctions: Series resistance



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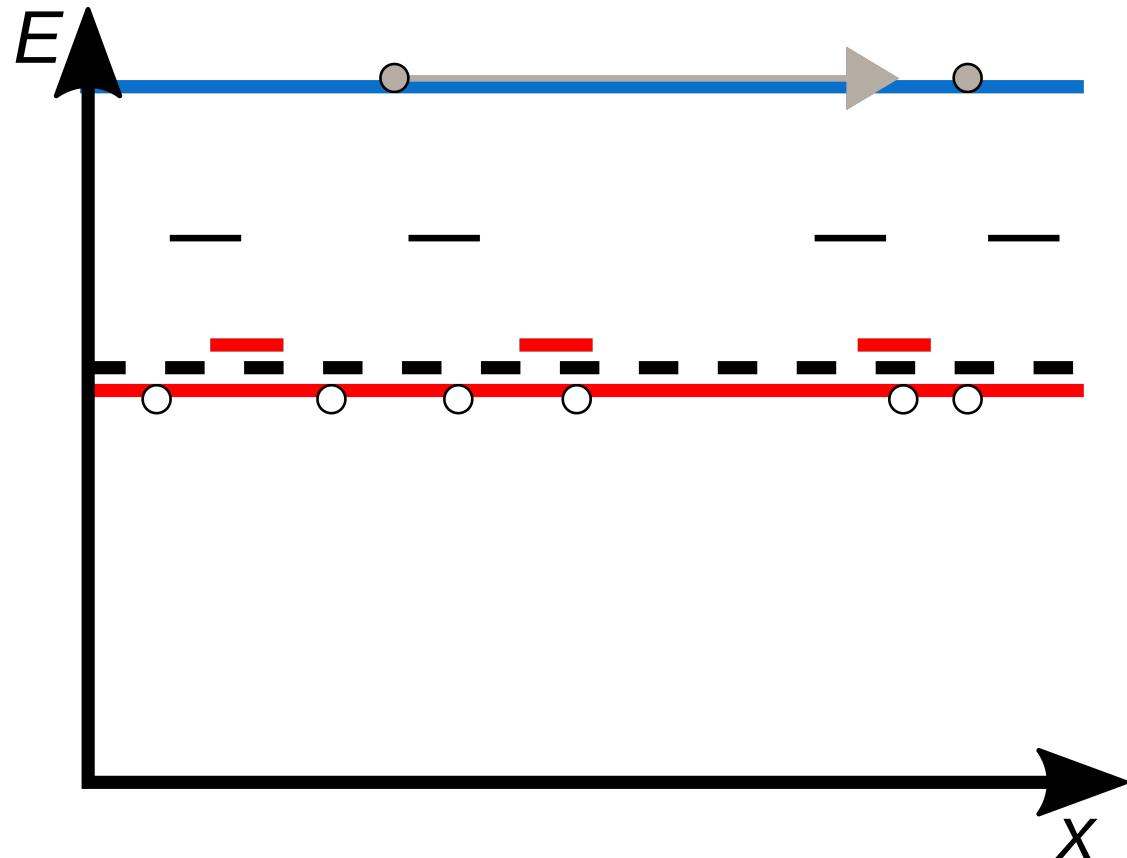
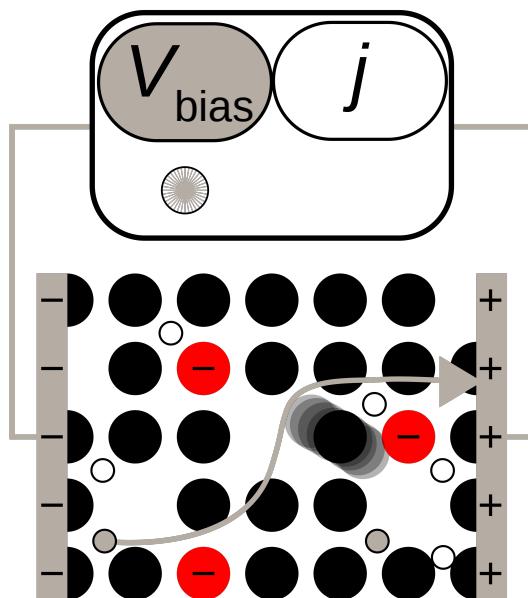


p-n junctions: Series resistance



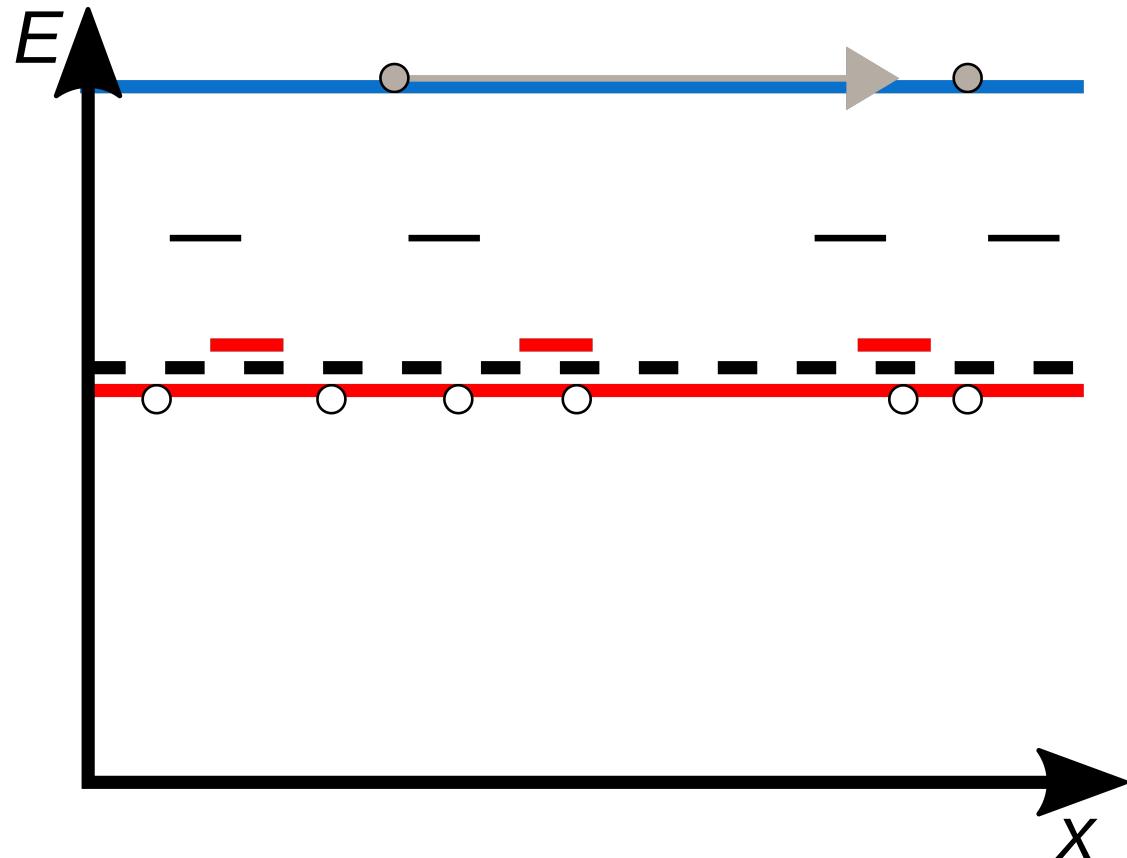
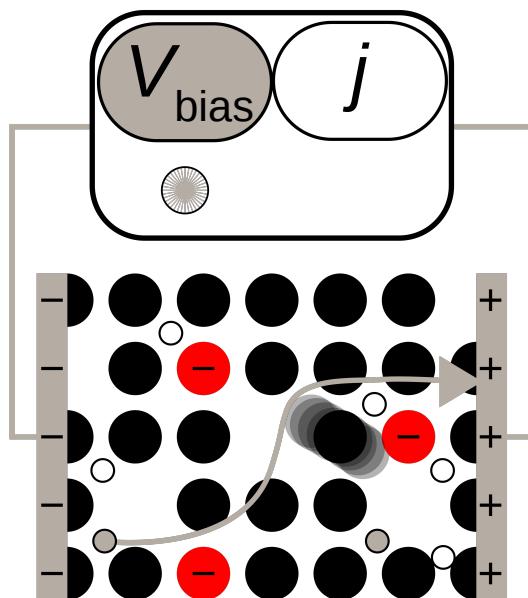
p-n junctions: Series resistance

Intrinsic Mobility



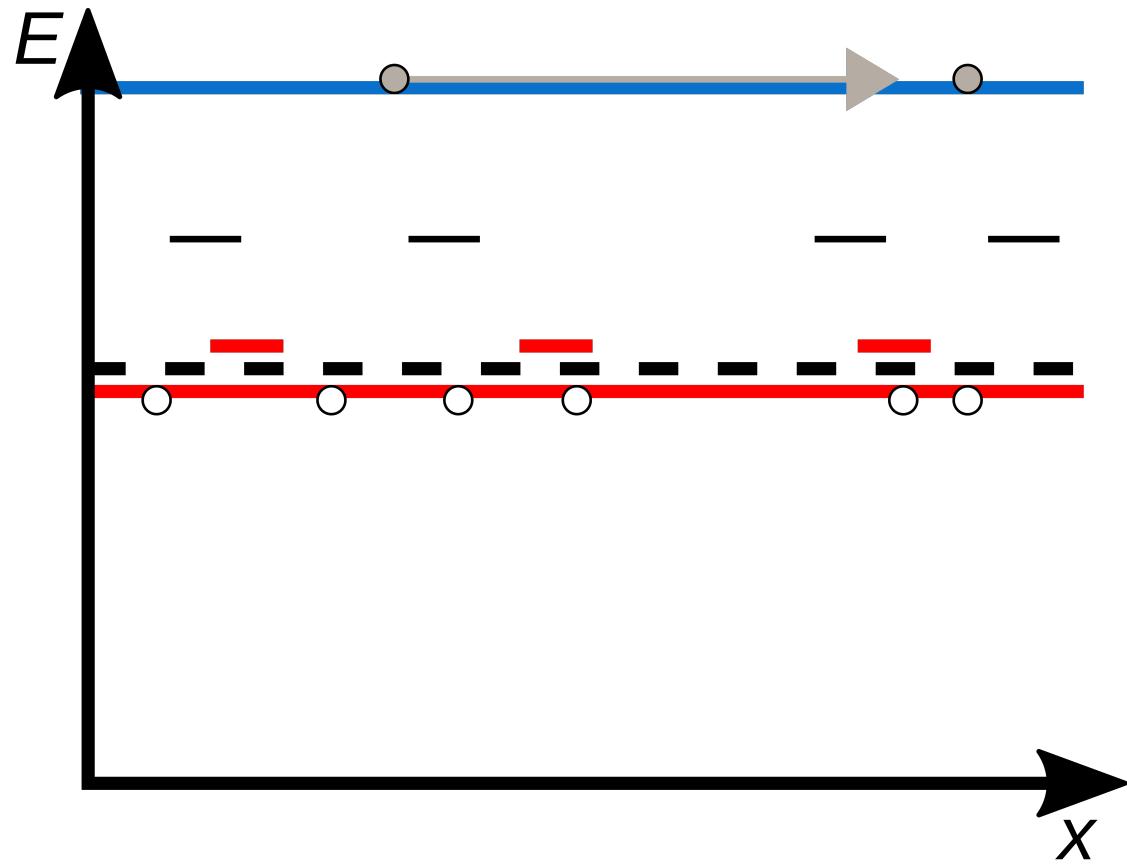
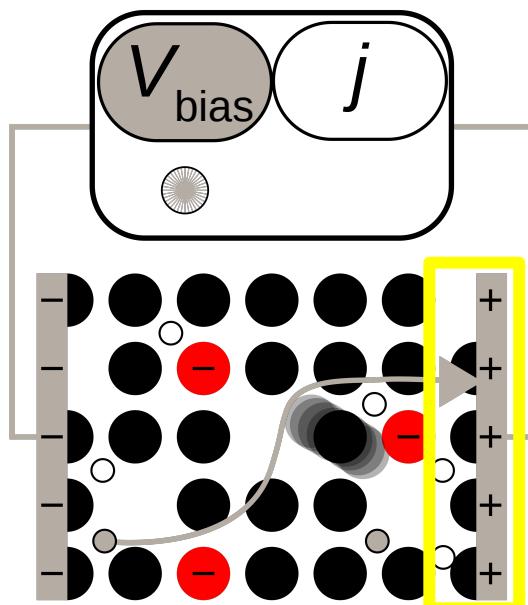
p-n junctions: Series resistance

Intrinsic Mobility
Scattering



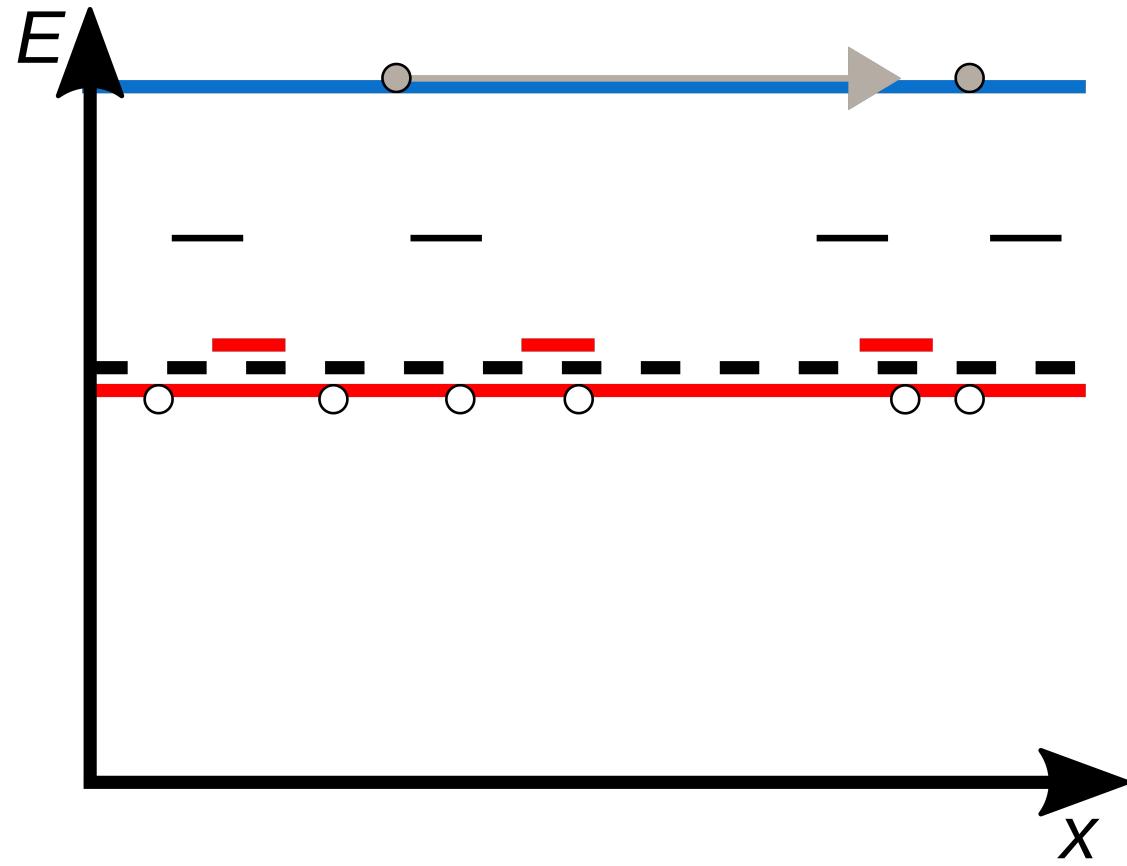
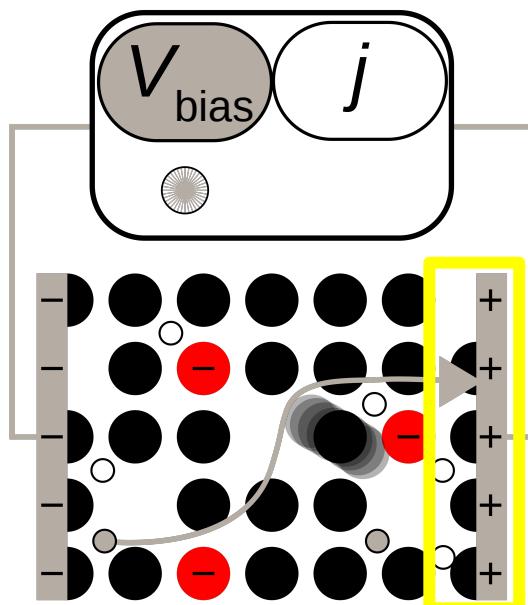
p-n junctions: Series resistance

Intrinsic Mobility
Scattering

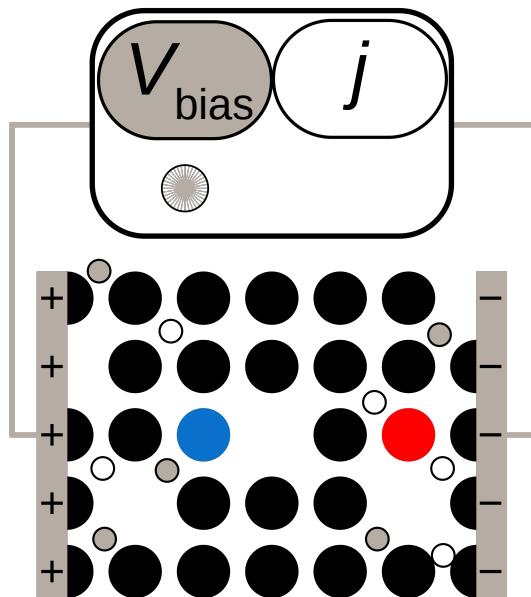


p-n junctions: Series resistance

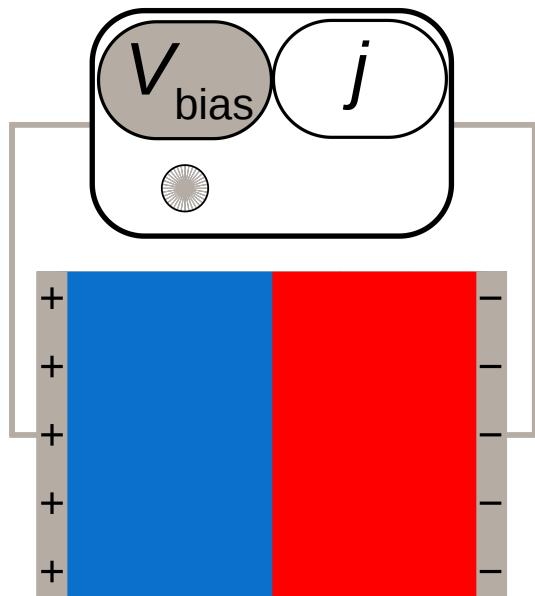
Intrinsic Mobility
Scattering
Contacts



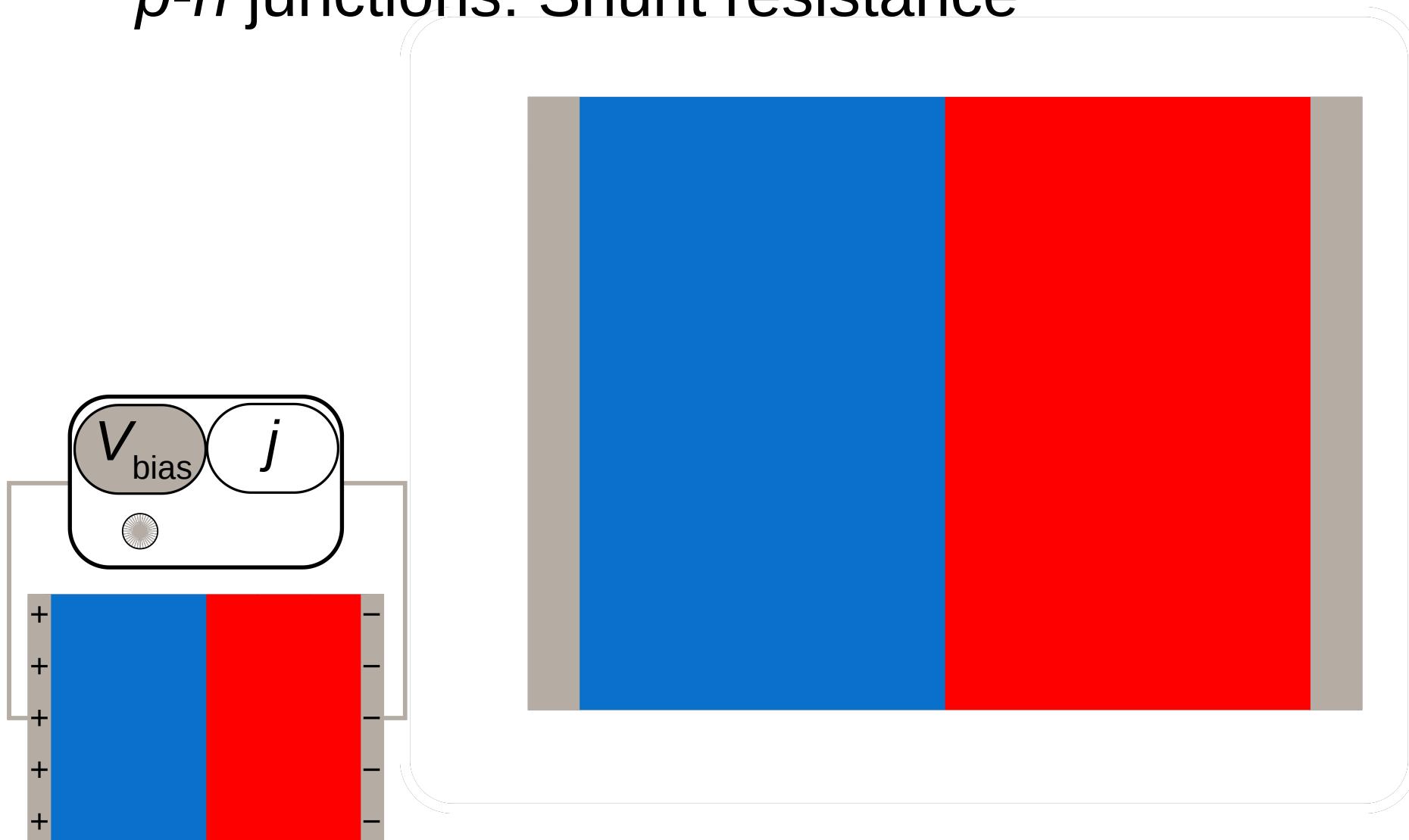
p-n junctions: Shunt resistance



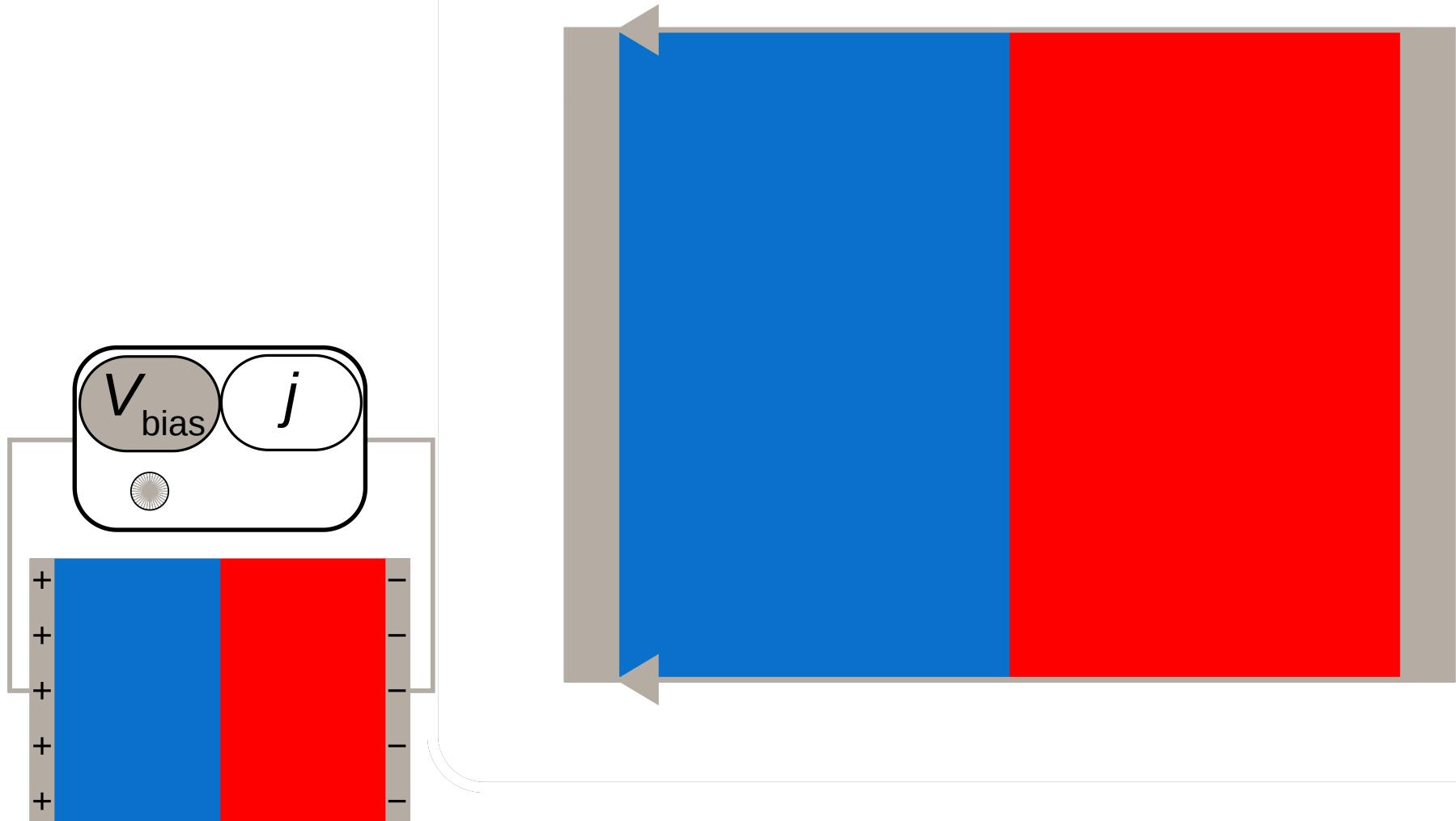
p-n junctions: Shunt resistance



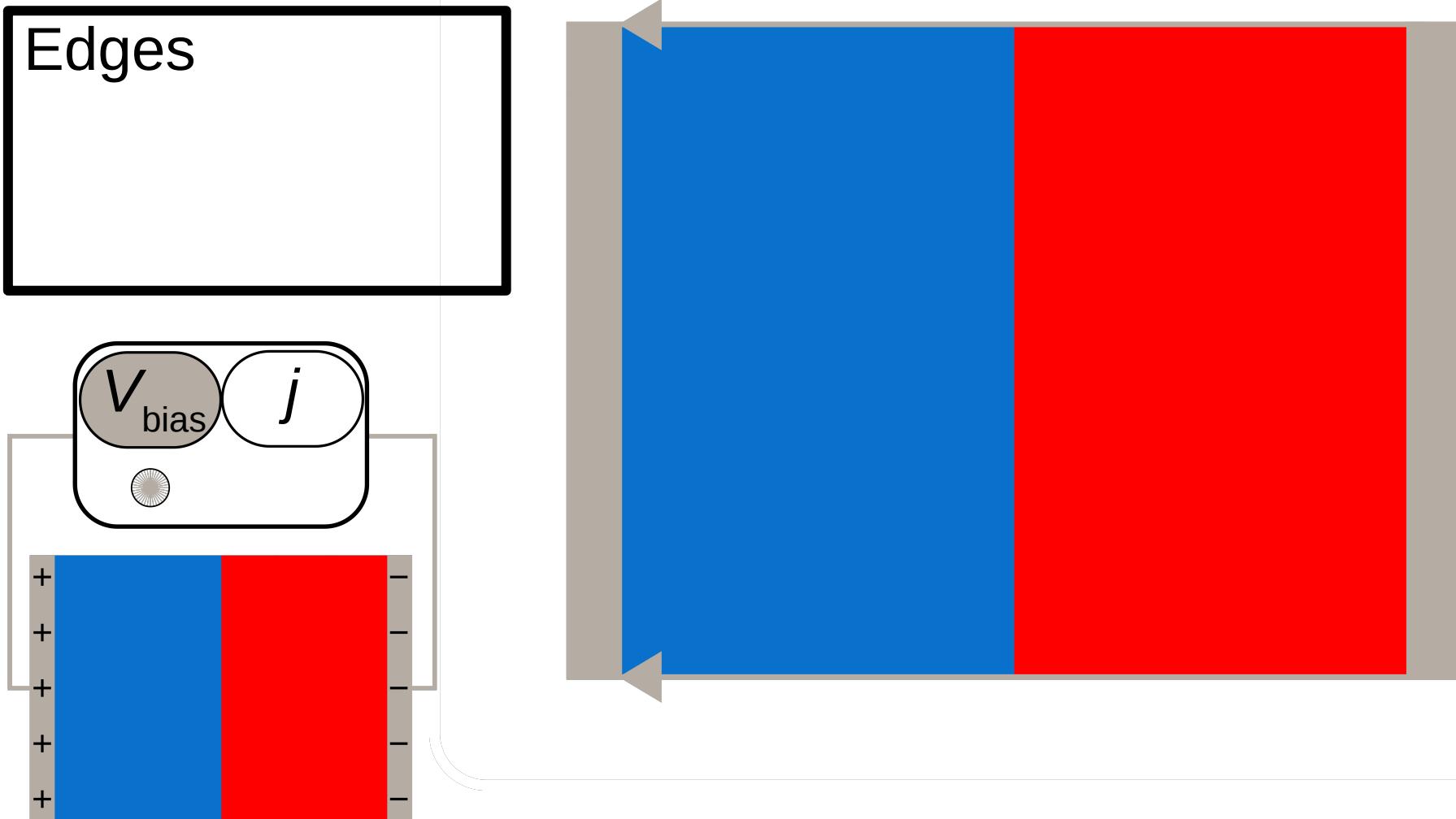
p-n junctions: Shunt resistance



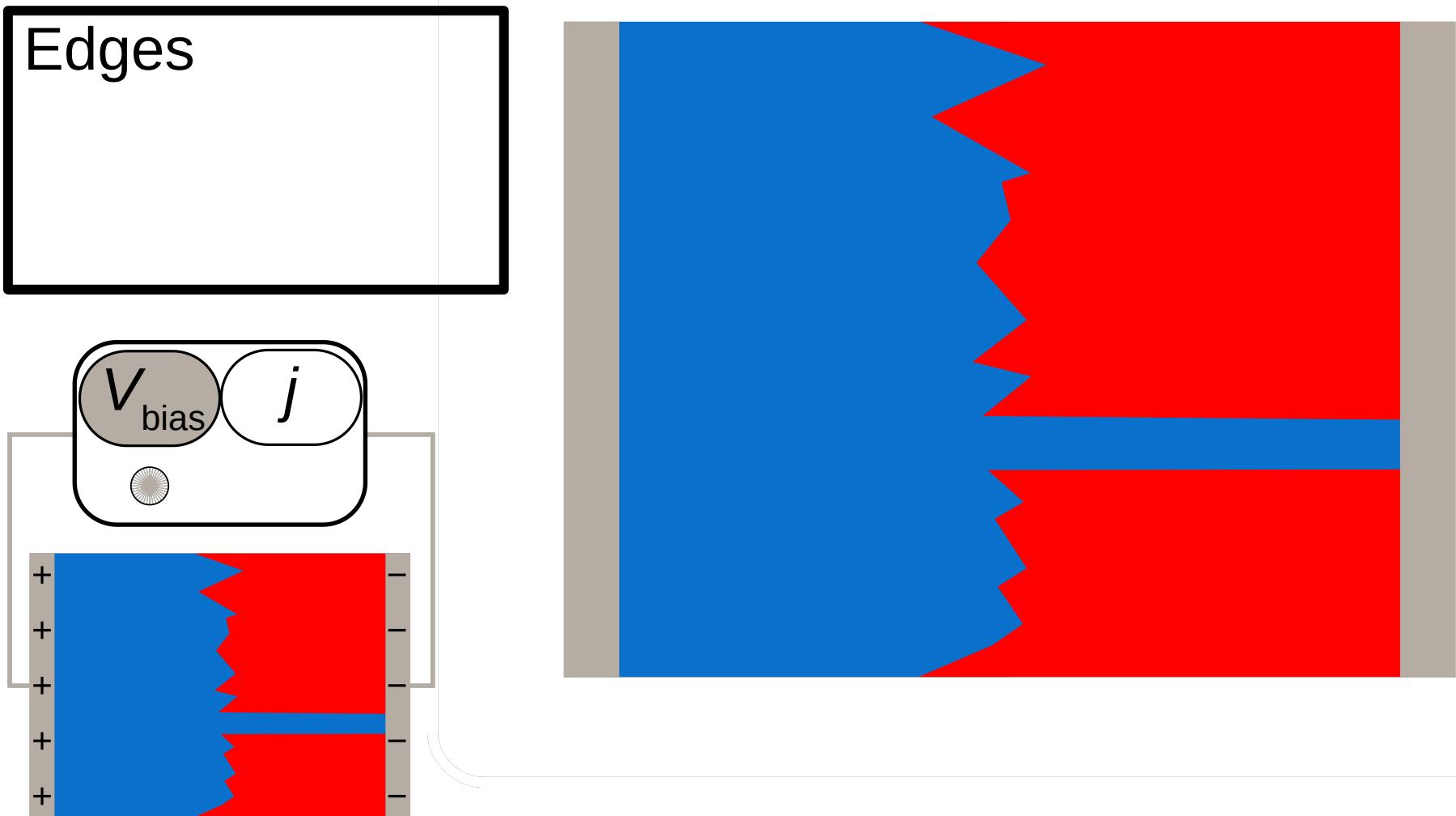
p-n junctions: Shunt resistance



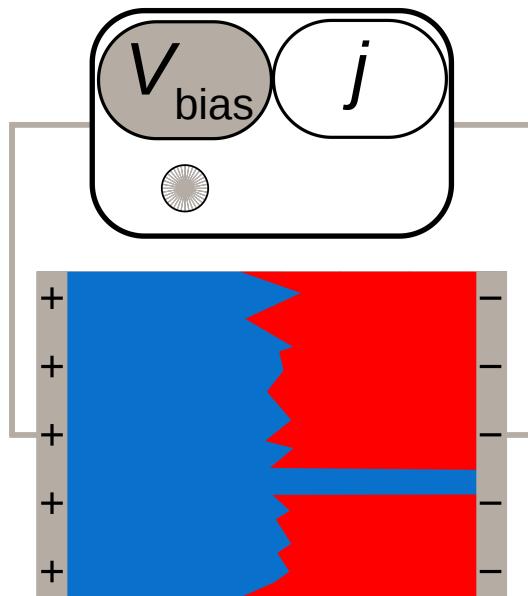
p-n junctions: Shunt resistance



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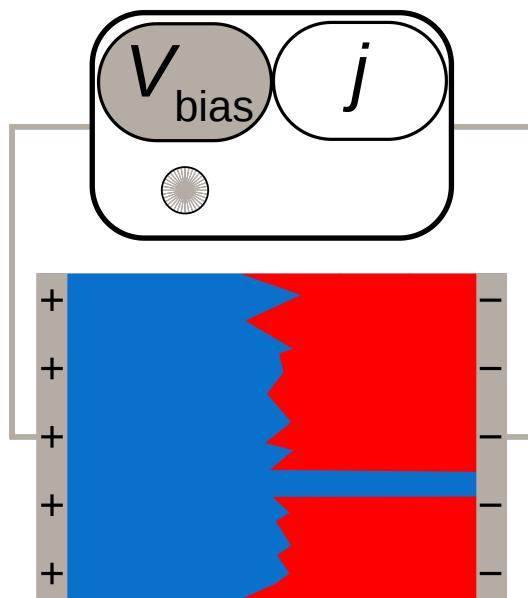


p-n junctions: Shunt resistance



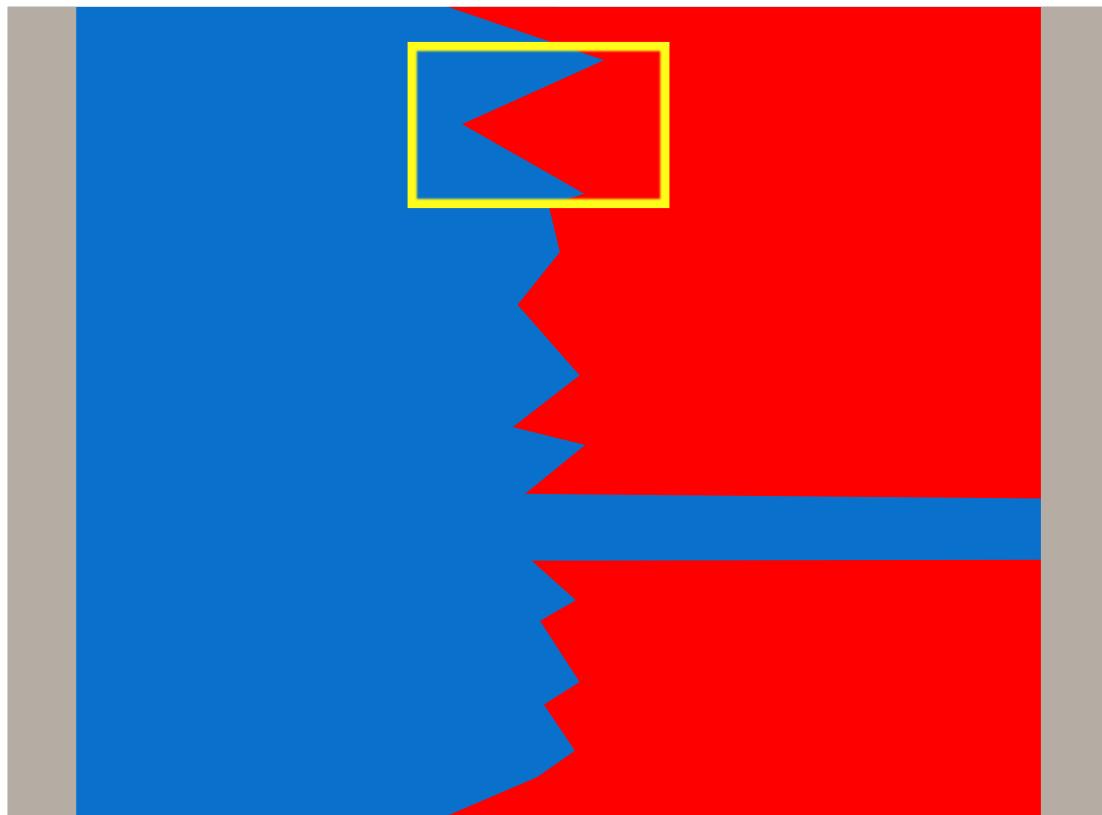
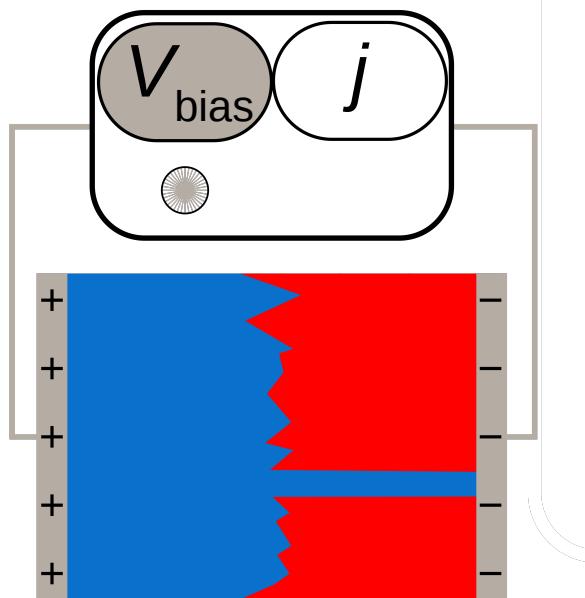
p-n junctions: Shunt resistance

Edges
Punch throughs



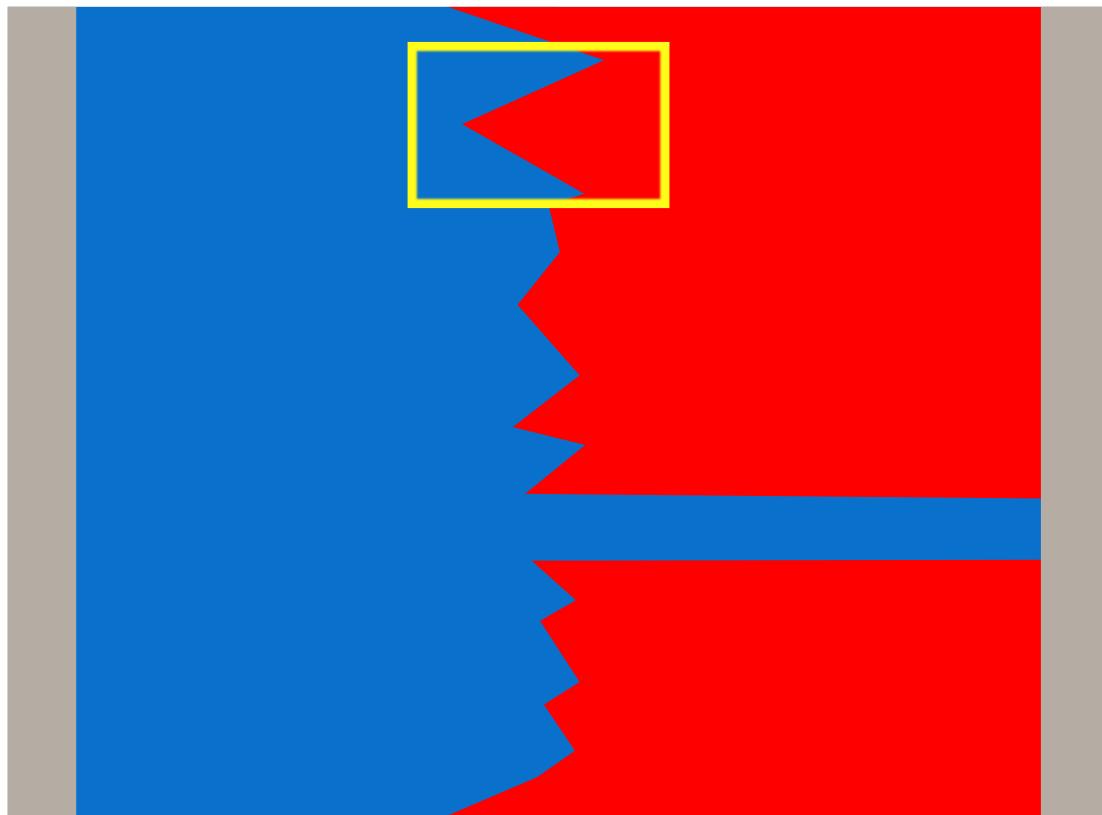
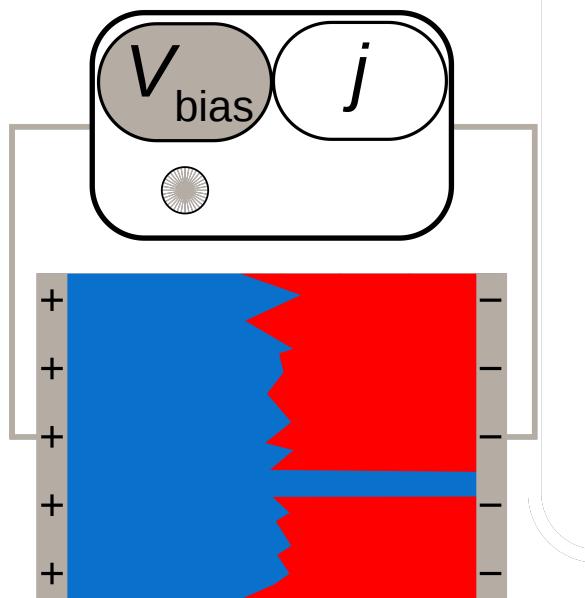
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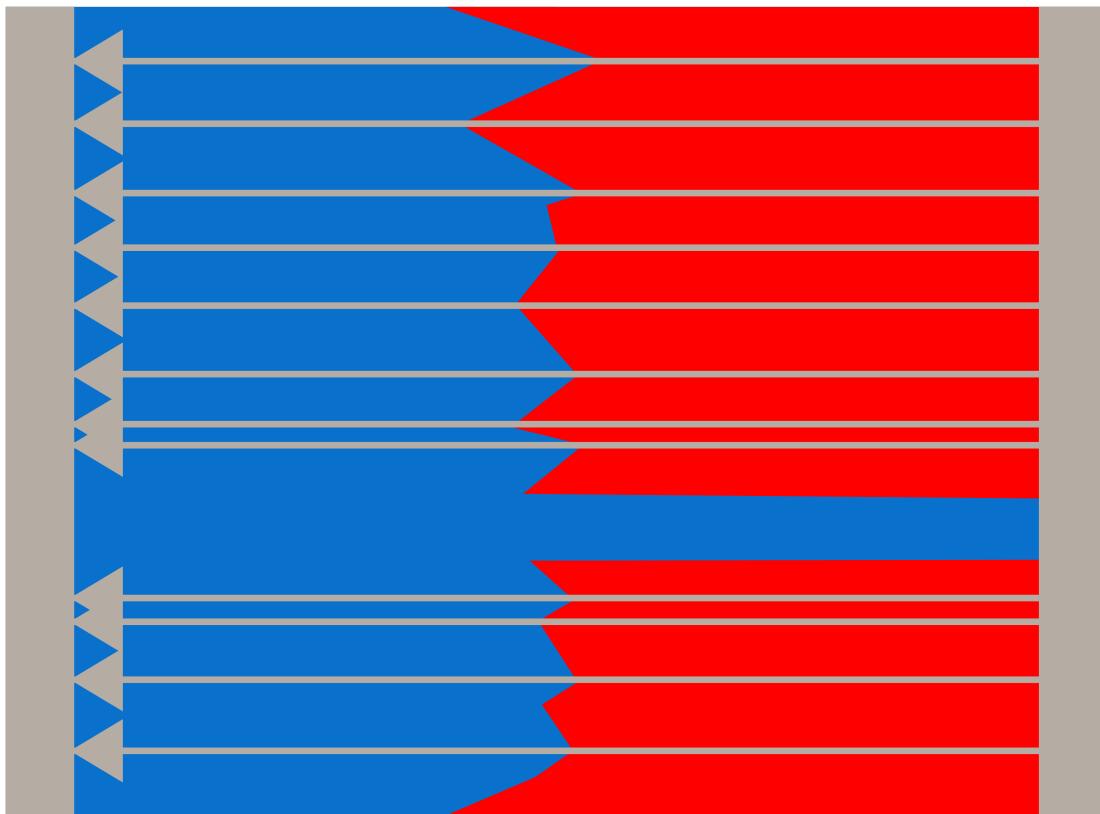
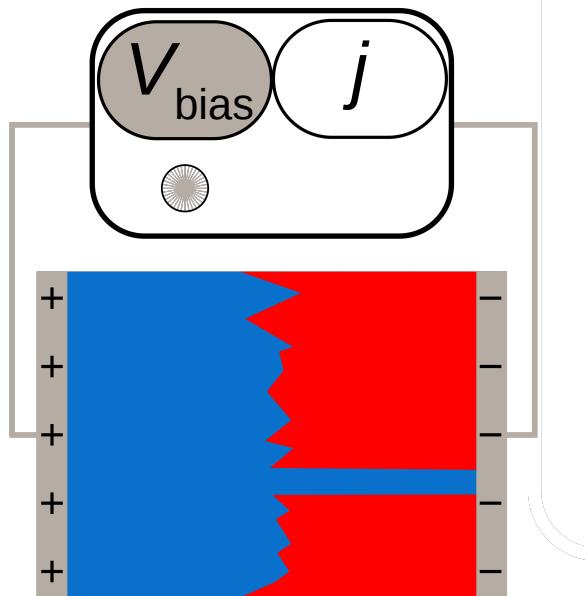
p-n junctions: Shunt resistance

Edges
Punch throughs
Tunneling



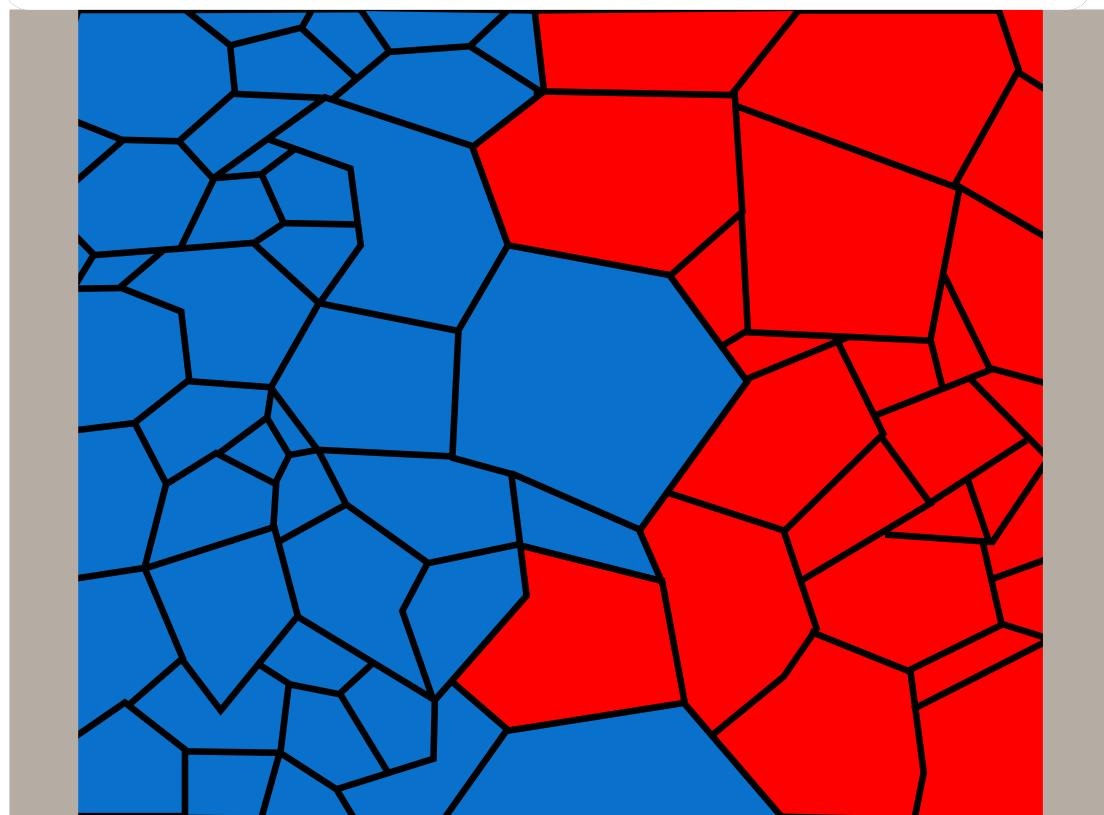
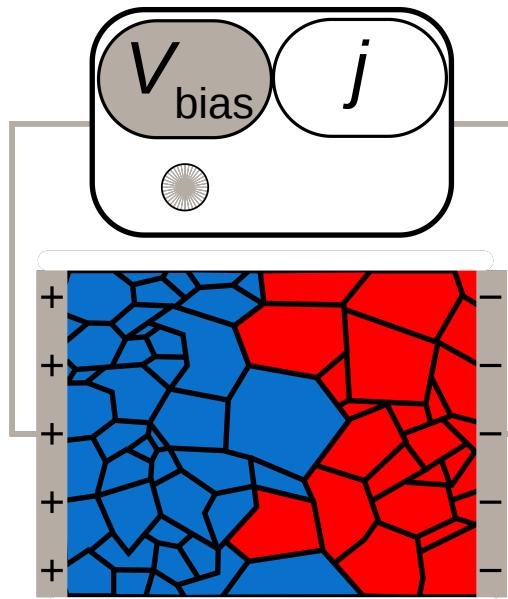
p-n junctions: Shunt resistance

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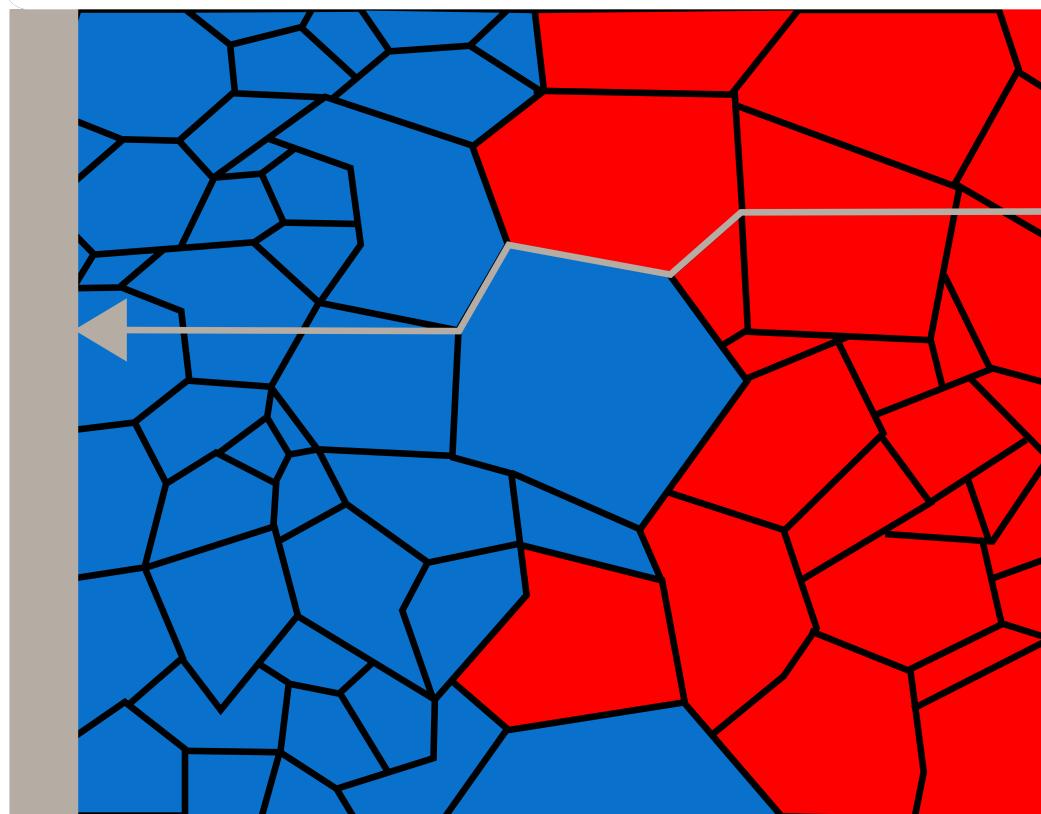
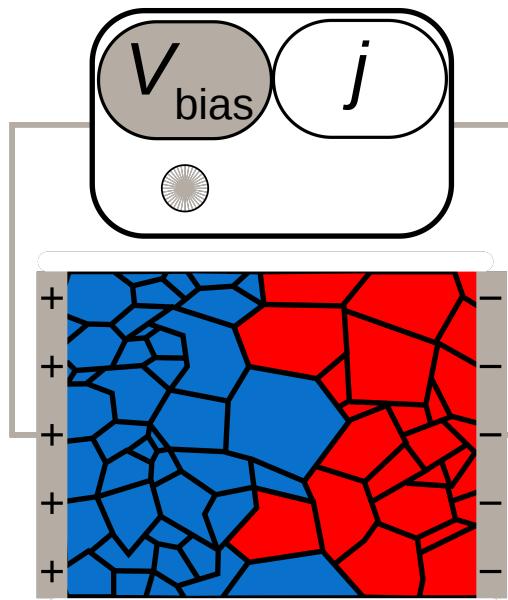
p-n junctions: Shunt resistance

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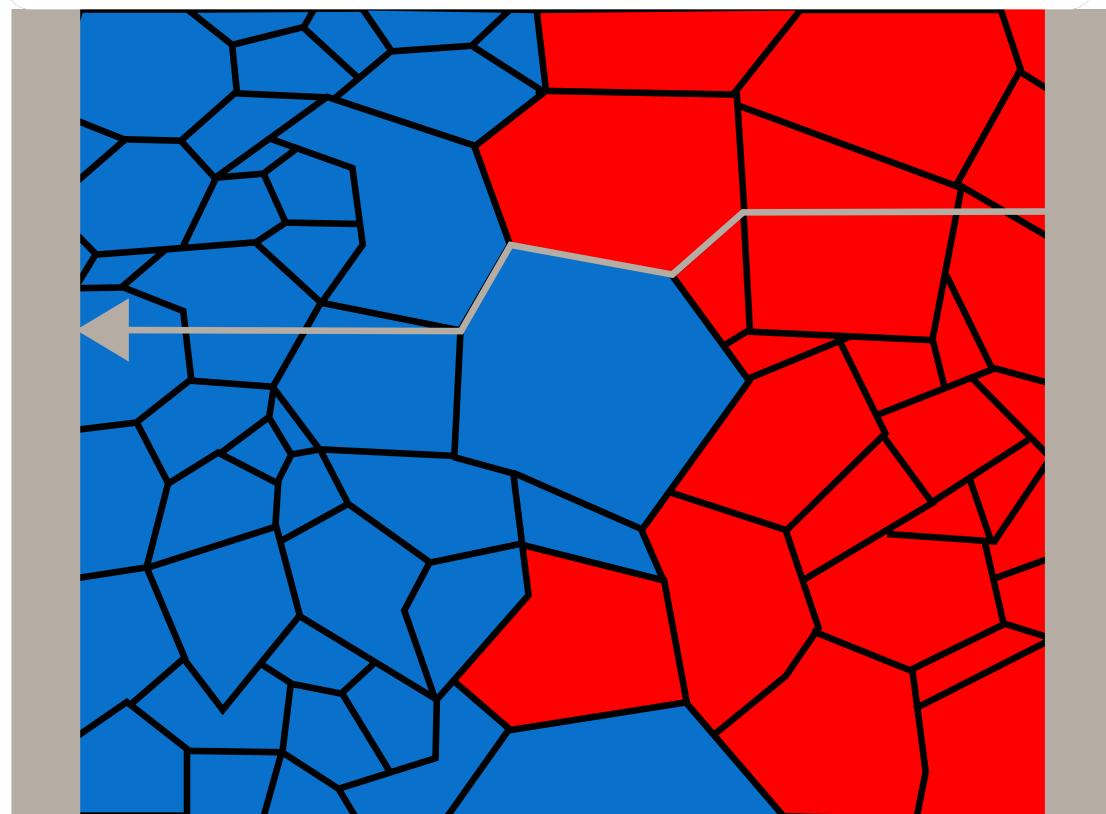
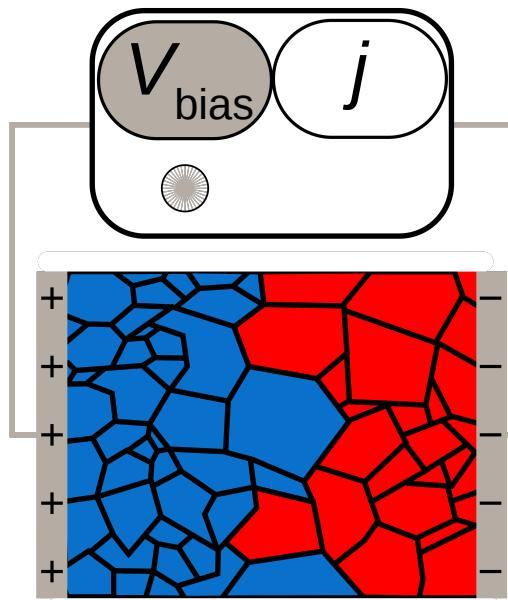
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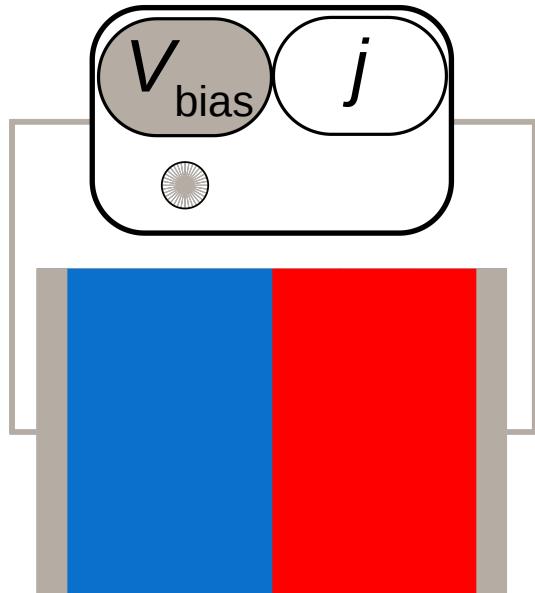


p-n junctions: Shunt resistance

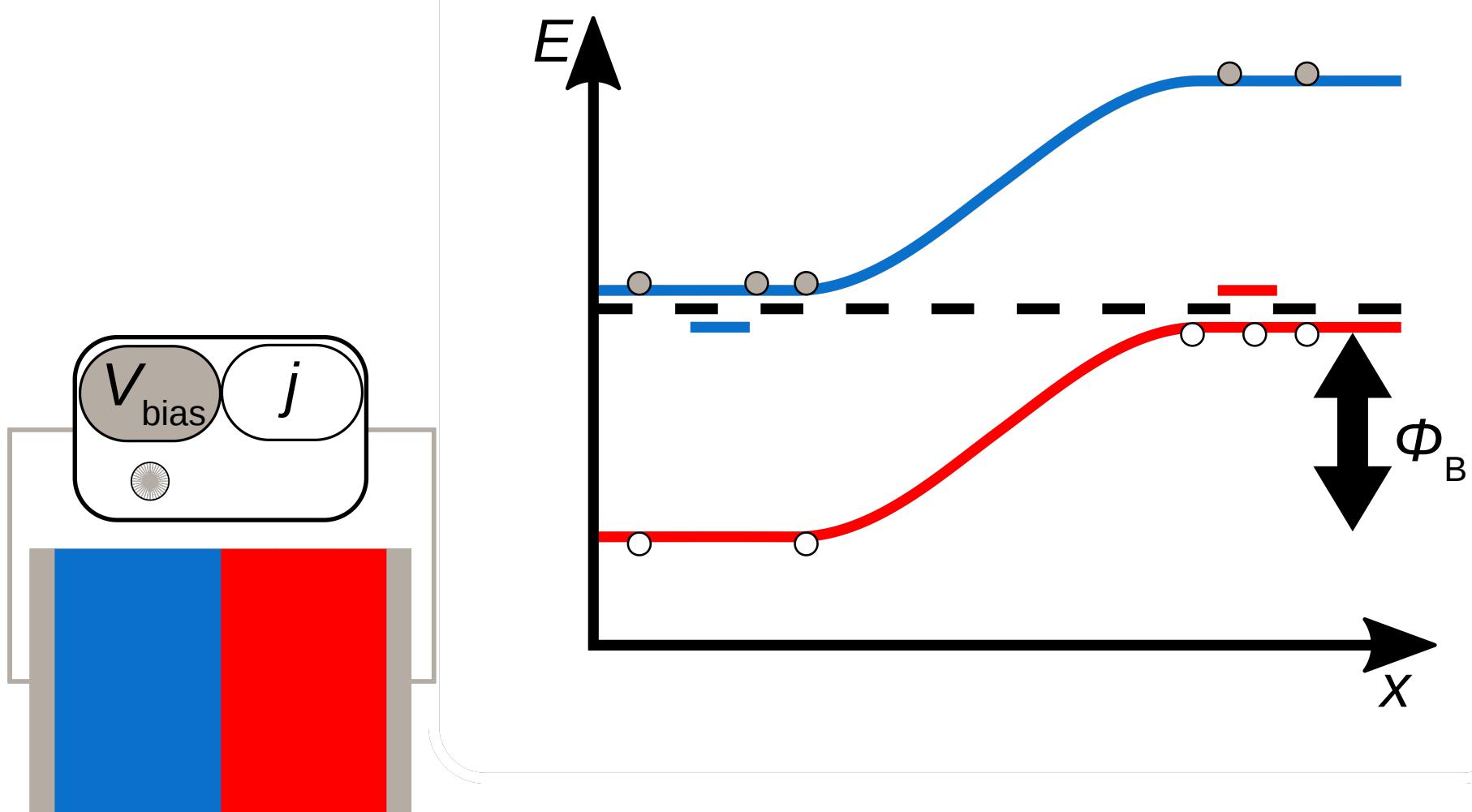
Edges
Punch throughs
Tunneling
Grain boundaries



p-n junctions: Equivalent circuit

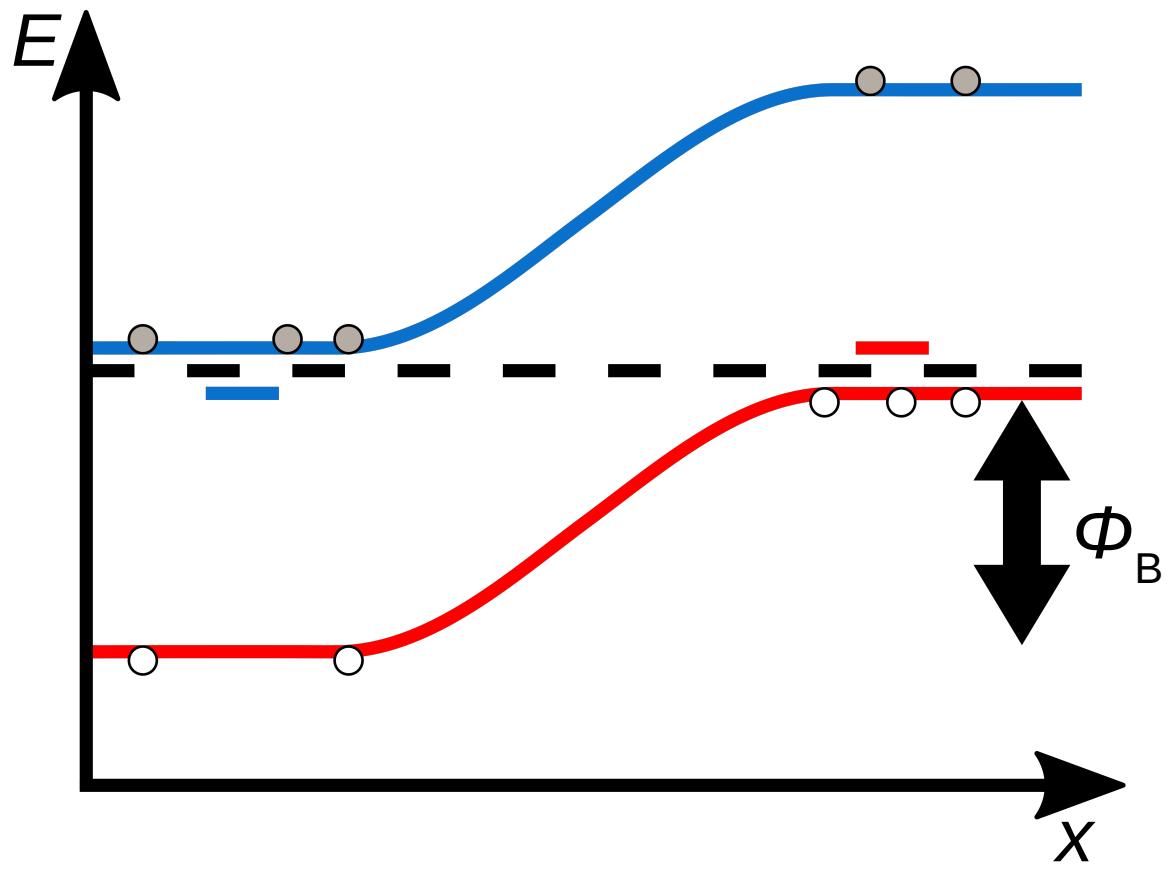
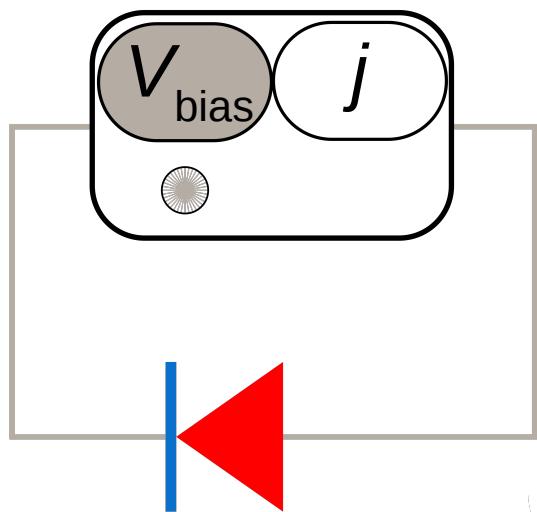


p-n junctions: Equivalent circuit



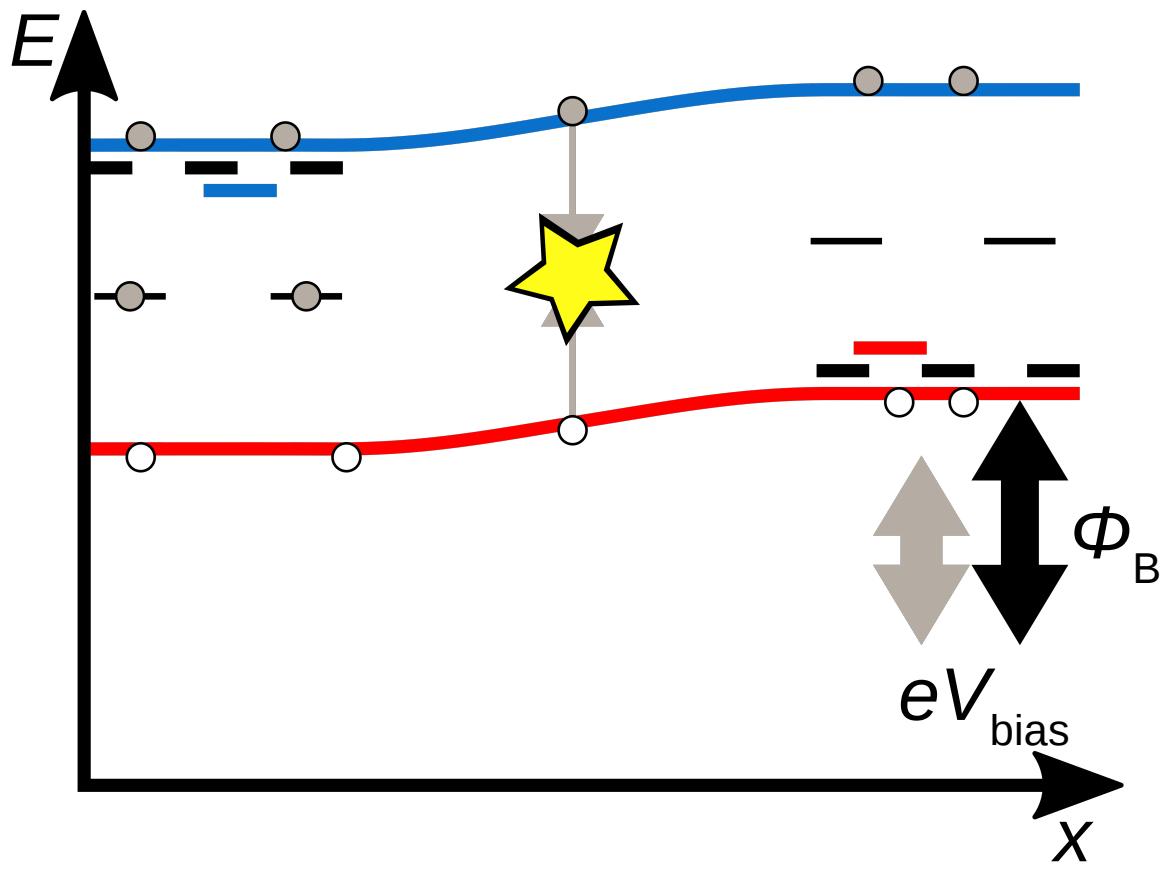
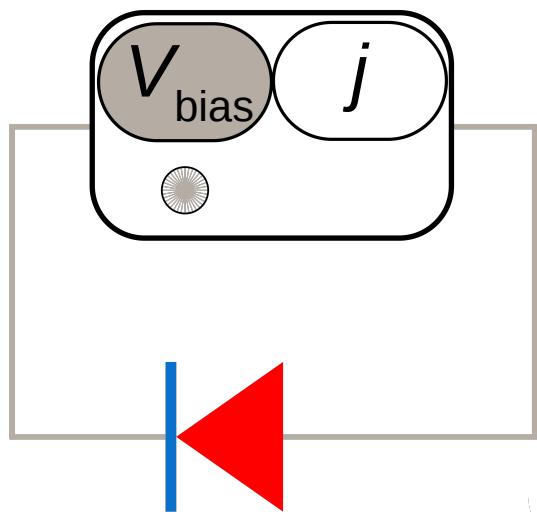
p-n junctions: Equivalent circuit

$$j = j_S(e^{\frac{eV_{bias}}{kT}} - 1)$$



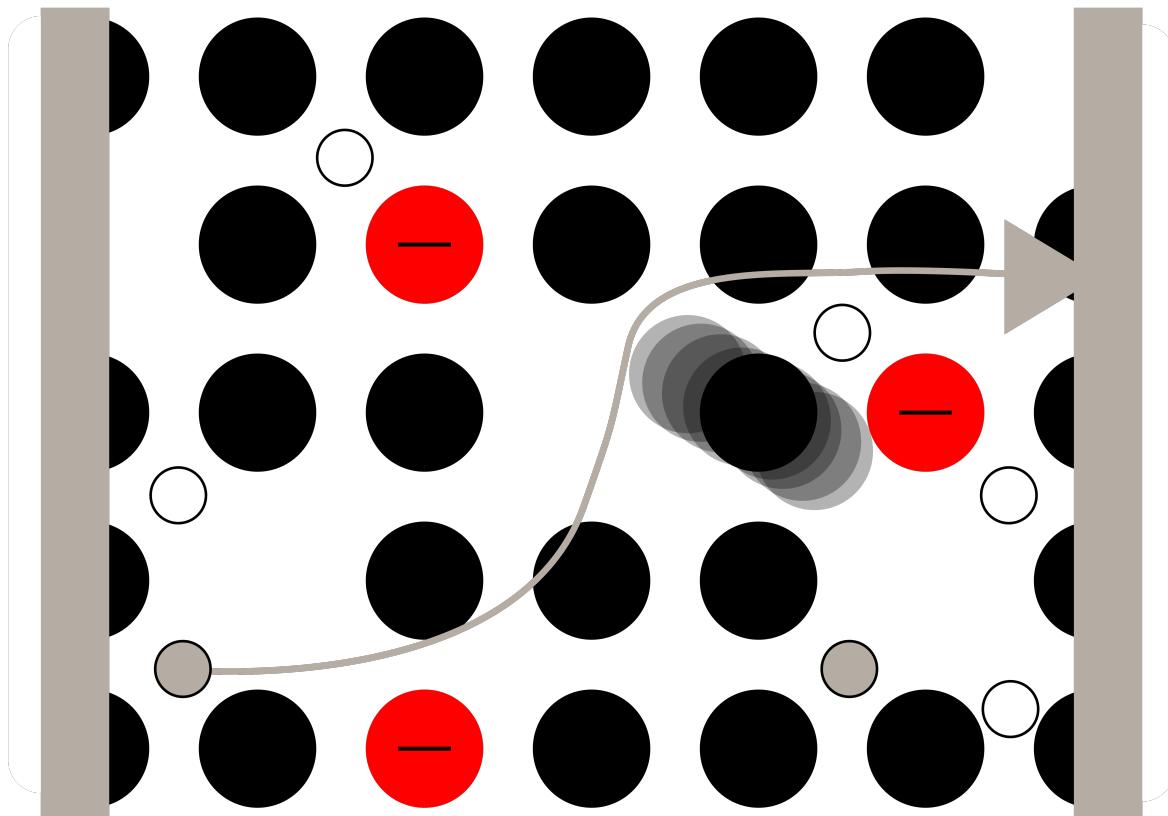
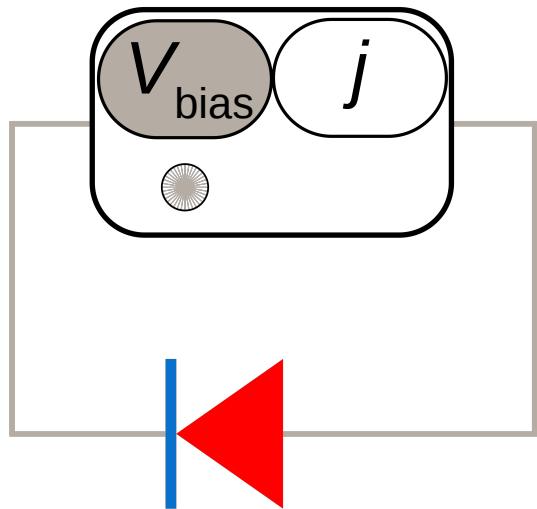
p-n junctions: Equivalent circuit

$$j = j_S(e^{\frac{eV_{bias}}{n_{ideal}kT}} - 1)$$



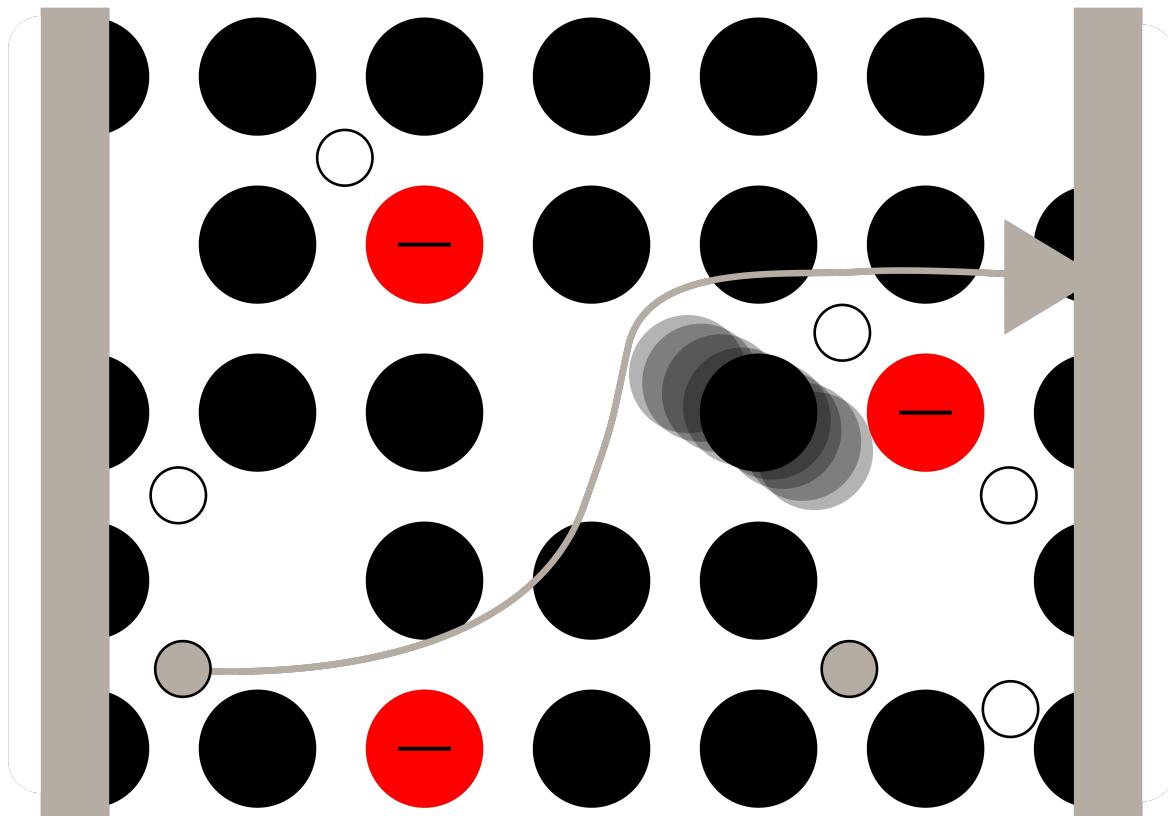
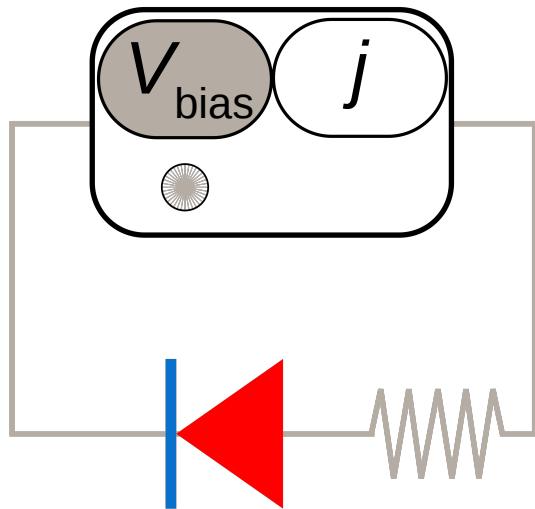
p-n junctions: Equivalent circuit

$$j = j_S \left(e^{\frac{eV_{\text{bias}}}{n_{\text{ideal}} kT}} - 1 \right)$$



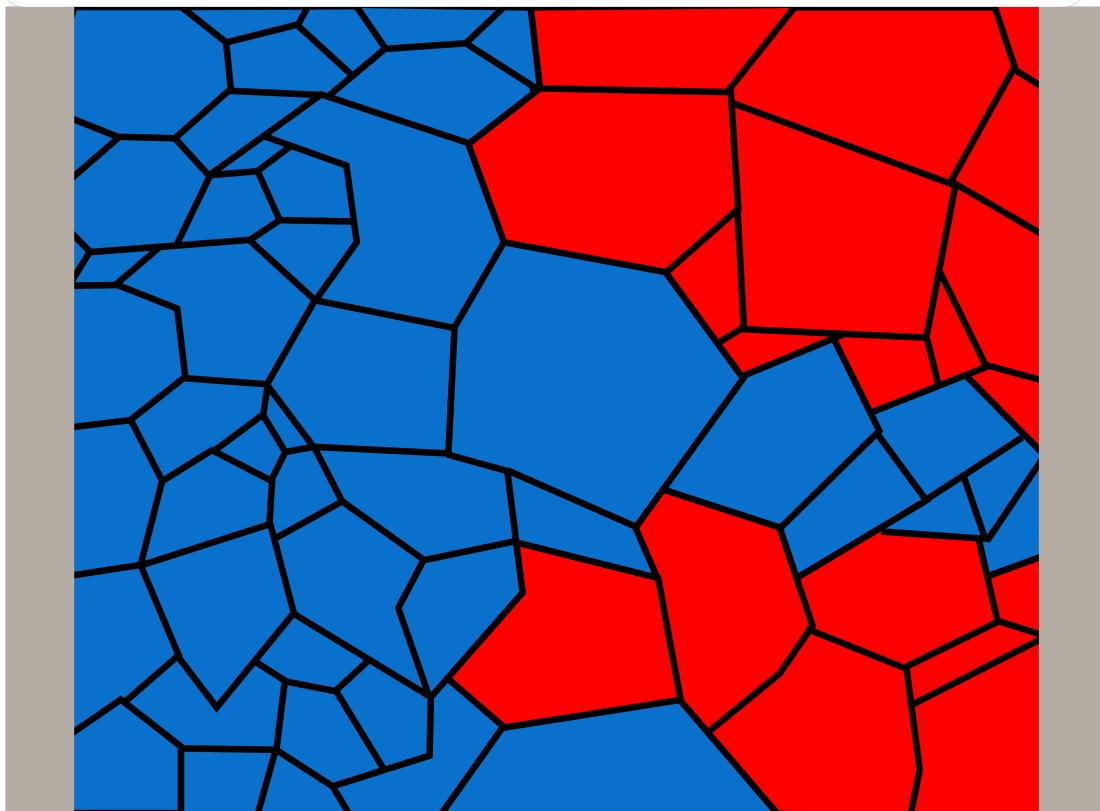
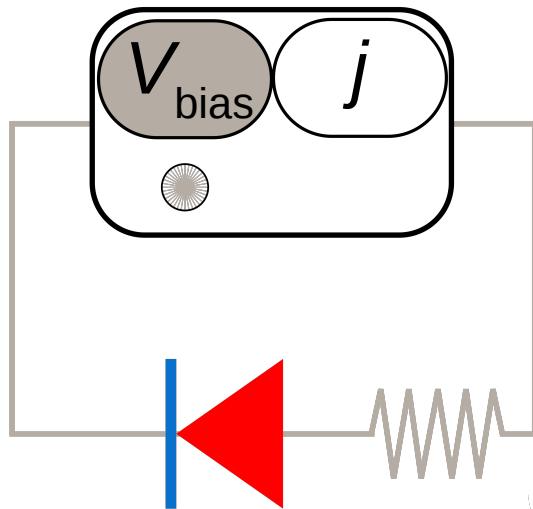
p-n junctions: Equivalent circuit

$$j = j_S \left(e^{\frac{eV_{bias} - jR_S}{n_{ideal}kT}} - 1 \right)$$



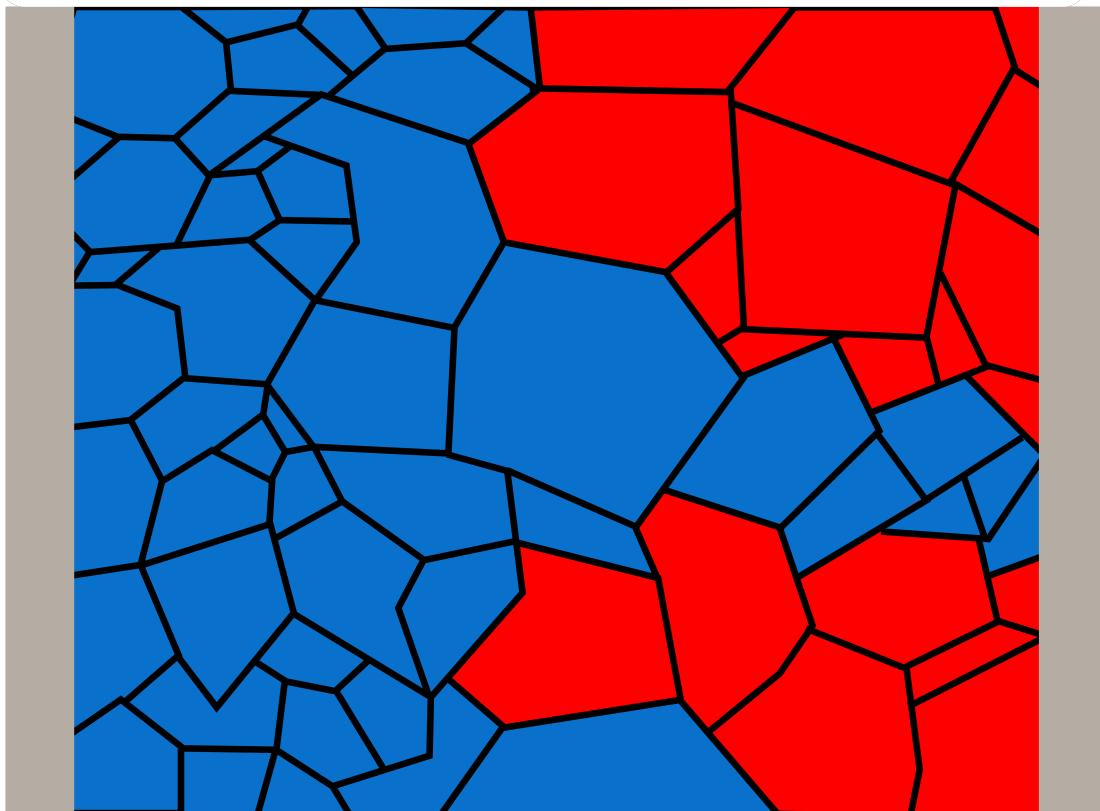
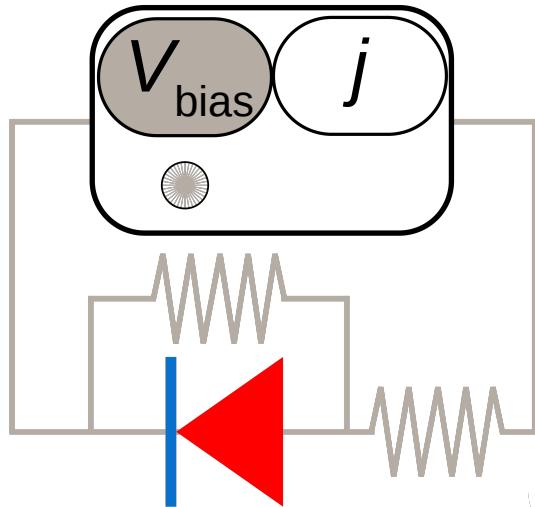
p-n junctions: Equivalent circuit

$$j = j_S \left(e^{\frac{eV_{bias} - jR_S}{n_{ideal}kT}} - 1 \right)$$



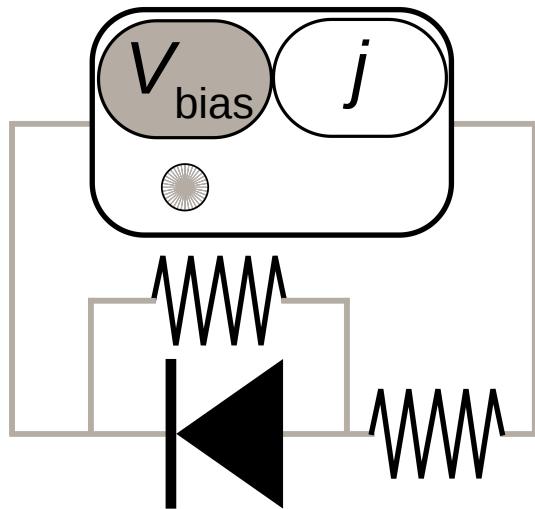
p-n junctions: Equivalent circuit

$$j = j_S \left(e^{\frac{eV_{bias} - jR_S}{n_{ideal}kT}} - 1 \right) + \frac{V_{bias} - jR_S}{R_{Sh}}$$



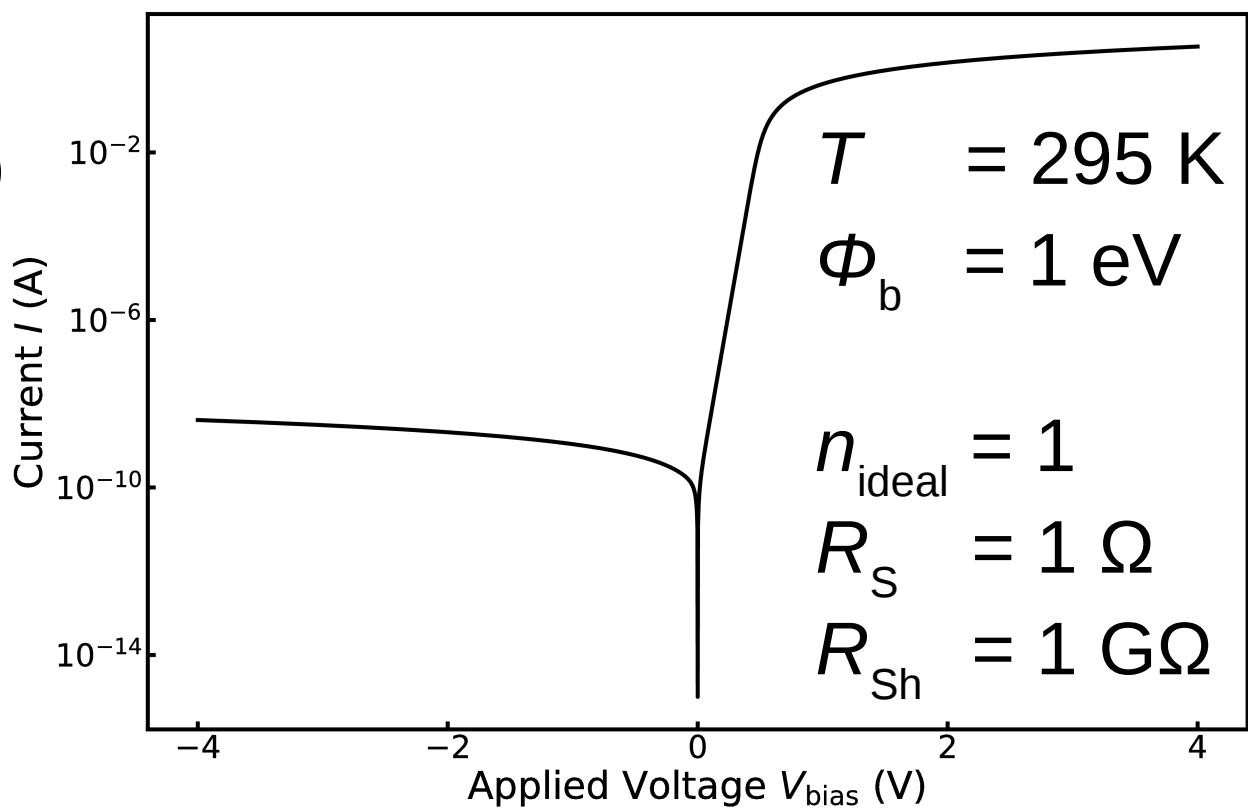
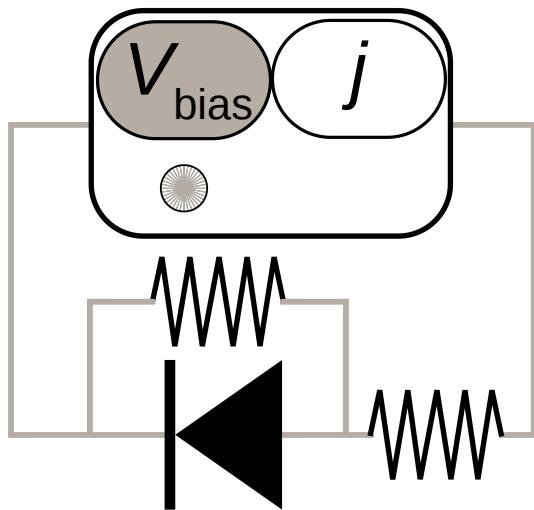
p-n junctions: Equivalent circuit

$$j = j_S \left(e^{\frac{eV_{\text{bias}} - jR_S}{n_{\text{ideal}}kT}} - 1 \right) + \frac{V_{\text{bias}} - jR_S}{R_{\text{Sh}}}$$



Current-Voltage Characteristics

$$j = j_S \left(e^{\frac{eV_{\text{bias}} - jR_S}{n_{\text{ideal}}kT}} - 1 \right) + \frac{V_{\text{bias}} - jR_S}{R_{\text{Sh}}}$$



Current-Voltage Characteristics

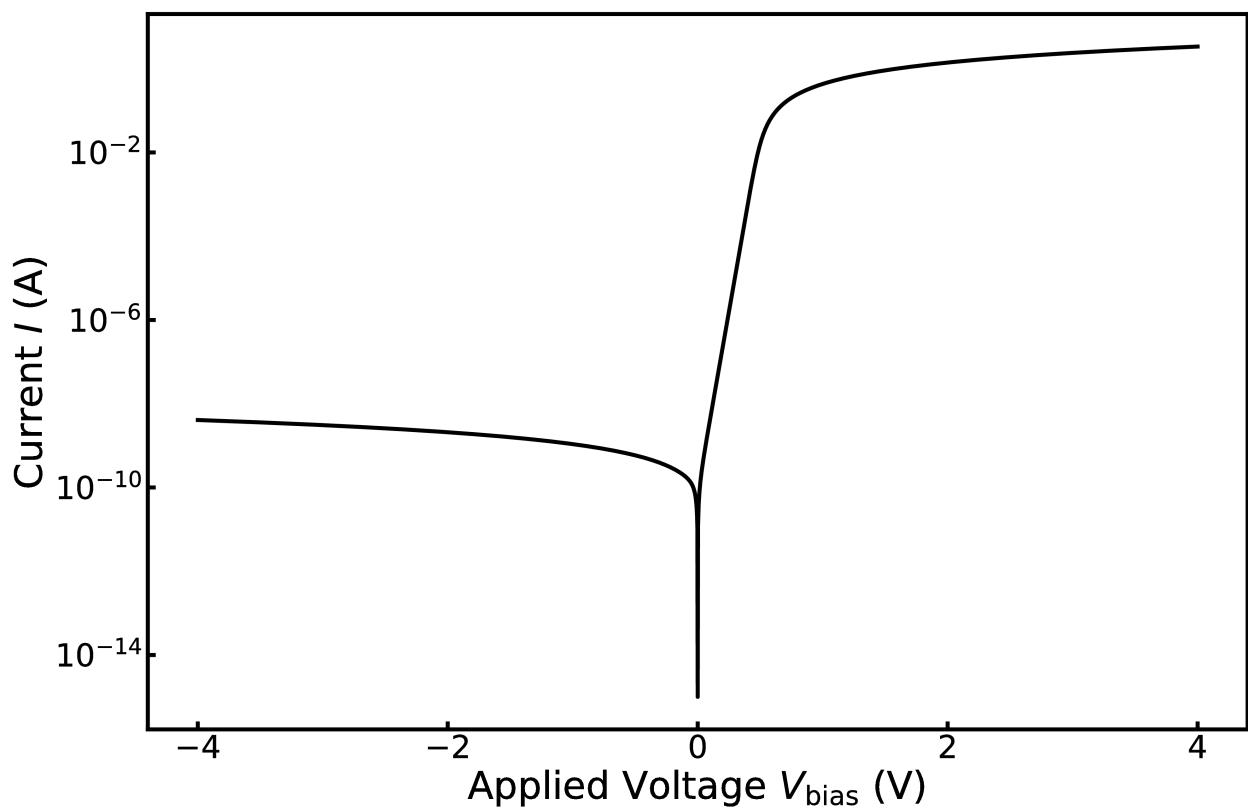
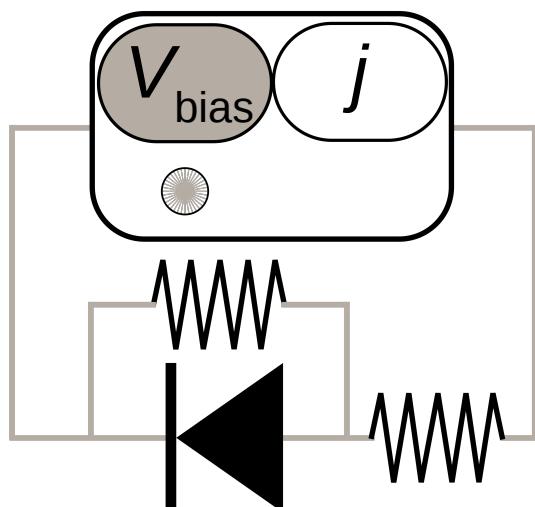
$$T = 295 \text{ K}$$

$$\Phi_b = 1 \text{ eV}$$

$$n_{\text{ideal}} = 1$$

$$R_s = 1 \Omega$$

$$R_{\text{Sh}} = 1 \text{ G}\Omega$$



$$j = j_s(e^{\frac{eV_{\text{bias}} - jR_s}{n_{\text{ideal}}kT}} - 1) + \frac{V_{\text{bias}} - jR_s}{R_{\text{Sh}}}$$

Current-Voltage Characteristics

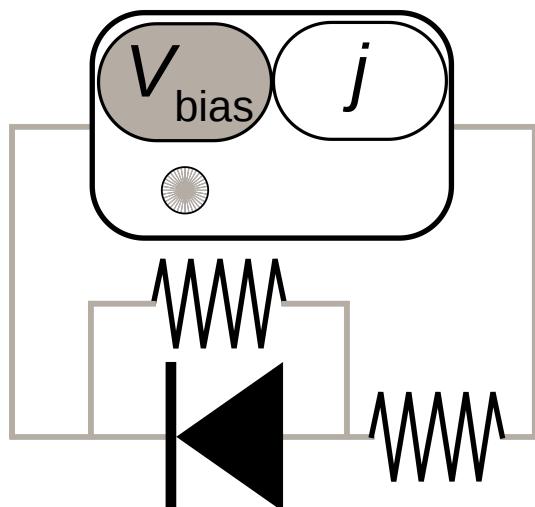
$$T = 295 \text{ K}$$

$$\Phi_b = 1 \text{ eV}$$

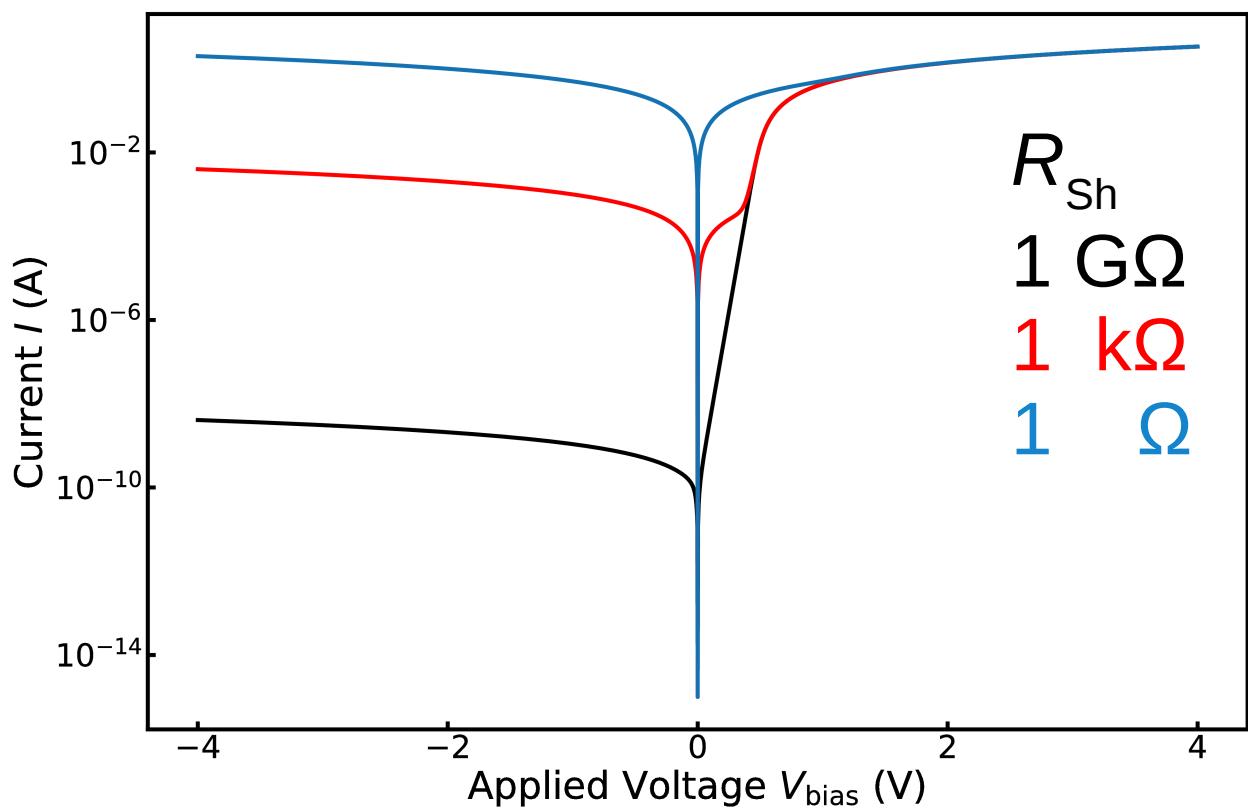
$$n_{\text{ideal}} = 1$$

$$R_s = 1 \Omega$$

$$R_{\text{Sh}} = [1 \text{ G}\Omega, 1 \text{ k}\Omega, 1\Omega]$$



$$j = j_s(e^{\frac{eV_{\text{bias}} - jR_s}{n_{\text{ideal}}kT}} - 1) + \frac{V_{\text{bias}} - jR_s}{R_{\text{Sh}}}$$



Current-Voltage Characteristics

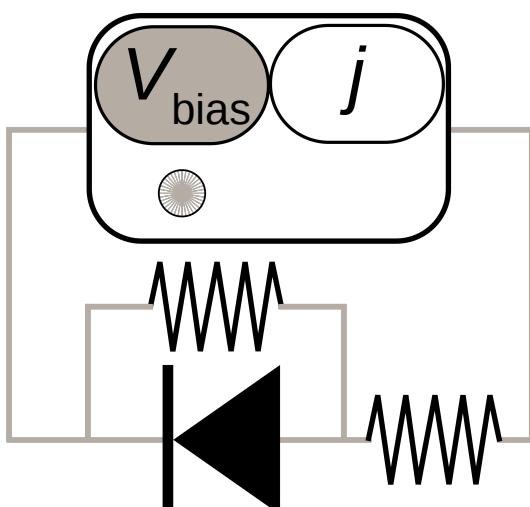
$$T = 295 \text{ K}$$

$$\Phi_b = 1 \text{ eV}$$

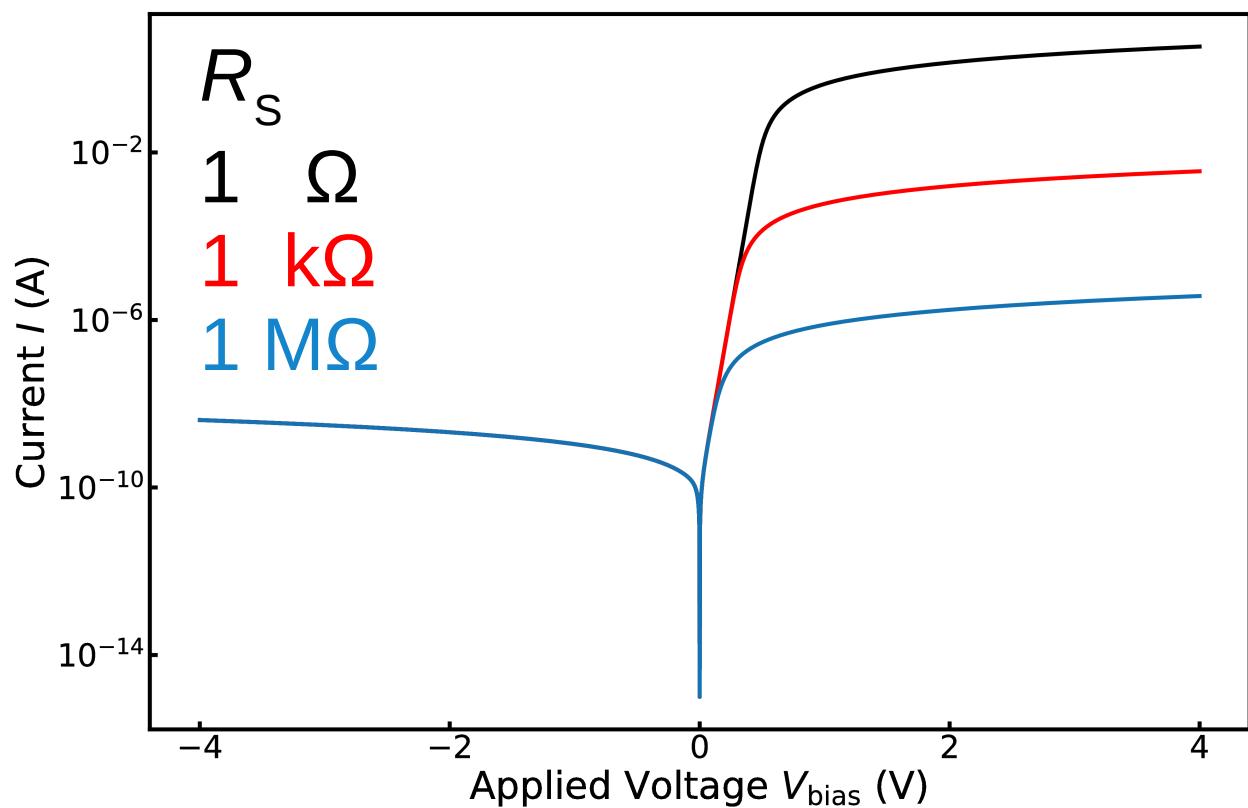
$$n_{\text{ideal}} = 1$$

$$R_s = [1 \Omega, 1 \text{ k}\Omega, 1 \text{ M}\Omega]$$

$$R_{\text{Sh}} = 1 \text{ G}\Omega$$



$$j = j_s(e^{\frac{eV_{\text{bias}} - jR_s}{n_{\text{ideal}}kT}} - 1) + \frac{V_{\text{bias}} - jR_s}{R_{\text{Sh}}}$$



Current-Voltage Characteristics

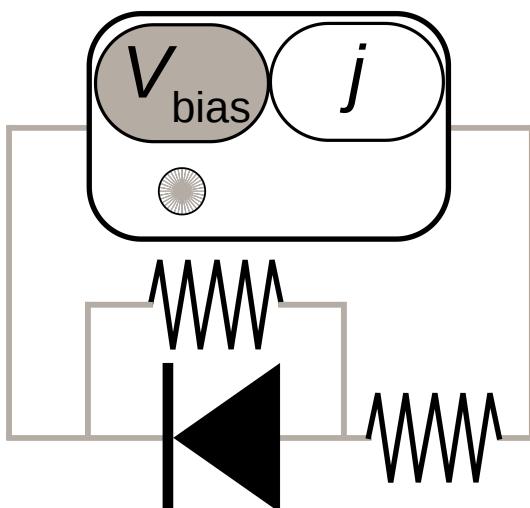
$$T = 295 \text{ K}$$

$$\Phi_b = 1 \text{ eV}$$

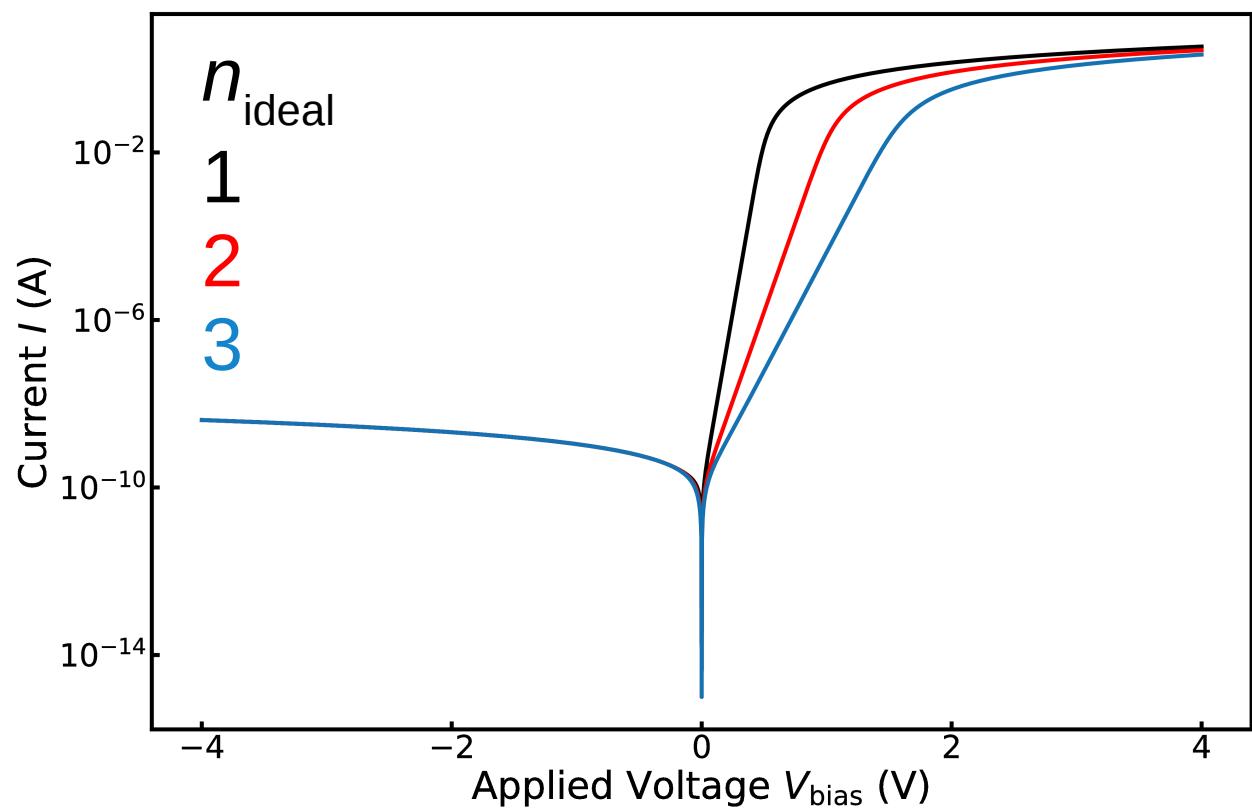
$$n_{\text{ideal}} = [1, 2, 3]$$

$$R_s = 1 \Omega$$

$$R_{\text{Sh}} = 1 \text{ G}\Omega$$



$$j = j_s(e^{\frac{eV_{\text{bias}} - jR_s}{n_{\text{ideal}}kT}} - 1) + \frac{V_{\text{bias}} - jR_s}{R_{\text{Sh}}}$$



Current-Voltage Characteristics

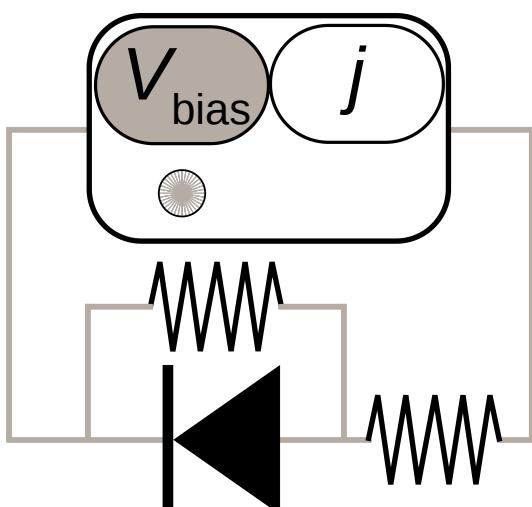
$$T = [295 \text{ K}, 450 \text{ K}, 600 \text{ K}]$$

$$\Phi_b = 1 \text{ eV}$$

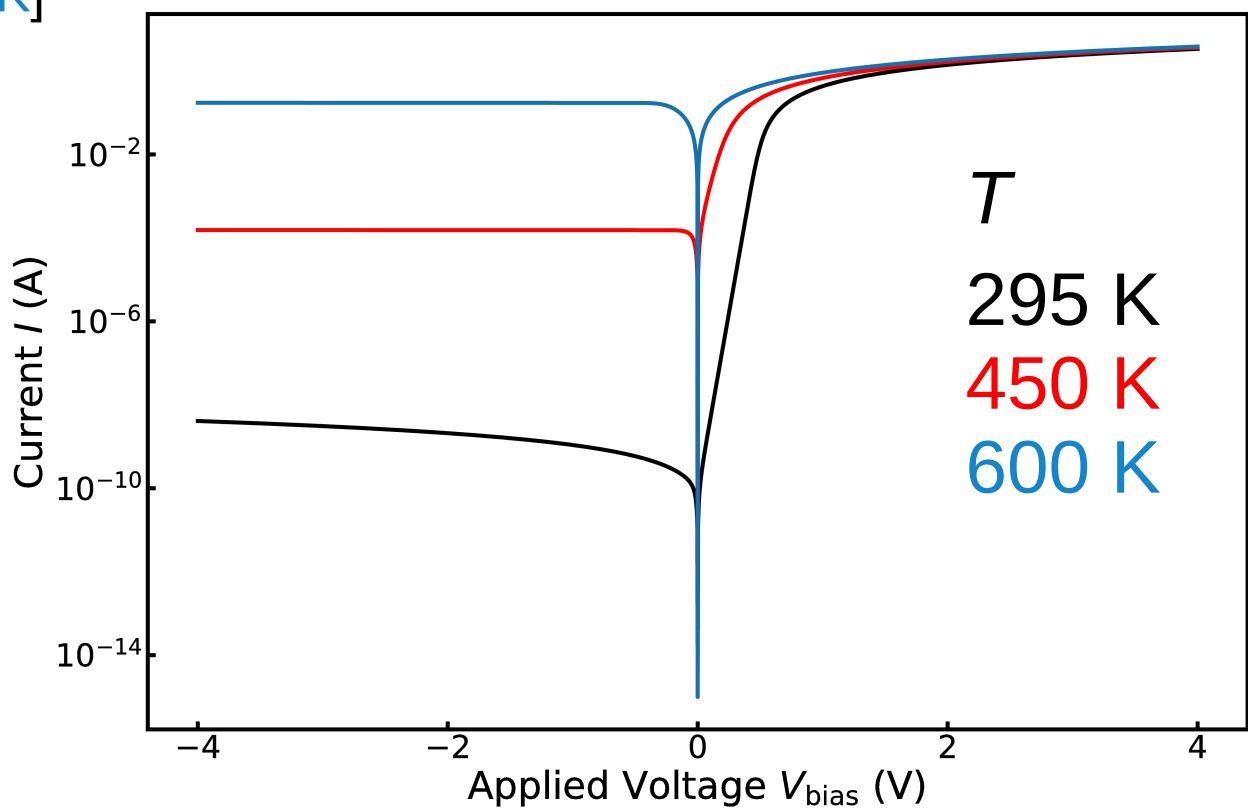
$$n_{\text{ideal}} = 1$$

$$R_s = 1 \Omega$$

$$R_{\text{Sh}} = 1 \text{ G}\Omega$$



$$j = j_s(e^{\frac{eV_{\text{bias}} - jR_s}{n_{\text{ideal}}kT}} - 1) + \frac{V_{\text{bias}} - jR_s}{R_{\text{Sh}}}$$



Current-Voltage Characteristics

$T = 295 \text{ K}$

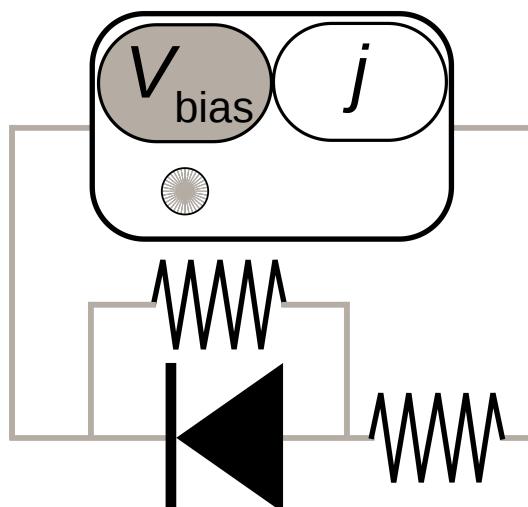
Si $p-n$ junction with:

$n_{\text{ideal}} = 1.72$

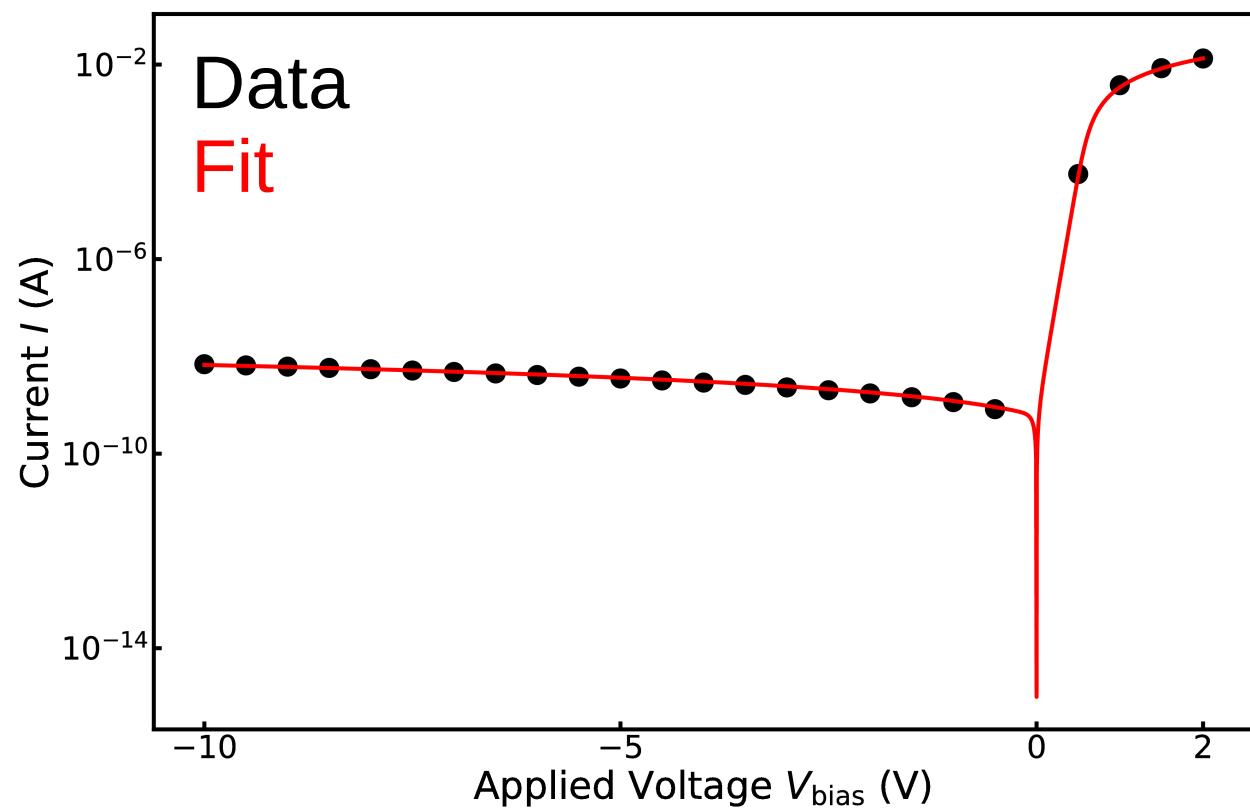
$R_s = 94 \Omega$

$R_{\text{Sh}} = 1.64 \text{ G}\Omega$

$j_s = 0.61 \text{ nA}$

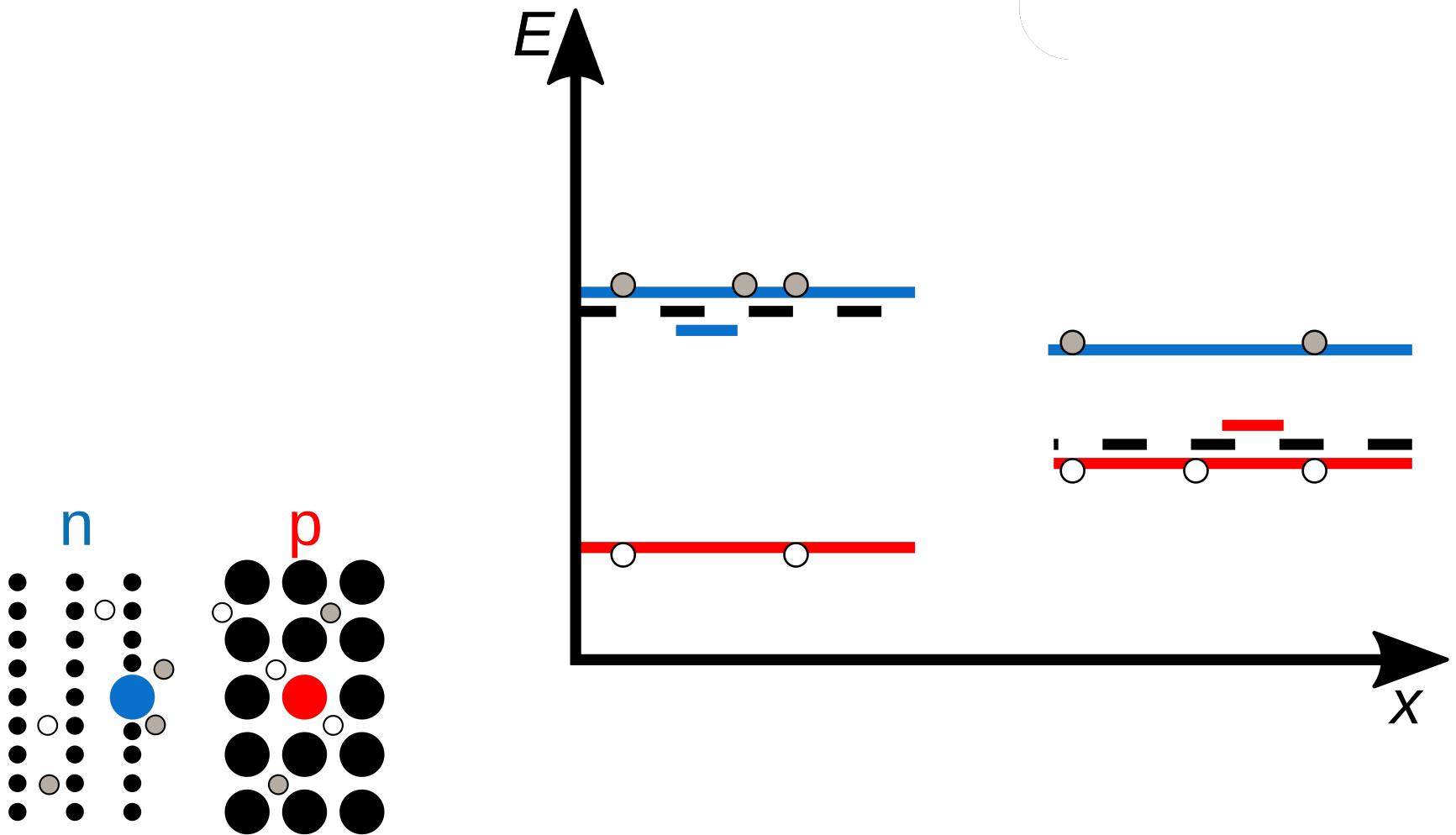


$$j = j_s(e^{\frac{eV_{\text{bias}} - jR_s}{n_{\text{ideal}}kT}} - 1) + \frac{V_{\text{bias}} - jR_s}{R_{\text{Sh}}}$$

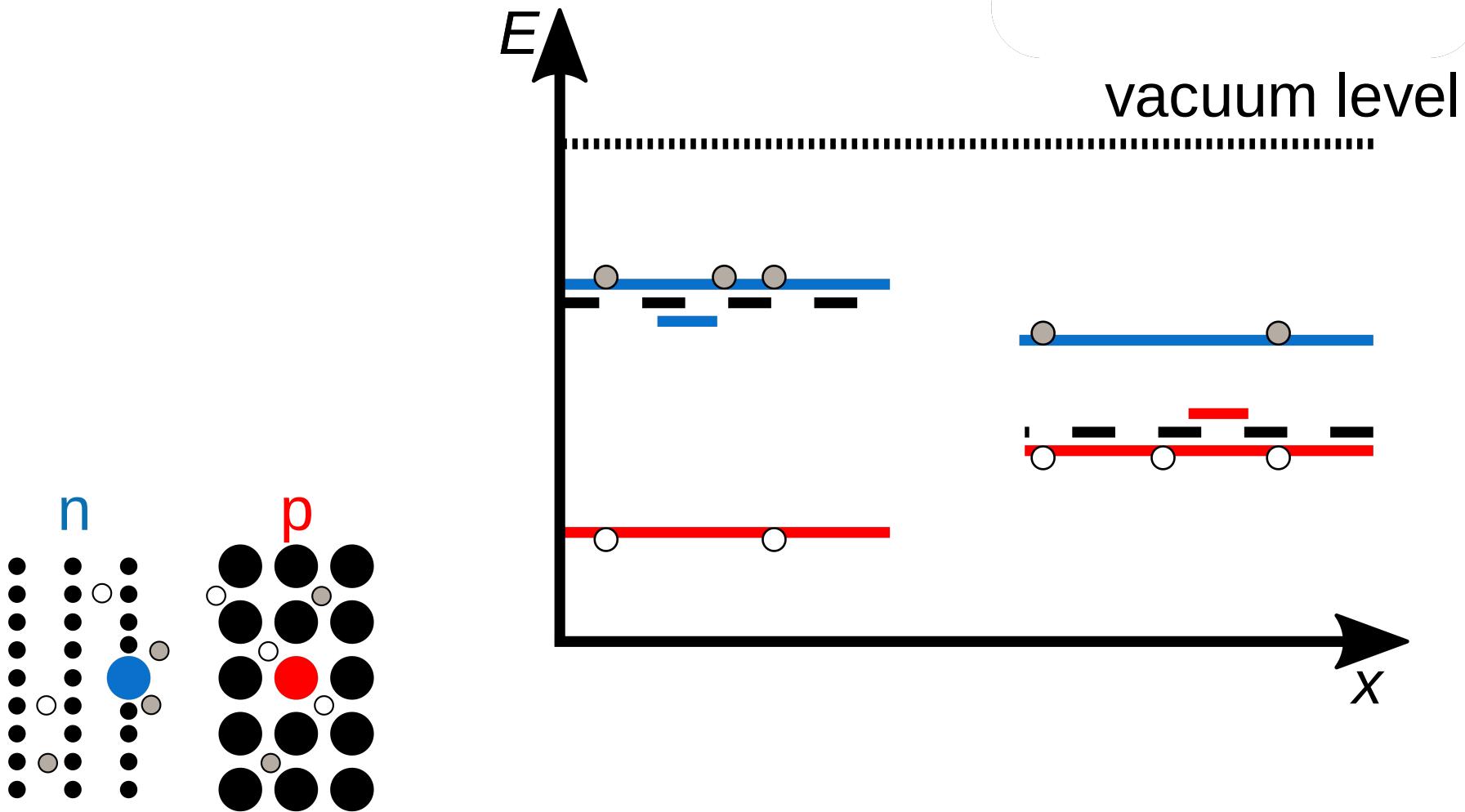


Data: Courtesy of Aleksei Andreevich Grigorev

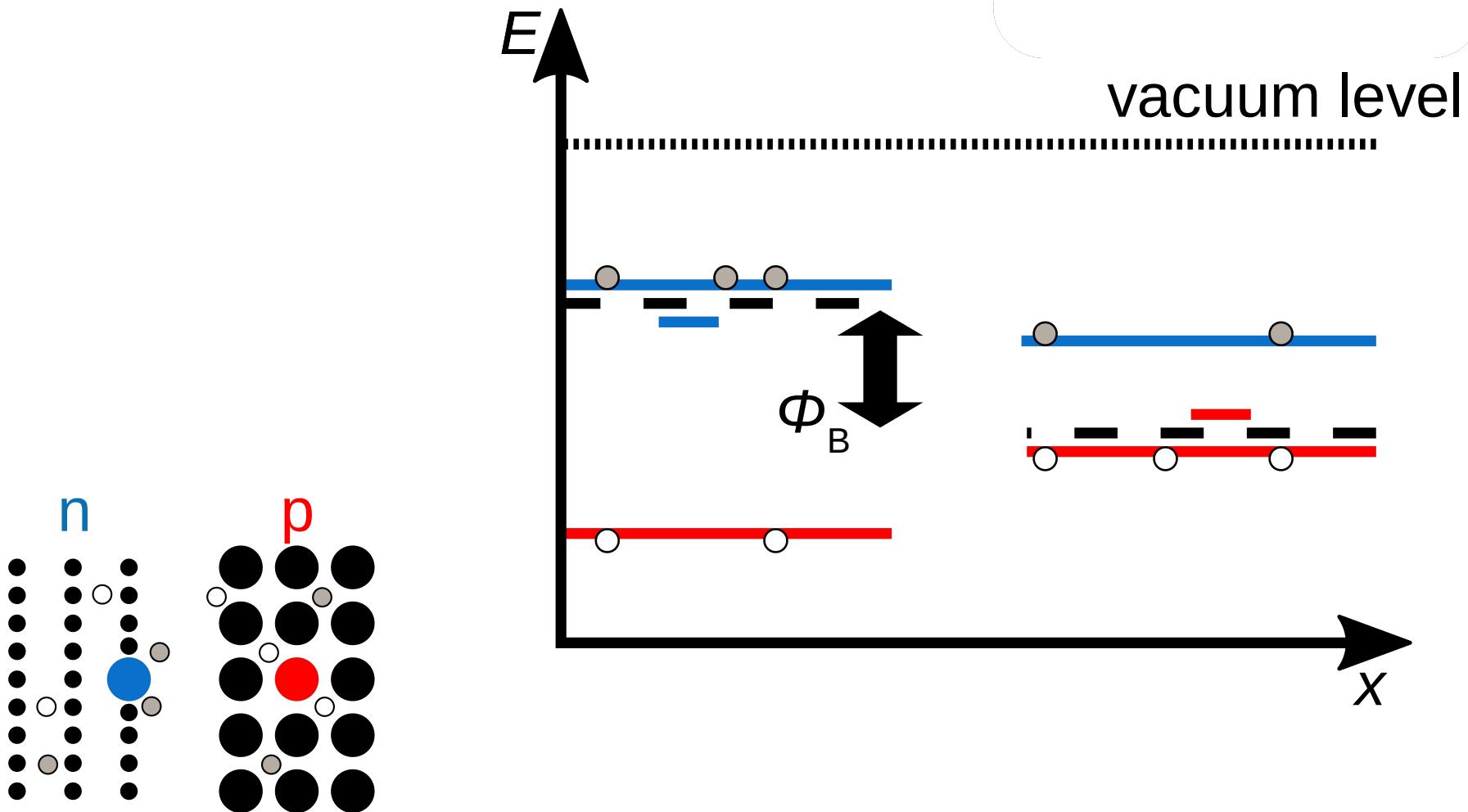
The band diagram of $p-n$ heterojunctions



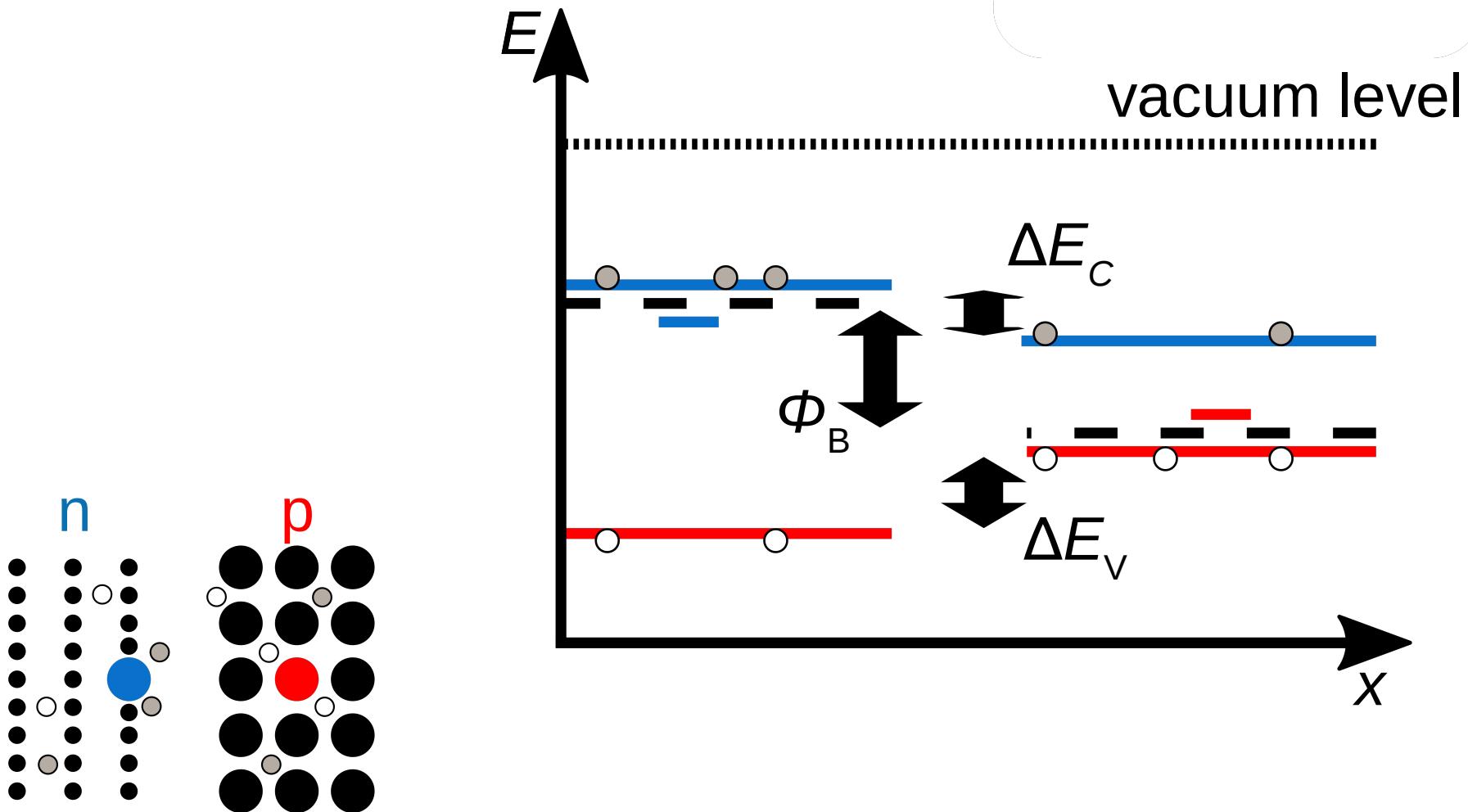
The band diagram of $p-n$ heterojunctions



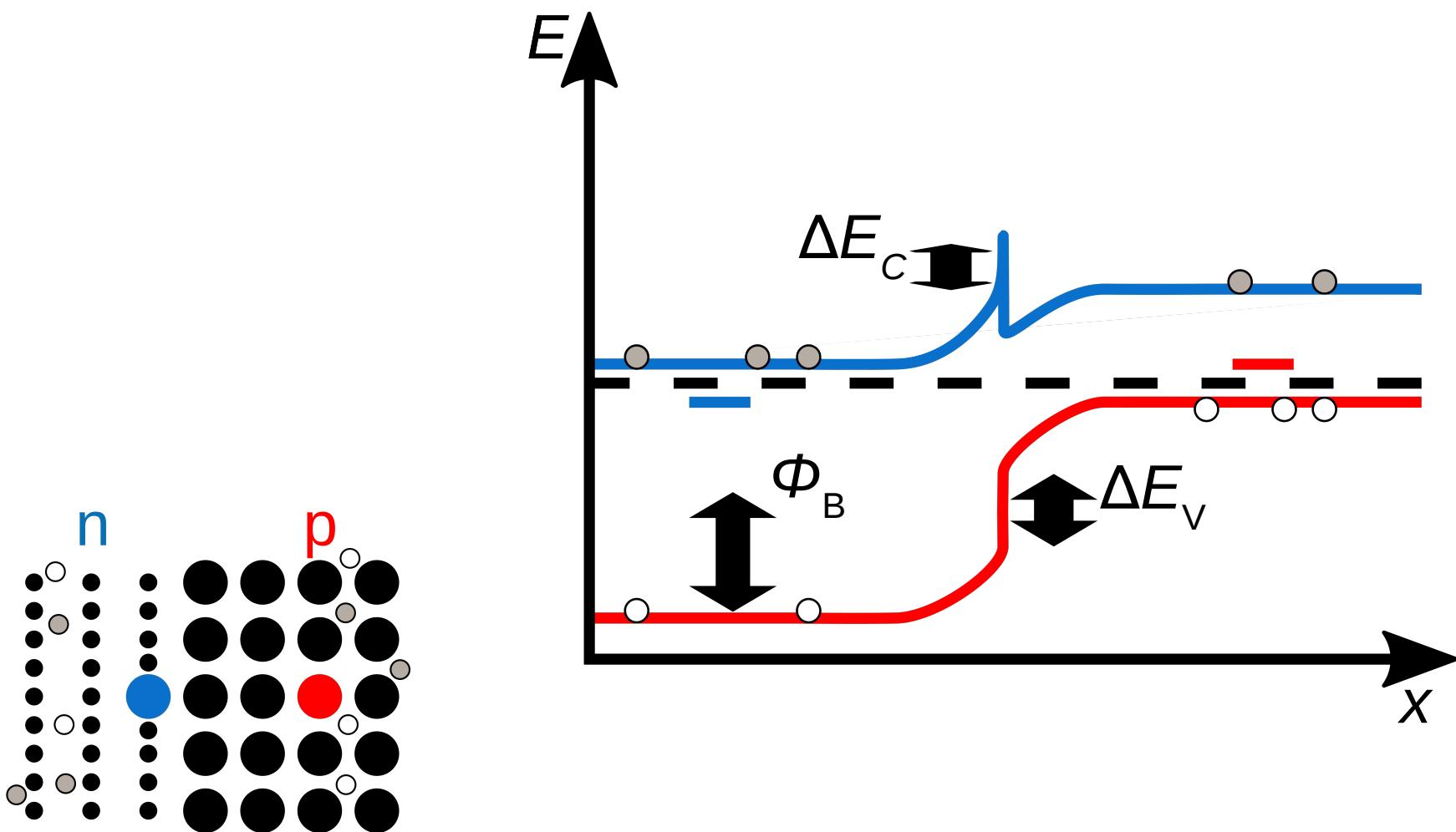
The band diagram of *p-n* heterojunctions



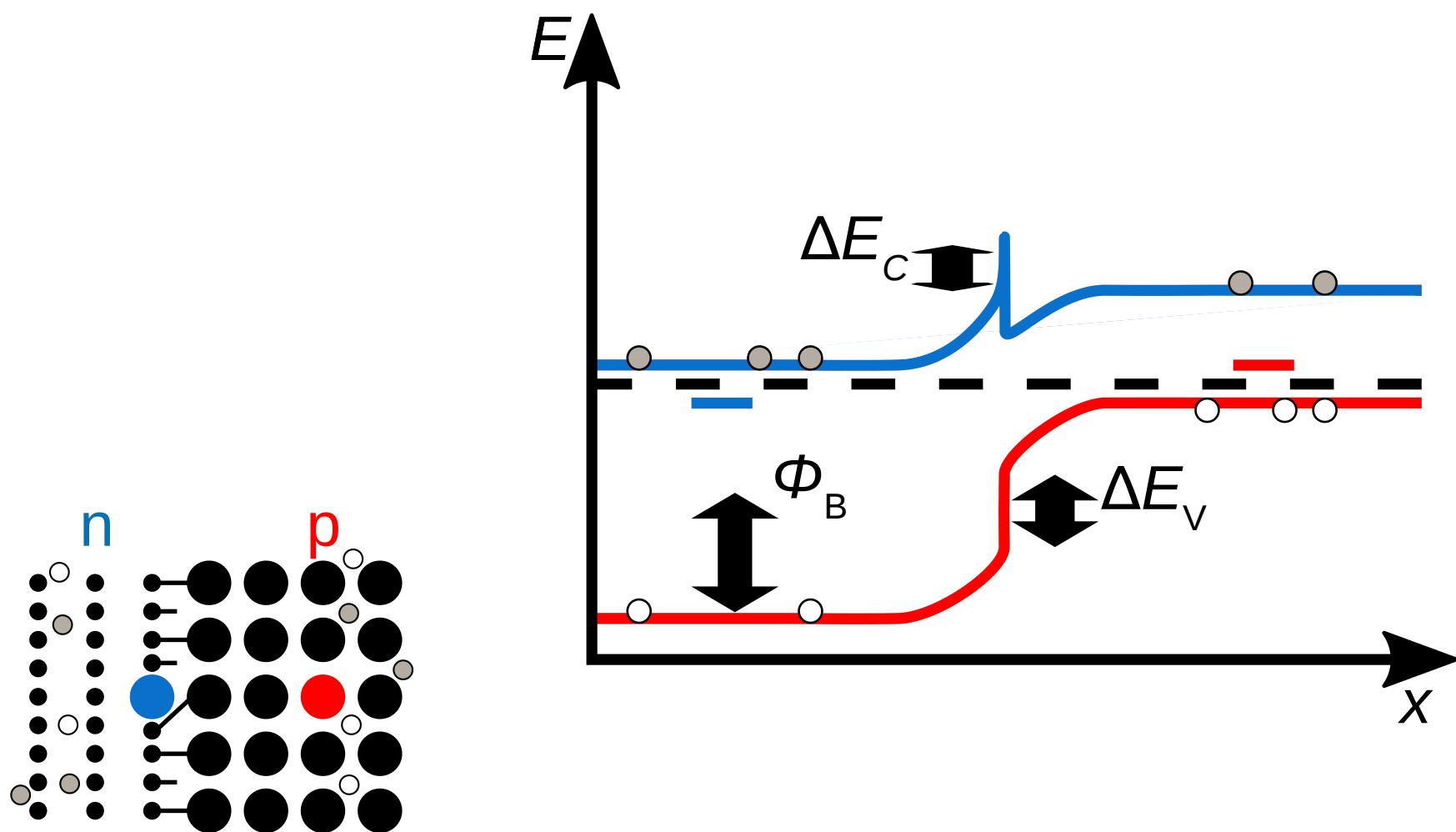
The band diagram of *p-n* heterojunctions



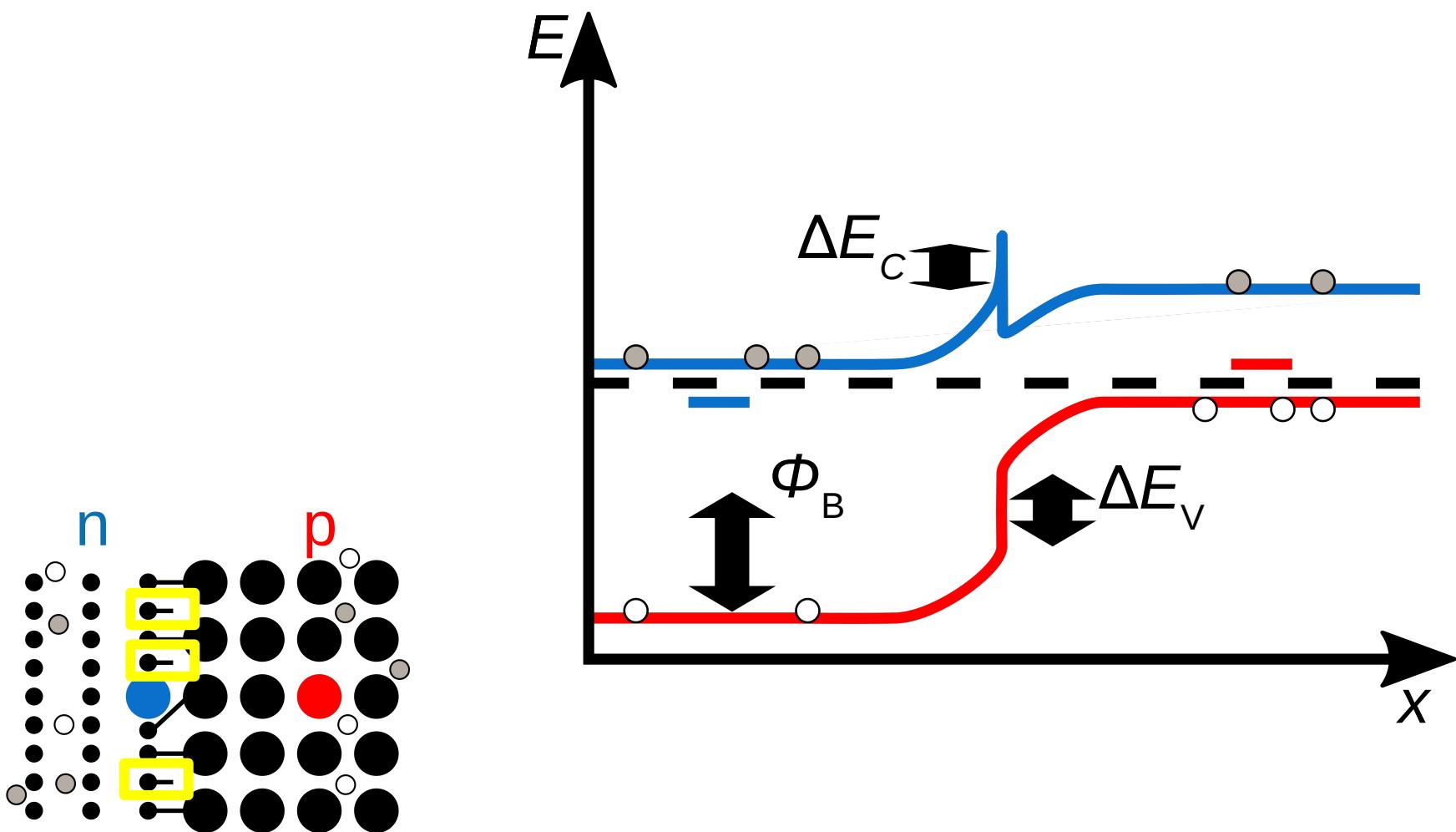
The band diagram of $p-n$ heterojunctions



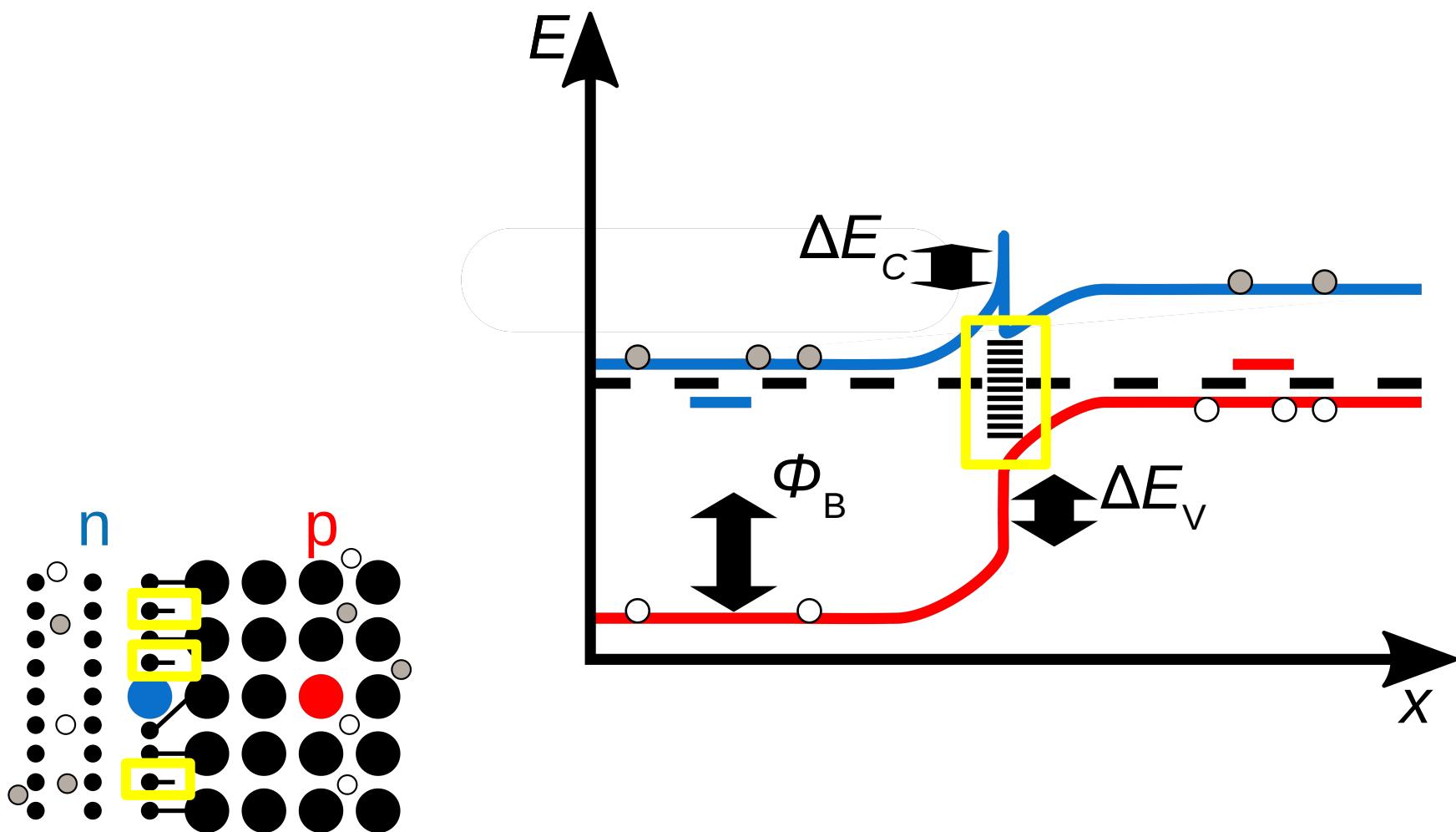
The band diagram of *p-n* heterojunctions



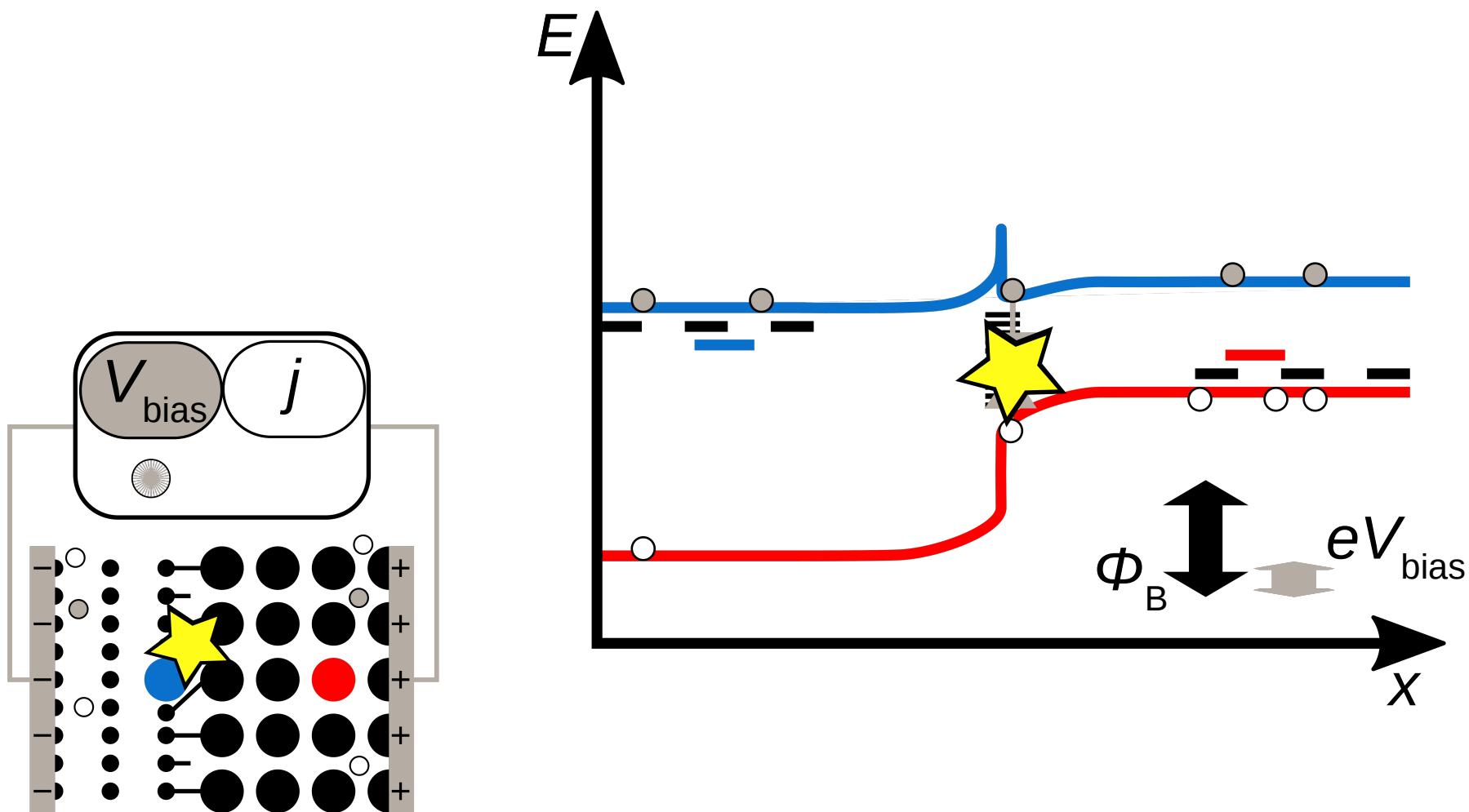
The band diagram of $p-n$ heterojunctions



The band diagram of *p-n* heterojunctions

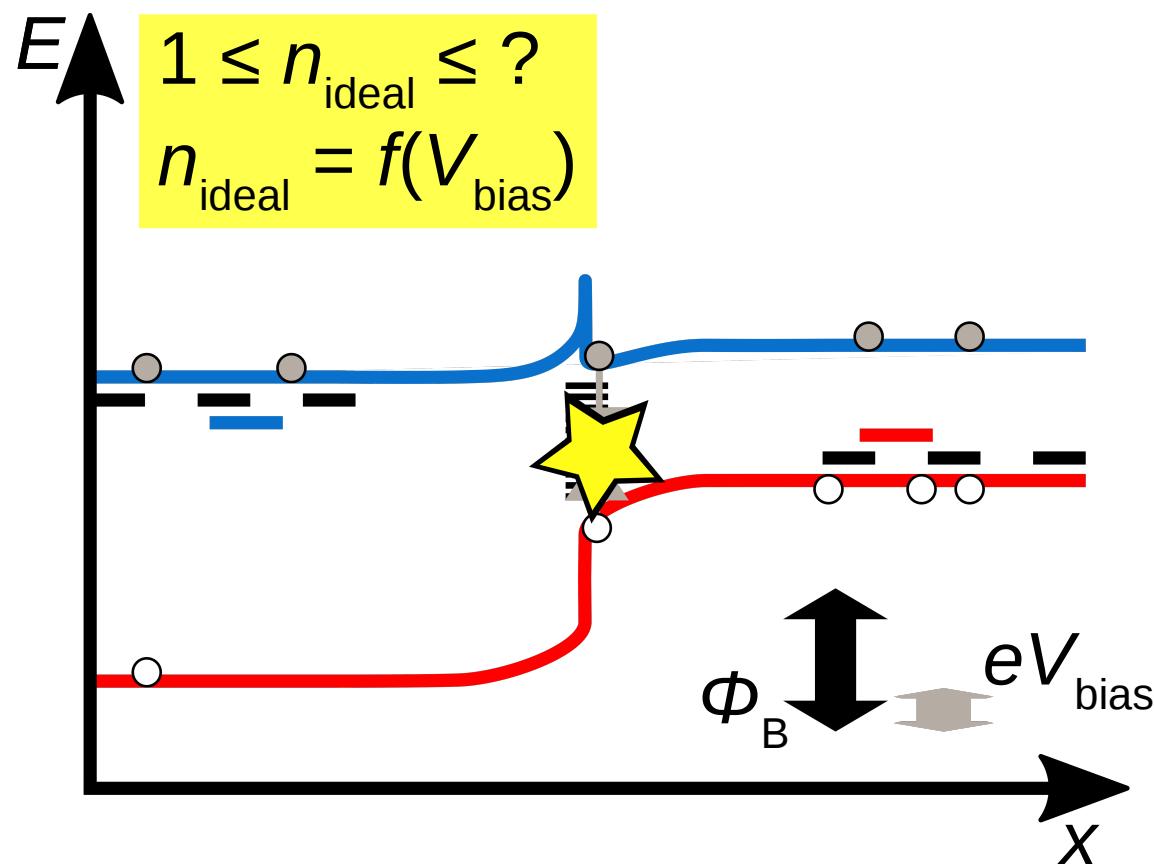
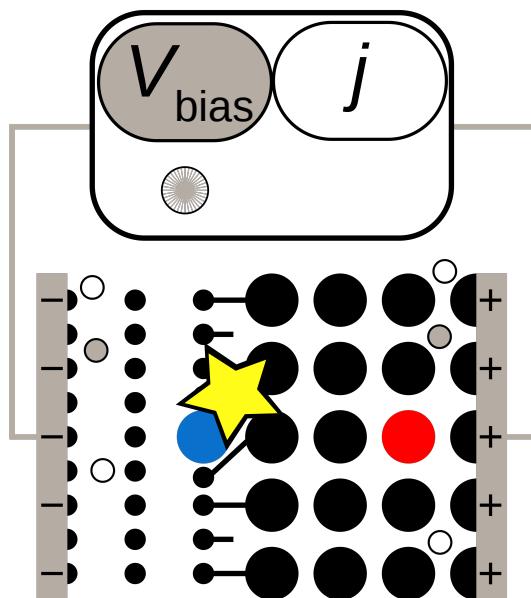


The band diagram of $p-n$ heterojunctions

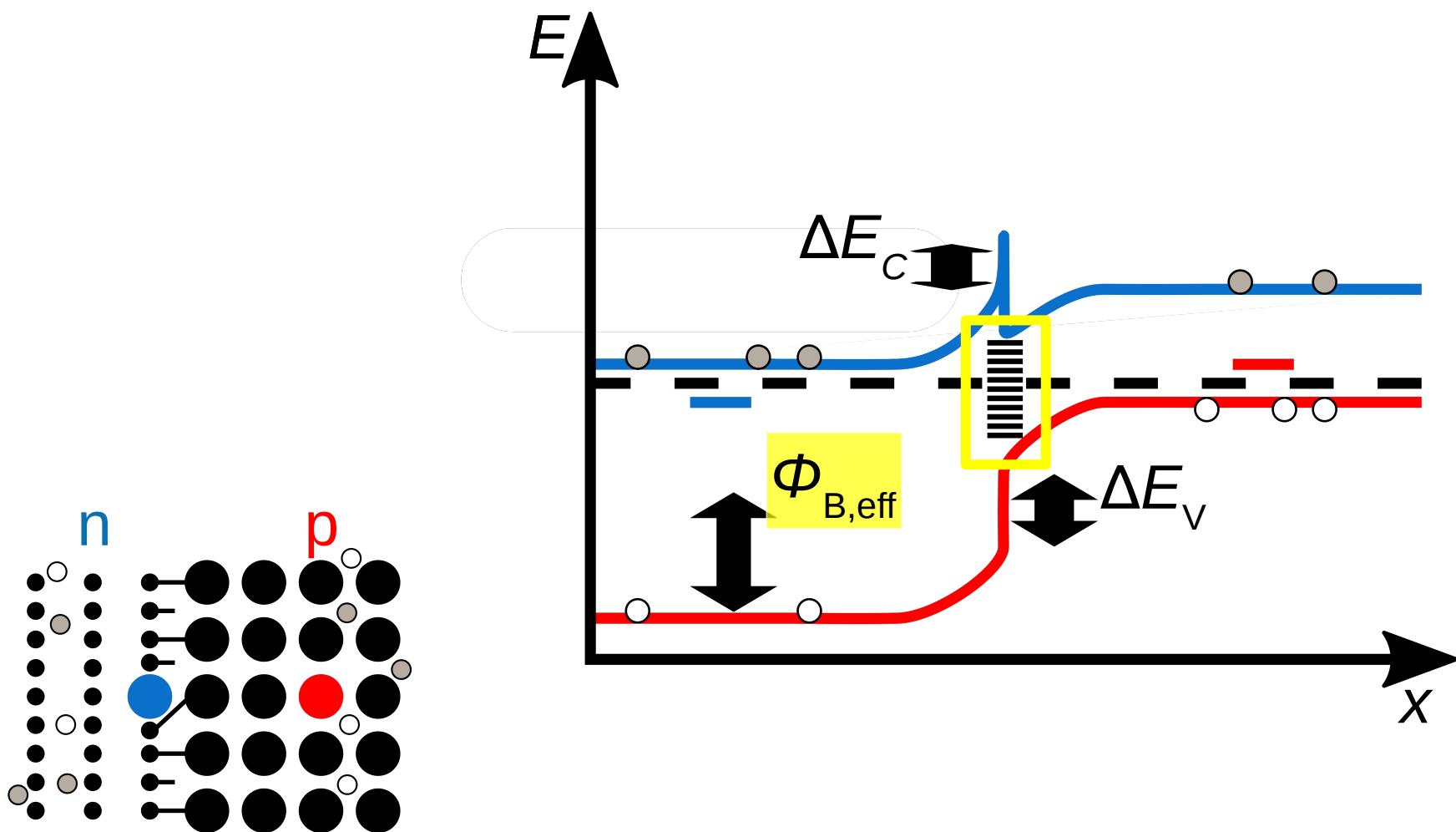


The band diagram of *p-n* heterojunctions

$$j = j_S \left(e^{\frac{eV_{\text{bias}} - jR_S}{n_{\text{ideal}} kT}} - 1 \right) + \frac{V_{\text{bias}} - jR_S}{R_{\text{Sh}}}$$



The band diagram of *p-n* heterojunctions



Current-Voltage Characteristics

$T = 295 \text{ K}$

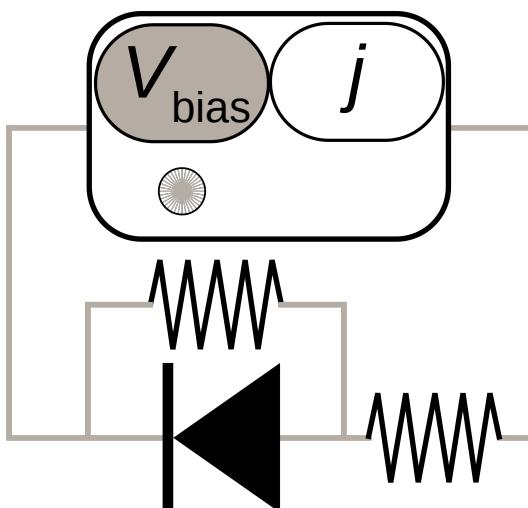
ZnO/CdS/CZTS junction:

$$n_{\text{ideal}} = 1.86$$

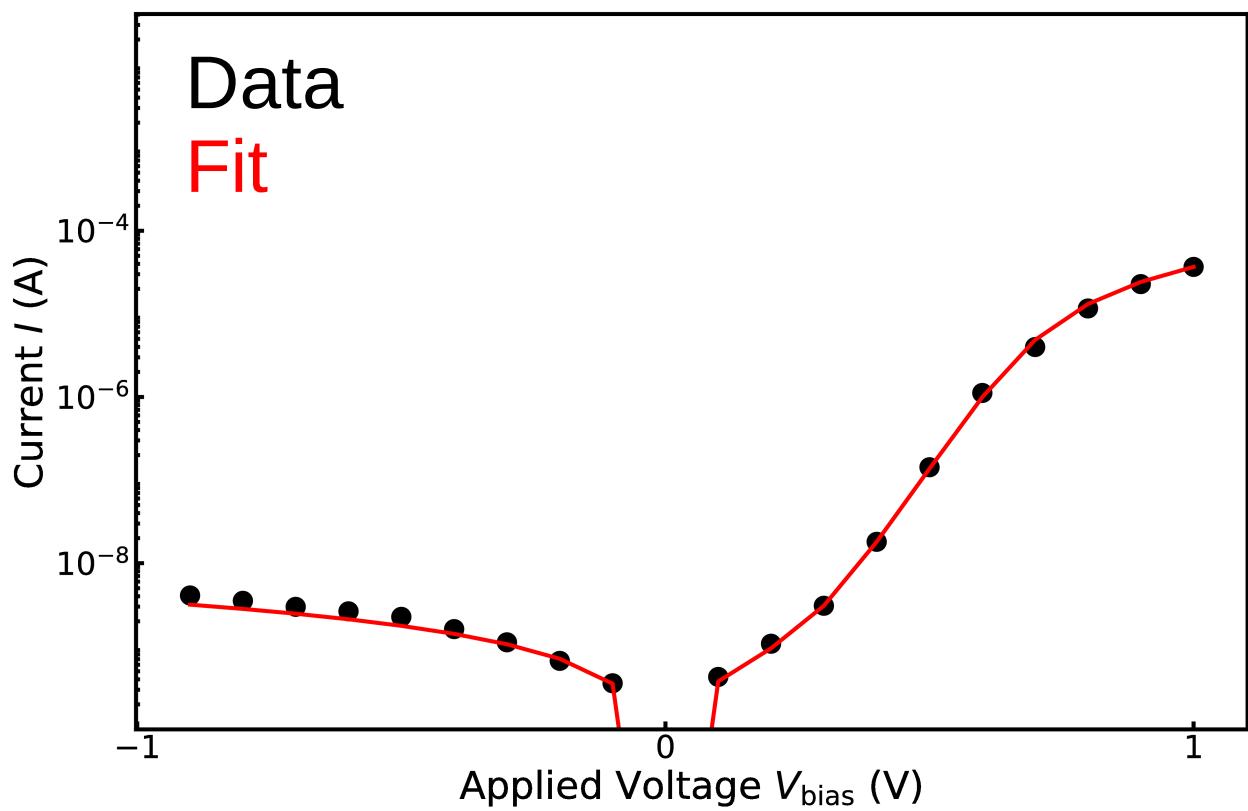
$$R_s = 6.4 \text{ k}\Omega$$

$$R_{\text{Sh}} = 284 \text{ M}\Omega$$

$$j_s = 3.6 \text{ pA}$$



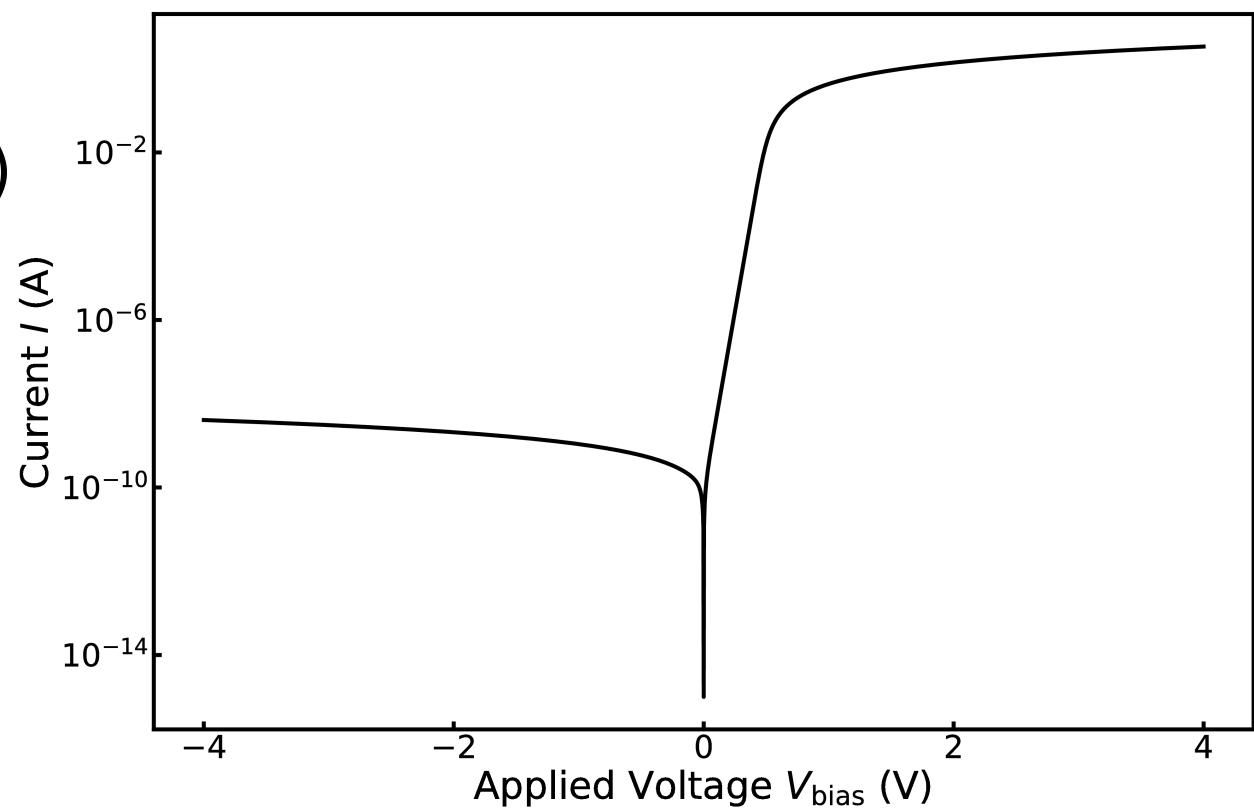
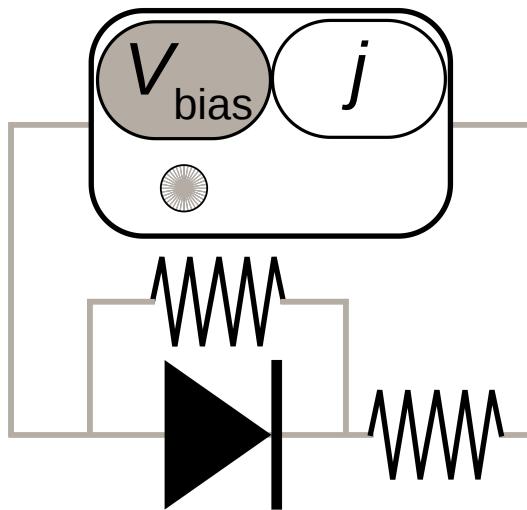
$$j = j_s(e^{\frac{eV_{\text{bias}} - jR_s}{n_{\text{ideal}}kT}} - 1) + \frac{V_{\text{bias}} - jR_s}{R_{\text{Sh}}}$$



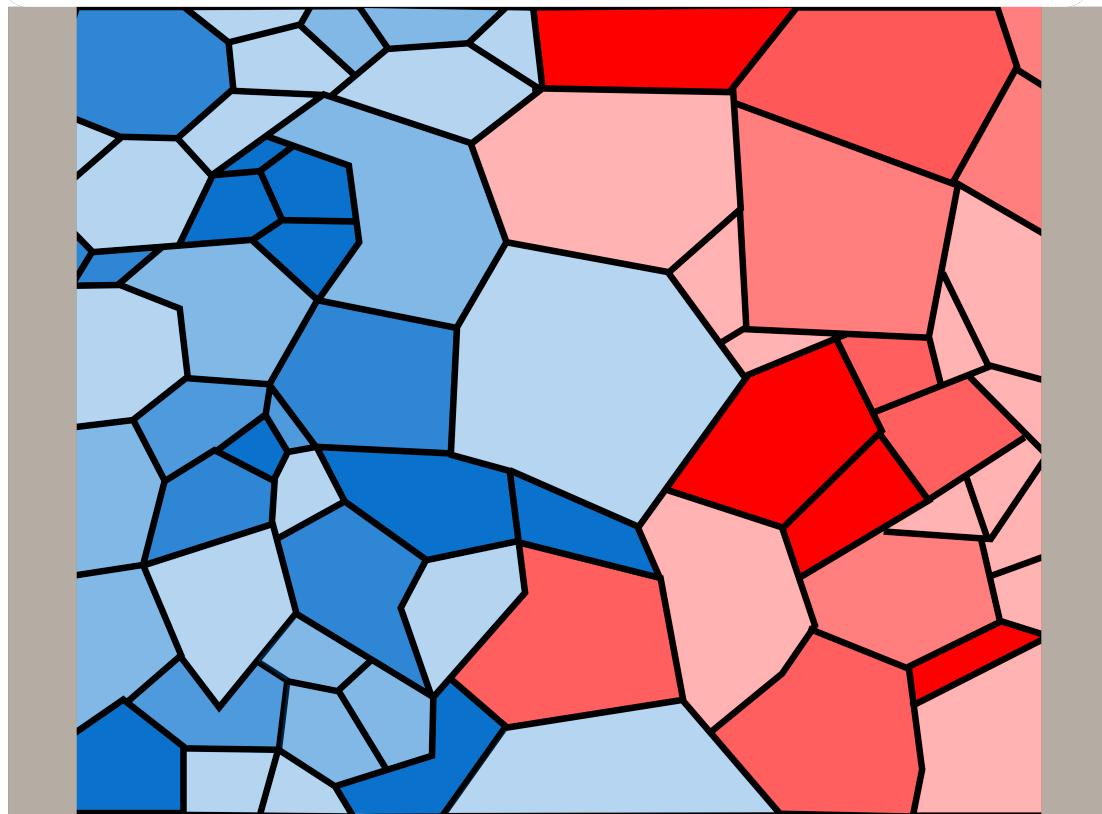
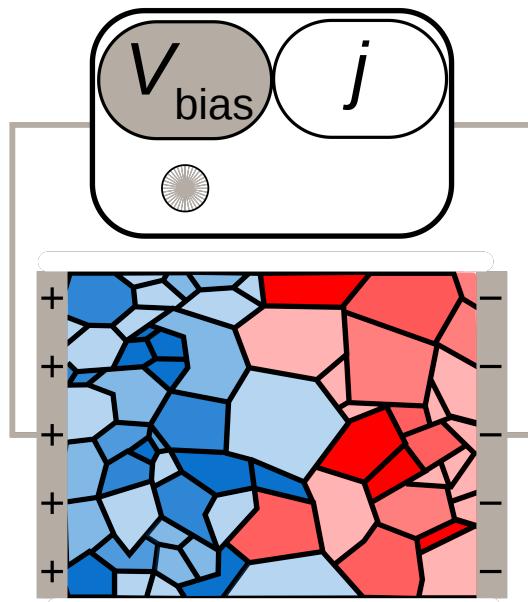
Data: Courtesy of Sigbjørn Grini

Fundamentals pf *p-n* junctions

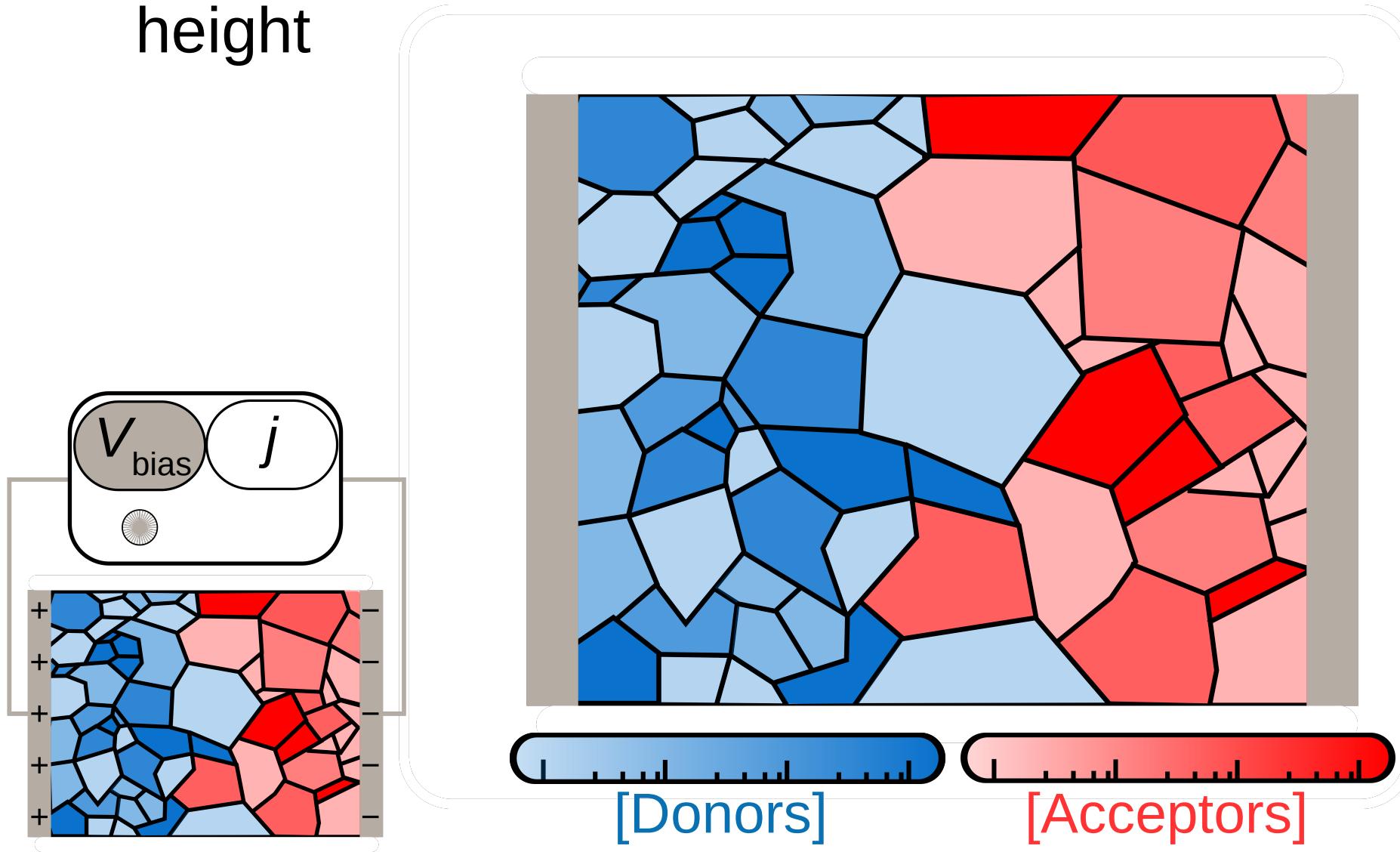
$$j = j_S \left(e^{\frac{eV_{\text{bias}} - jR_S}{n_{\text{ideal}} kT}} - 1 \right) + \frac{V_{\text{bias}} - jR_S}{R_{\text{Sh}}}$$



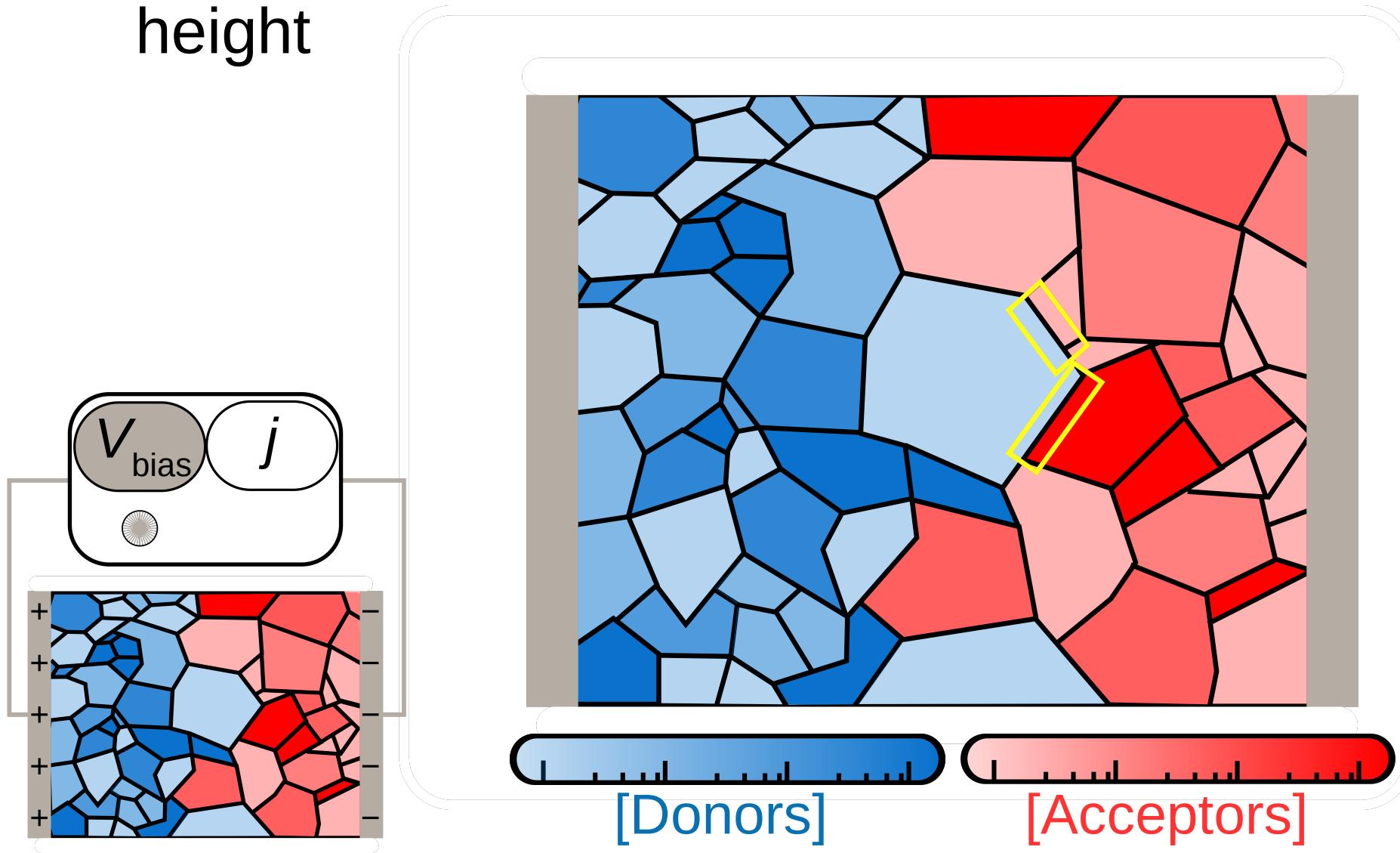
p-n junctions: Inhomogeneous barrier height



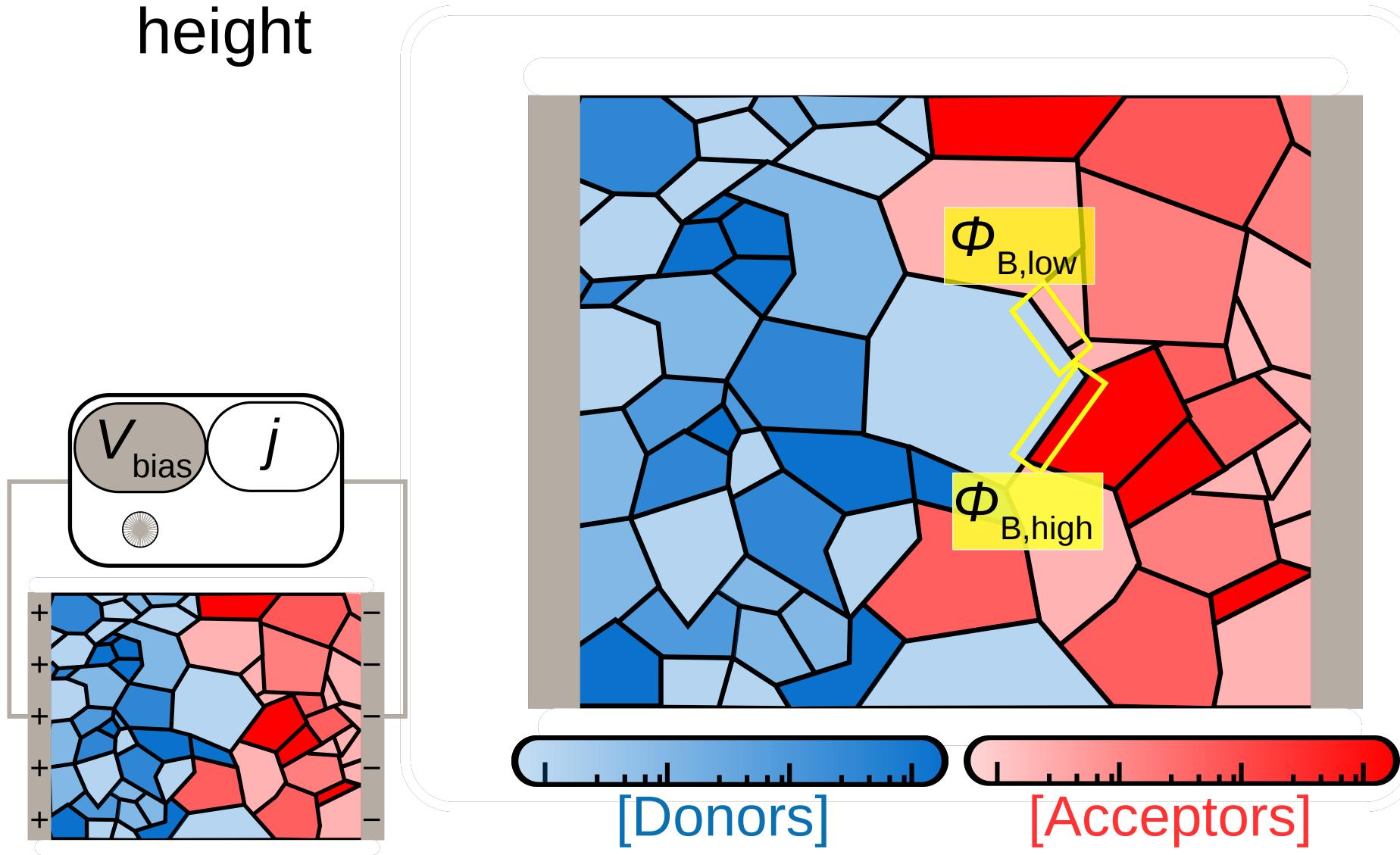
p-n junctions: Inhomogeneous barrier height



p-n junctions: Inhomogeneous barrier height

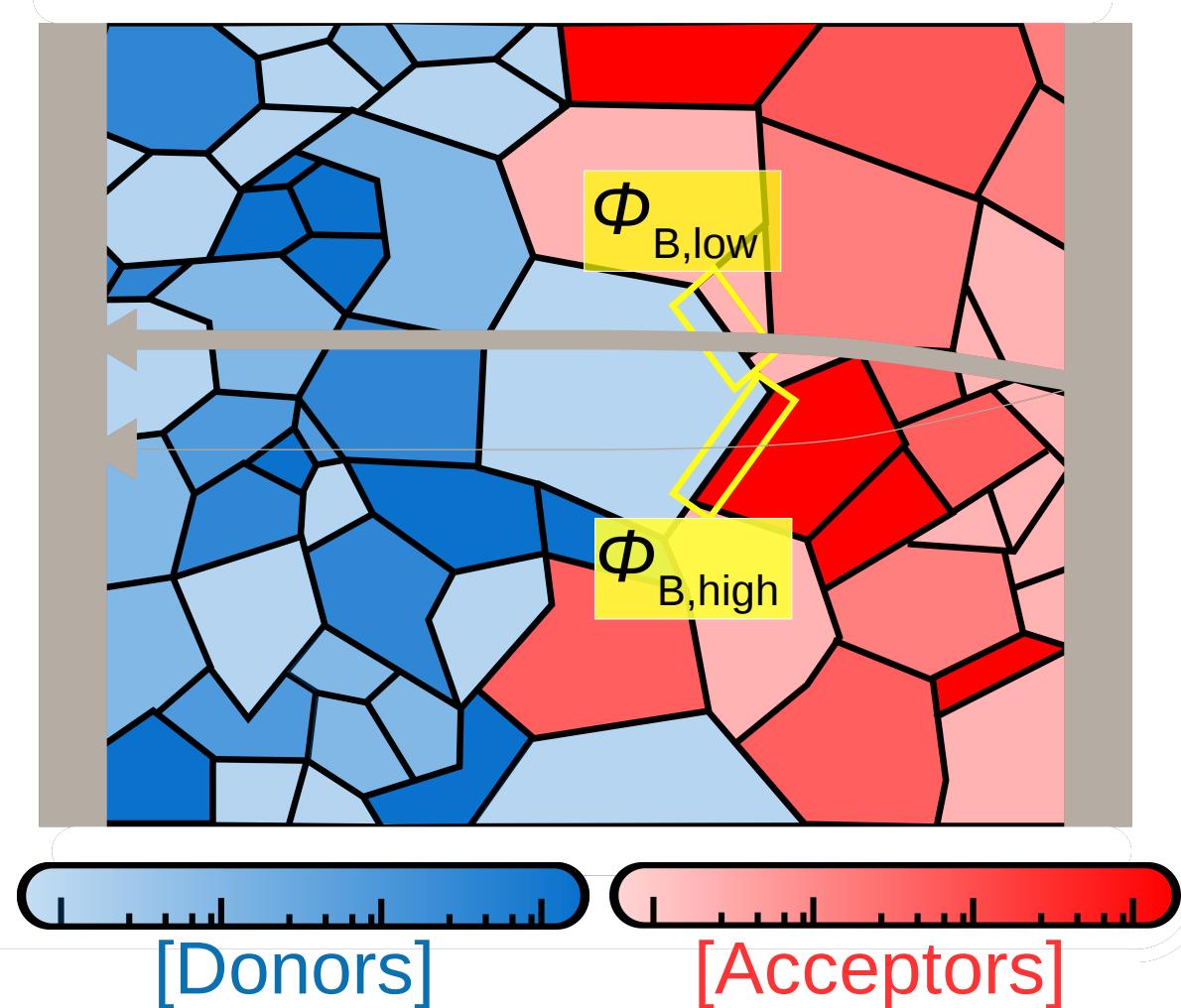
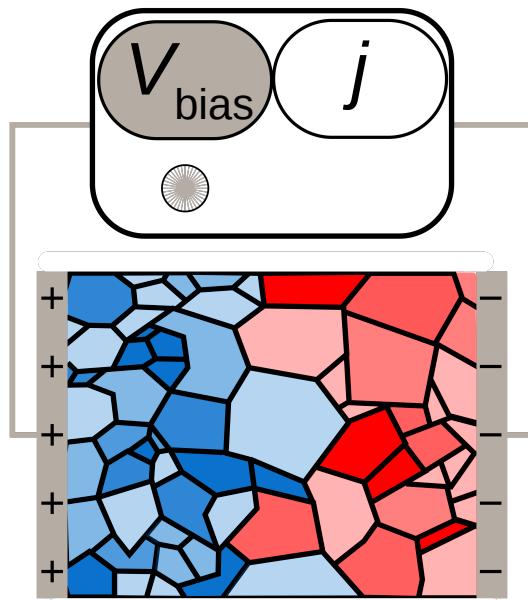


p-n junctions: Inhomogeneous barrier height



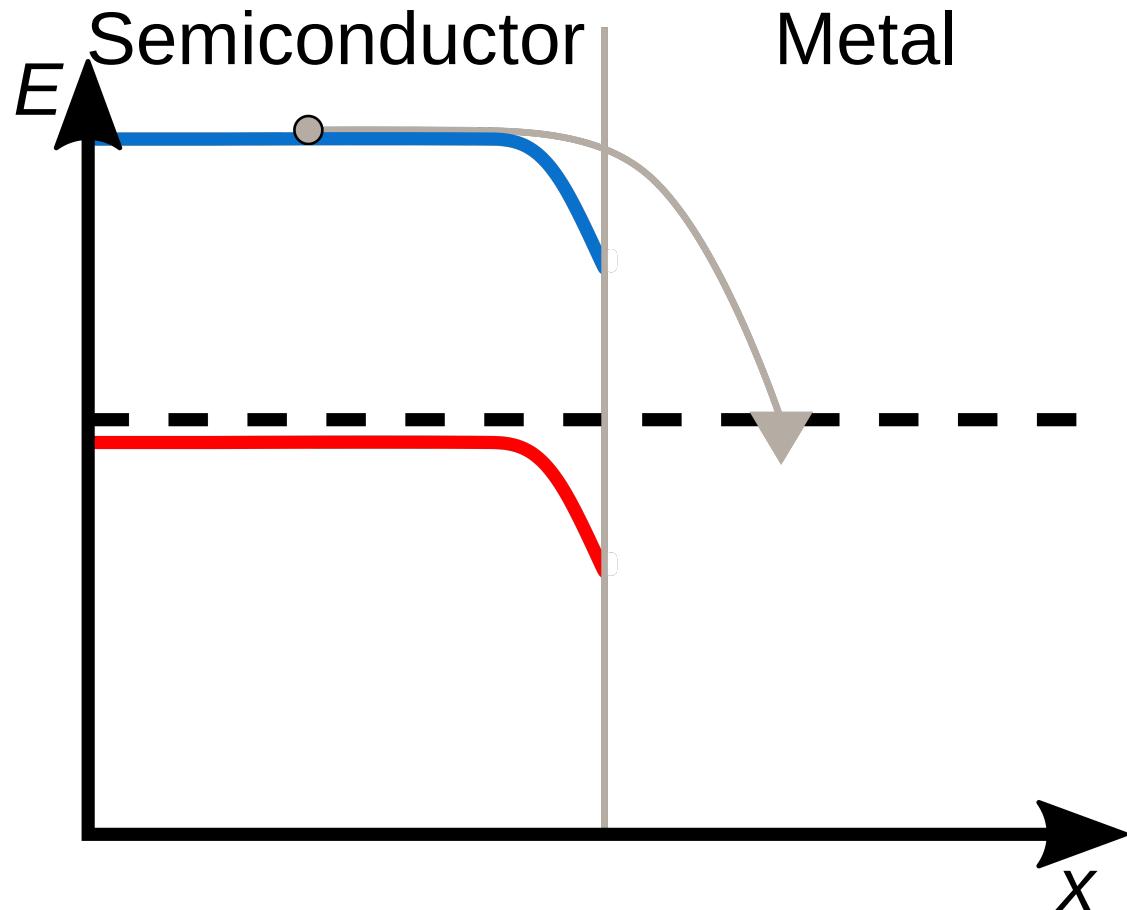
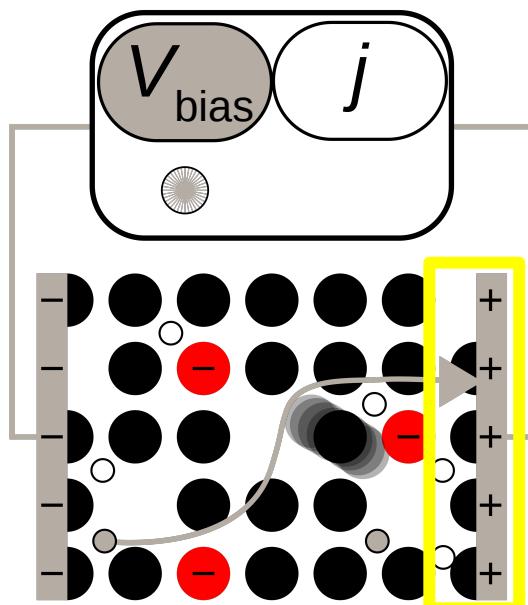
p-n junctions: Inhomogeneous barrier height

Current will see
more of low
 ϕ_B



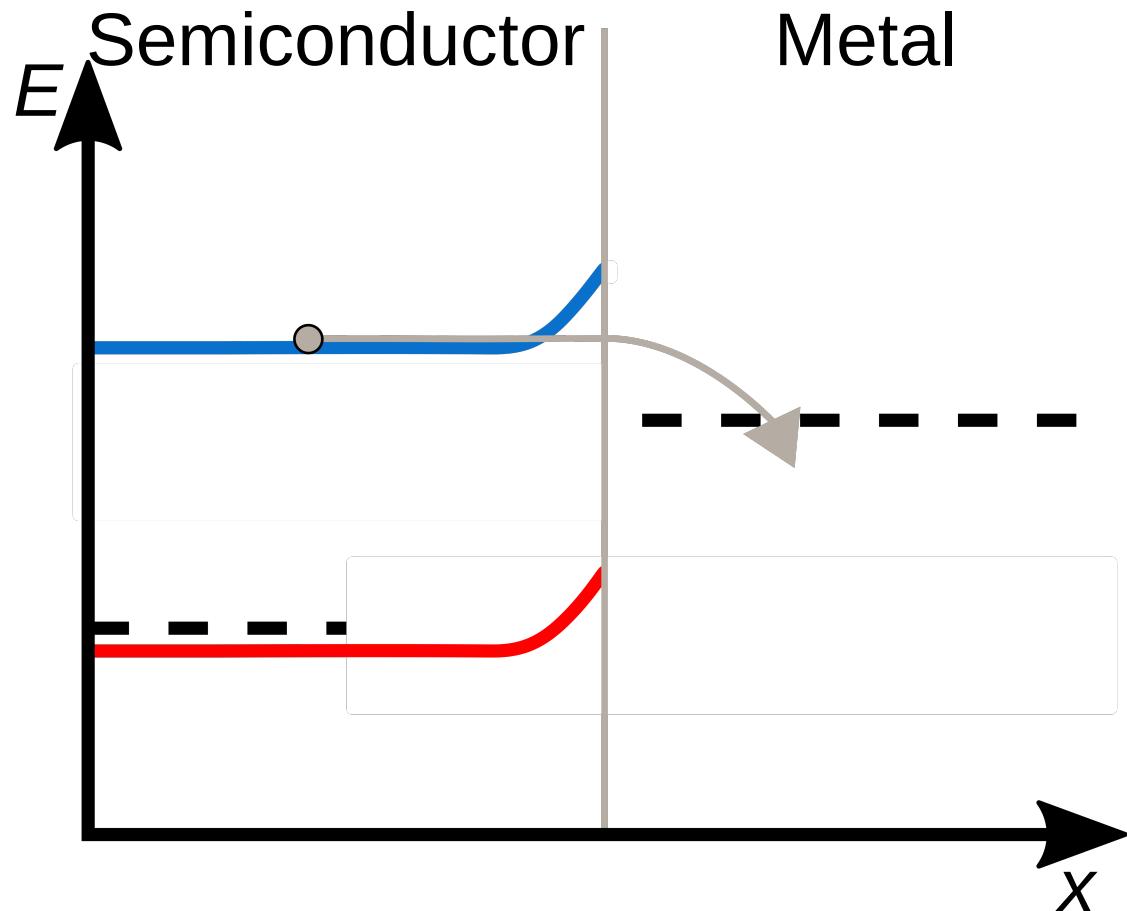
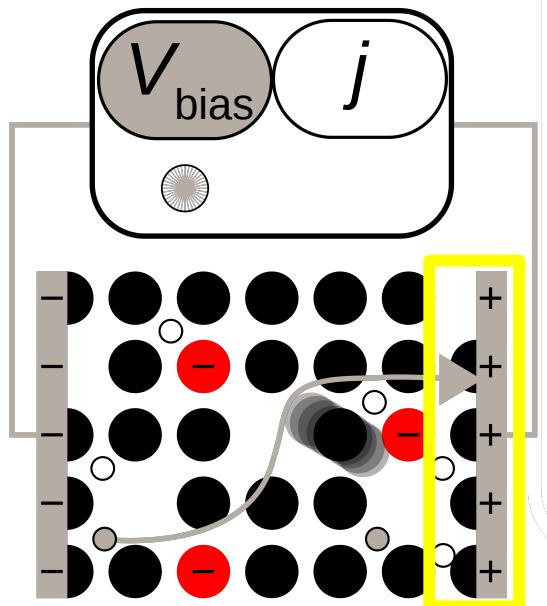
p-n junctions: Series resistance

Intrinsic Mobility
Scattering
Contacts



p-n junctions: Series resistance

Intrinsic Mobility
Scattering
Contacts



p-n junctions: Series resistance

Intrinsic Mobility
Scattering
Contacts

